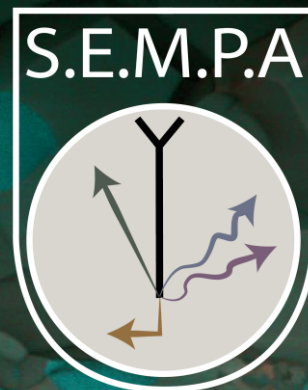


4

Introduction Thermo Fisher Portfolio

Salomé Larmier

13-03-2024



US based company as world leader in serving science

ThermoFisher
SCIENTIFIC

ThermoFisher
SCIENTIFIC

thermo
scientific

applied
biosystems

invitrogen

fisher
scientific

unity
lab services

Pathenon



\$40 B
revenue



130,000+
employees



\$2B
invested in R&D

Industry-leading scale

- Unparalleled commercial reach
- Expanding global footprint
- Unique customer access

Unmatched depth of capabilities

- Leading innovative technologies
- Premier productivity partner
- Deep applications expertise
- Comprehensive services offering

Powered by our Practical Process Improvement (PPI) Business System

Our leading scientific products, services and workflow solutions

ThermoFisher
SCIENTIFIC

ThermoFisher
SCIENTIFIC

The world leader in
serving science

thermo
scientific

Analytical precision
and diagnostics
excellence

applied
biosystems

Inspiring
meaningful genetic
analysis

invitrogen

Accelerating
discovery research

fisher
scientific

Products one-stop
access for scientific
supplies

unity
lab services

Instrument and
enterprise services

patheon

Pharma services

PPD

Drug development

A scenic photograph of two hikers on a mountain trail. The hiker in the foreground is wearing a red jacket and a backpack, walking away from the camera. The second hiker is further ahead on the path. The landscape is a lush green valley with yellow wildflowers in the foreground, leading up to steep, rocky mountains with patches of snow under a blue sky with scattered clouds. A large red diagonal overlay covers the right side of the image, containing the text.

We take pride in our Mission:

To enable our customers to
make the world healthier,
cleaner and safer

MSD Locations

**Analytical
Instruments
Group
(AIG)**

**Chromatography
& mass
Spectrometry
Division
(CMD)**

**Chemical Analysis
Divisions
(CAD)**

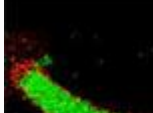
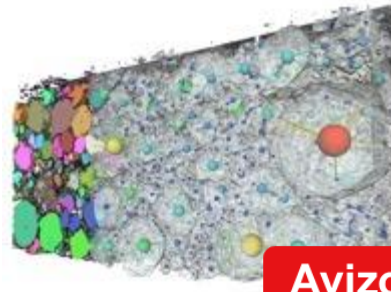
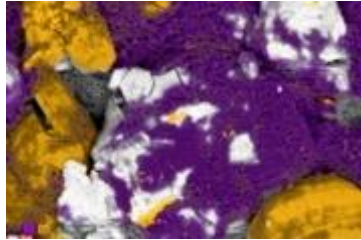
**Materials and
Structural Analysis
Division
(MSD)**

**Instrument and
Enterprise Services
(IES)**

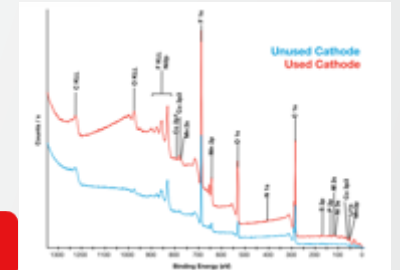


- Location of sites ≥ 5 R&D employees
- Location name called out for sites with ≥ 25 R&D employees

ThermoFisher
SCIENTIFIC



Avizo Software



XPS



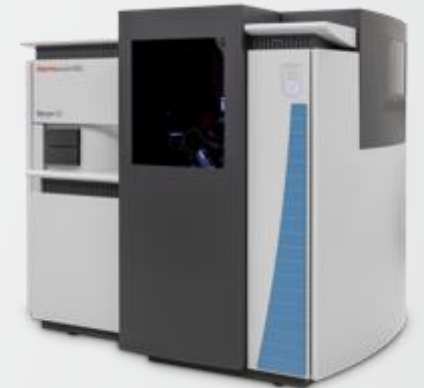
Thermo Scientific Apreo 2 and Axia SEM



Thermo Scientific Scios 2 and Helios DualBeam



Thermo Scientific Talos and Spectra TEM



Thermo Scientific K-Alpha, Nexsa G2 And ESCALAB Qxi XPS

Contents

1 Scanning Electron Microscopes

2 Dual Beam

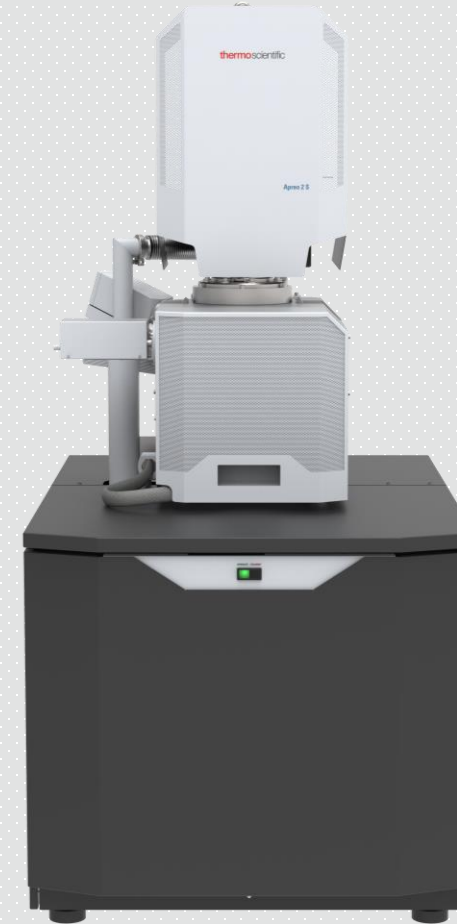
3 TEM

4 XPS

5 Inert Gas Sample Transfer Module

6 IonMiller

7 Avizo Software: data processing



Thermo Scientific offers a complete SEM product portfolio

What samples do I have, and what do I want to see?

Desktop SEM



Phenom ProX



Phenom XL



Phenom Pharos

- Time to image
- Ease of use
- Smallest footprint

conventional SEM

- **Flexibility**
 - Large samples
 - Difficult samples
 - Accessories
- **Performance**
 - Ultimate resolution
 - Best contrast



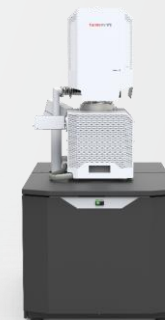
Axia ChemiSEM



Prisma E



Quattro

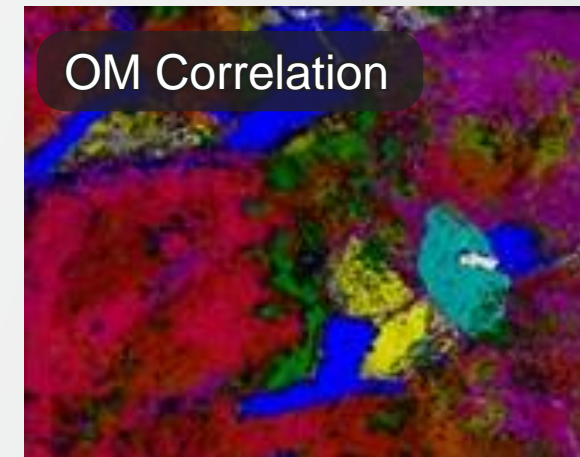
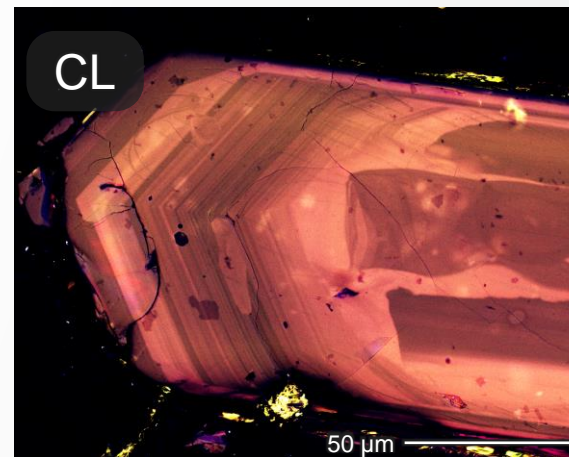
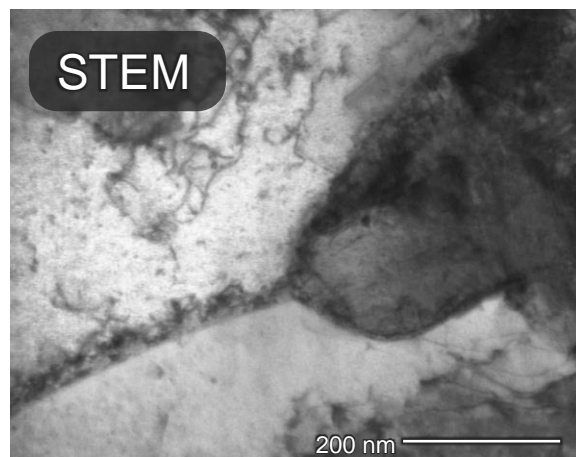
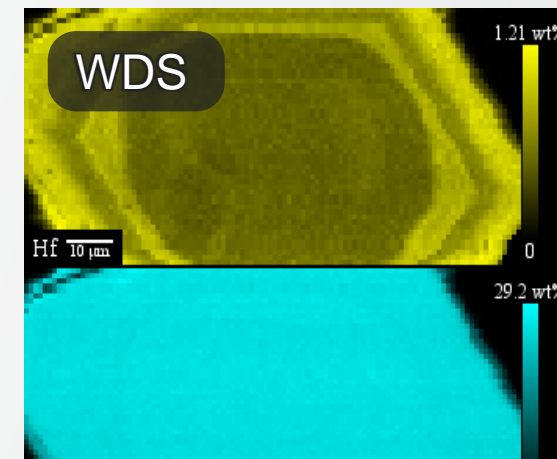
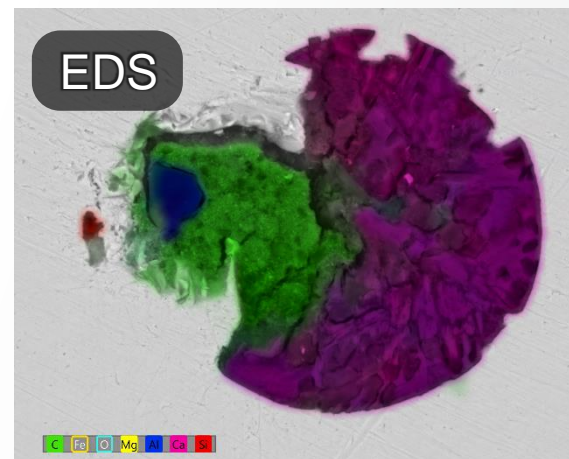
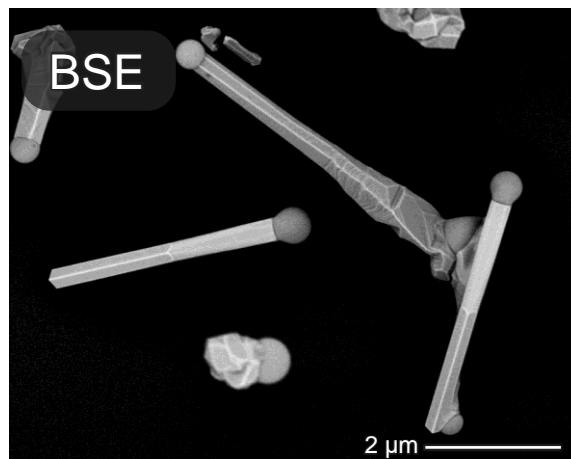
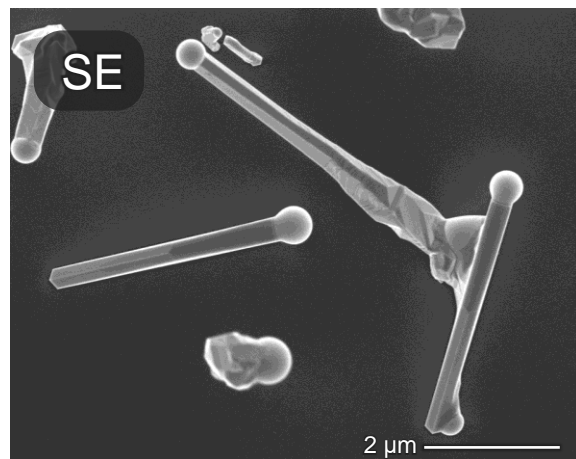


Apreo



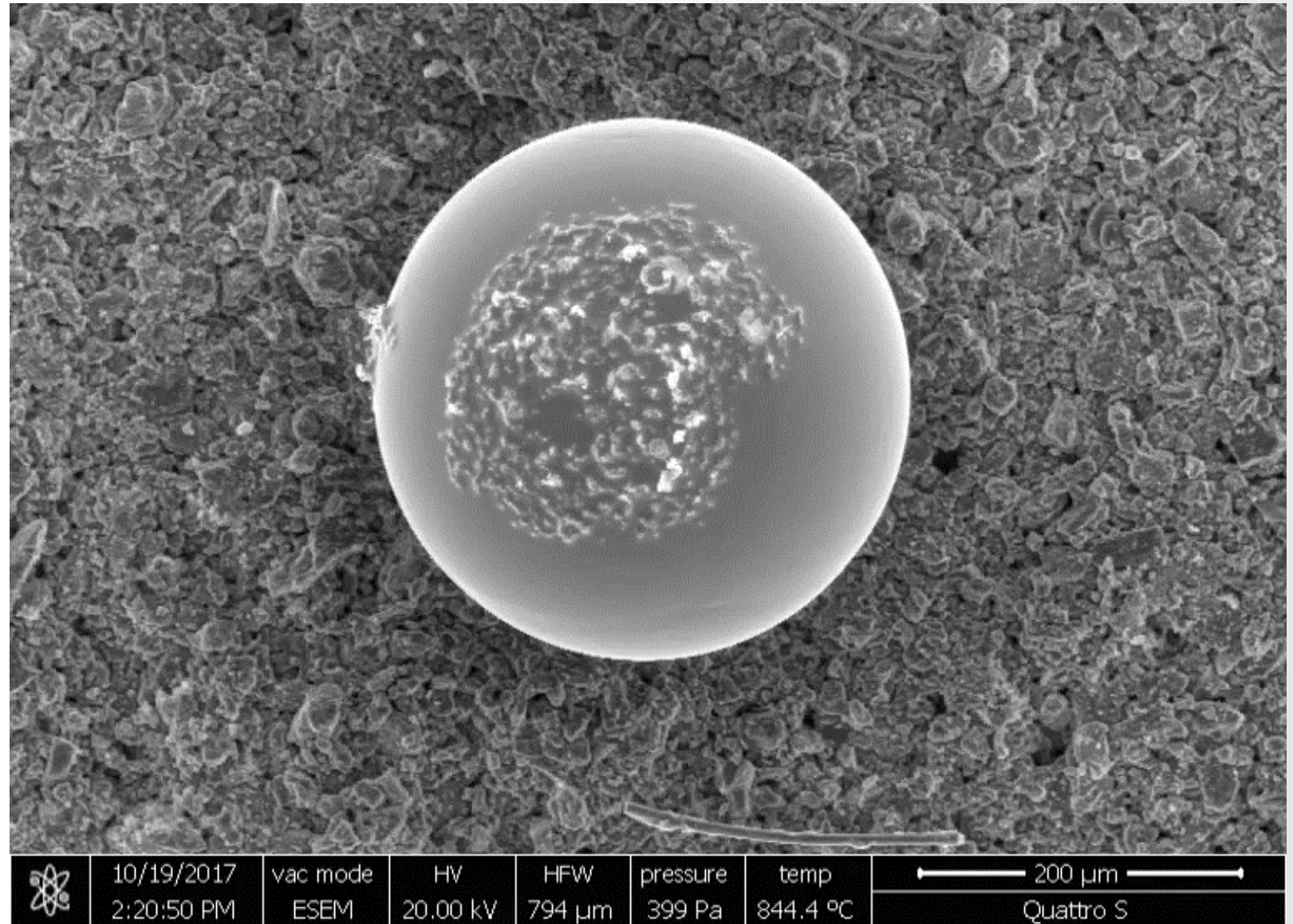
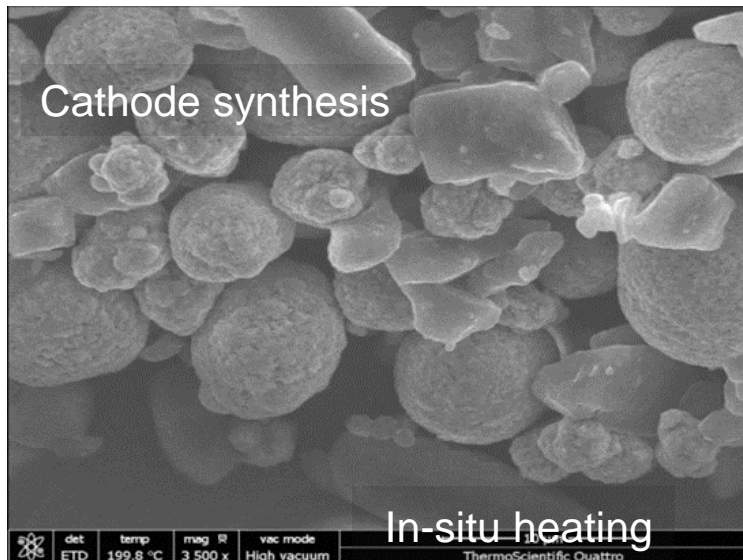
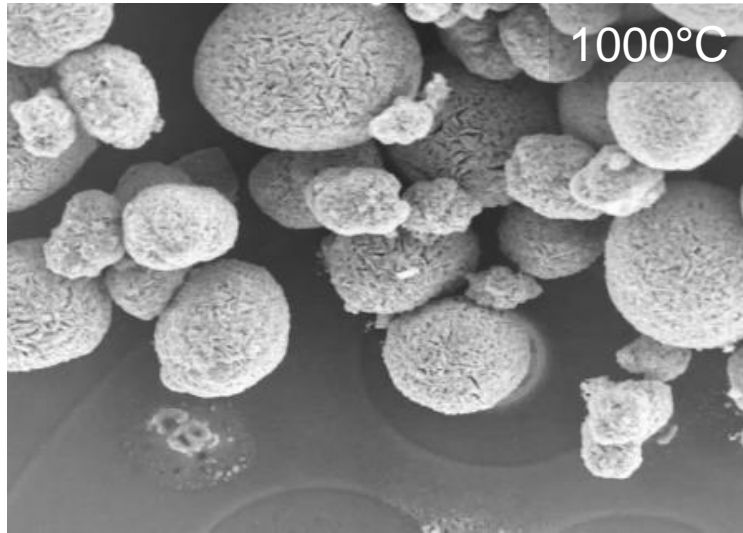
Verios

Type of information required – depends on the detector selection



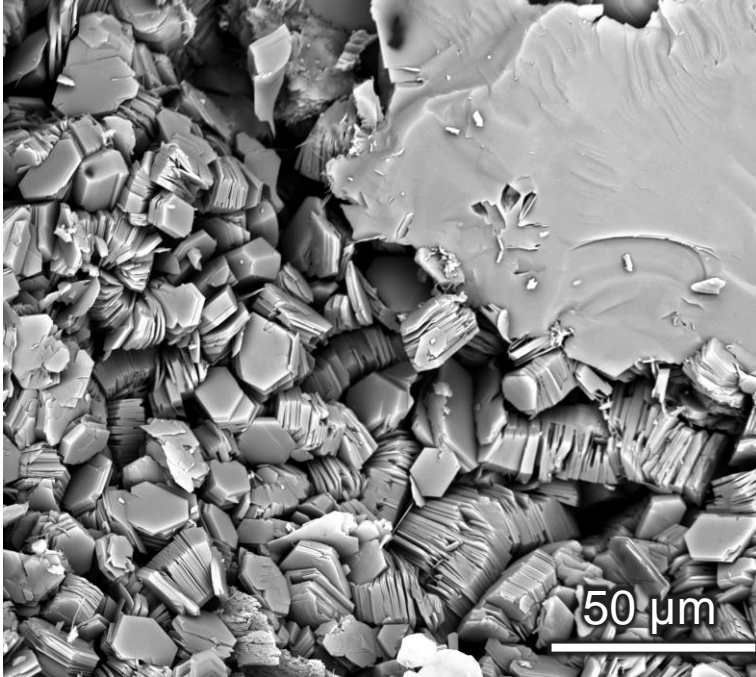
→ All these types of information, and more, are available on all conventional Thermo Scientific SEMs

In situ heating in SEM



Feature size and resolution

Large feature sizes ($> 1 \mu\text{m}$)



Aluminum fracture

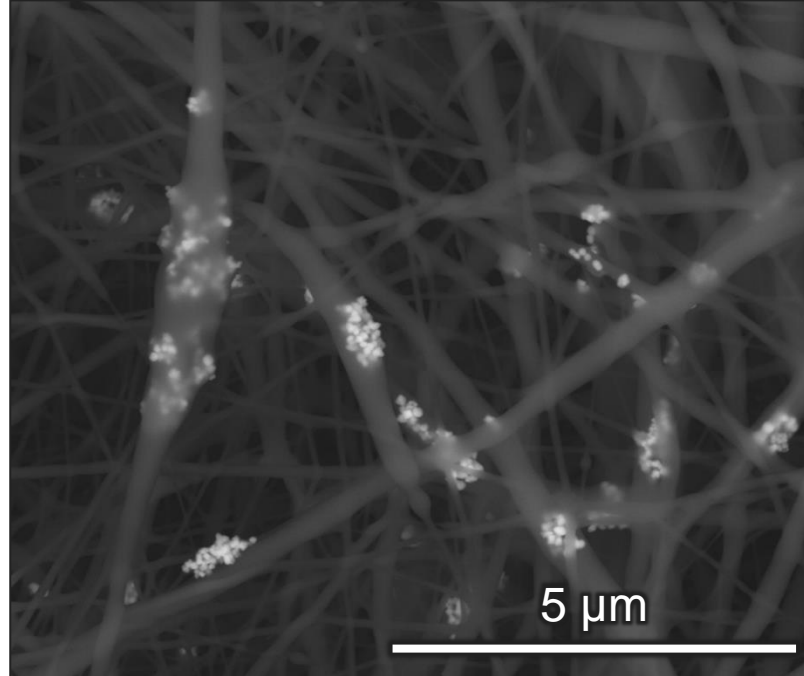
Tungsten SEM

a.k.a.

Conventional SEM

Thermionic source

Small feature sizes ($\ll 1 \mu\text{m}$)



Electrospun fibers with Fe₃O₄ particles

Field Emission SEM

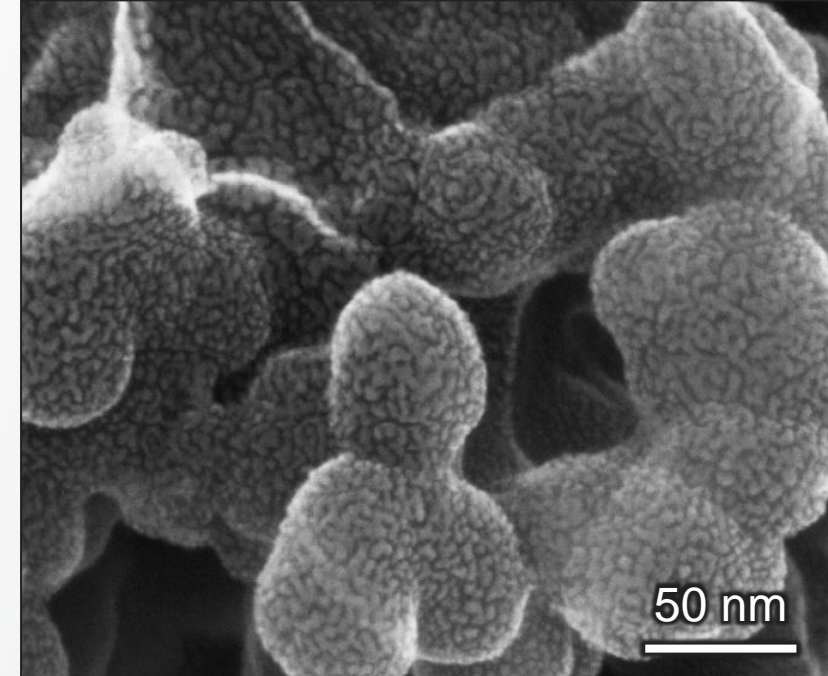
a.k.a.

FEG (field emission gun)

Conventional FEG

Schottky FEG

Nanomaterials ($< 10 \text{ nm}$)



Sputtered Pt on C Film
Courtesy Sandia National Lab, USA

In-lens SEM

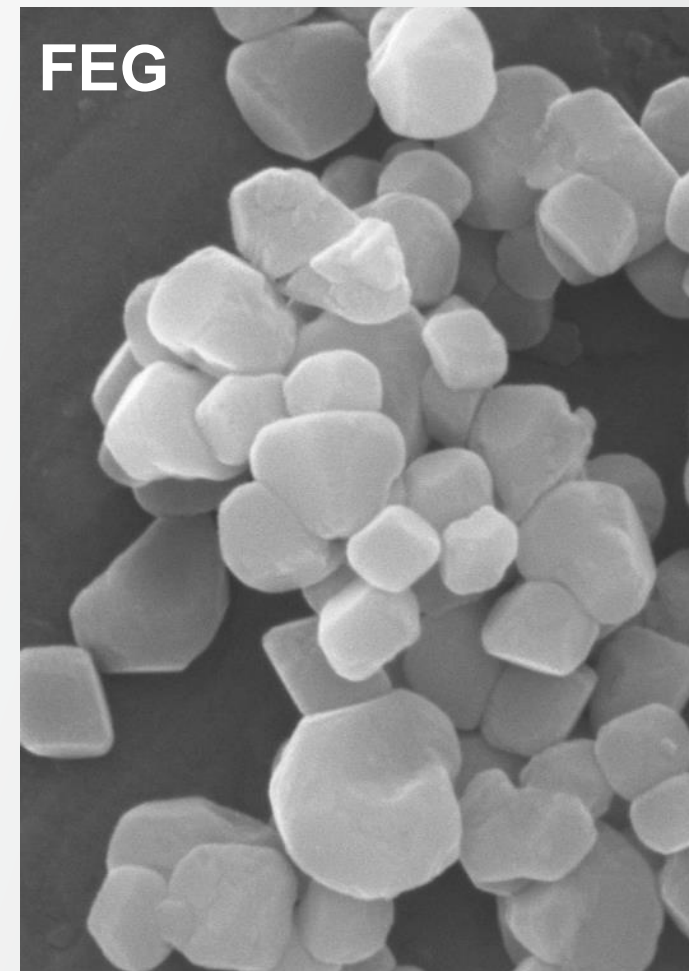
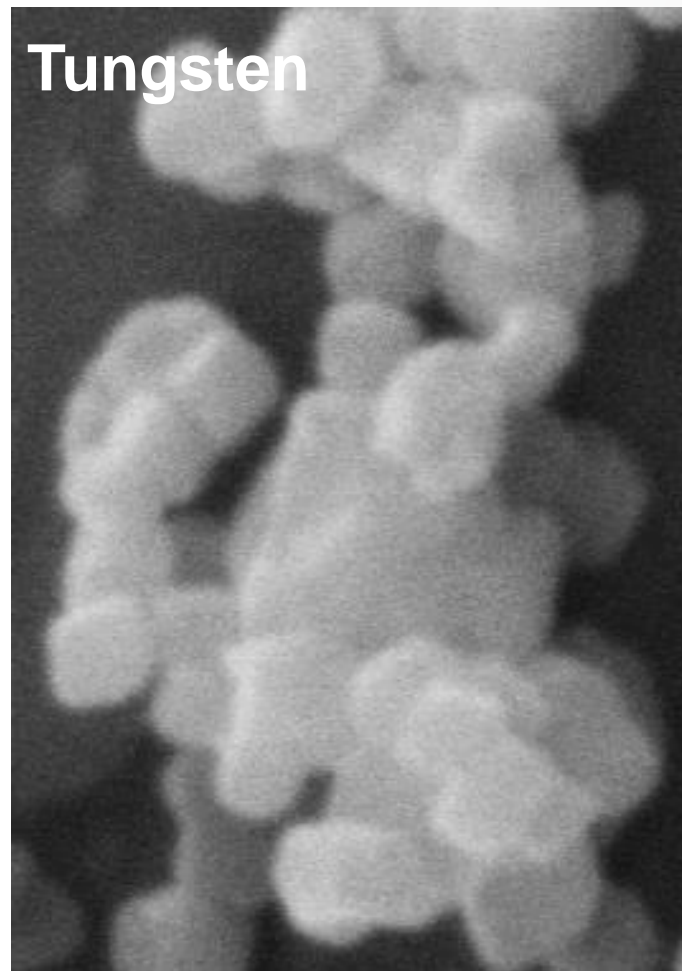
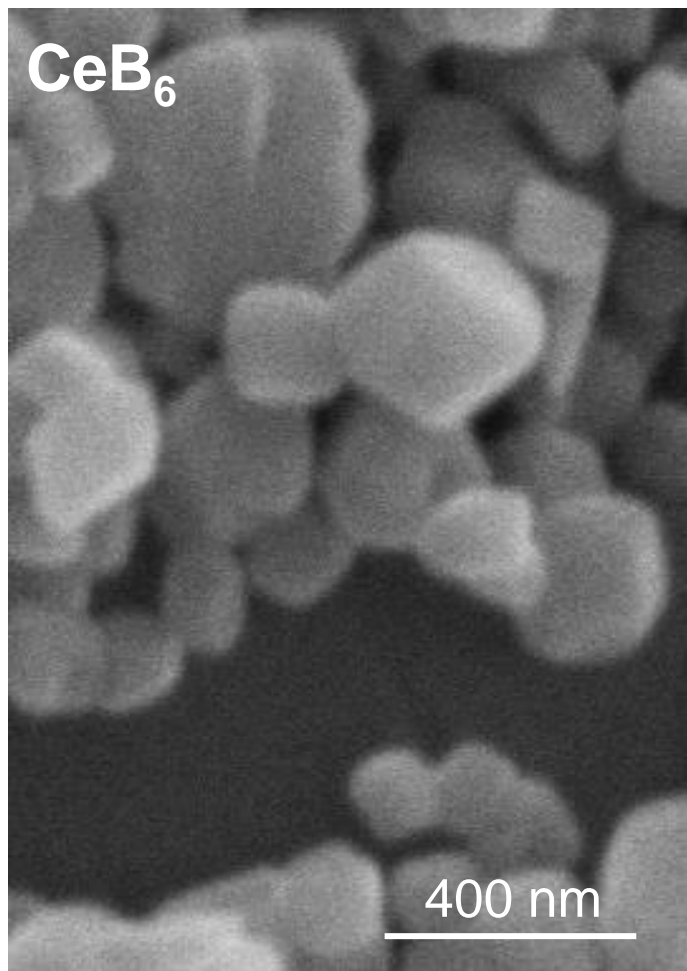
a.k.a.

In-lens FEG

Acceleration tube FEG

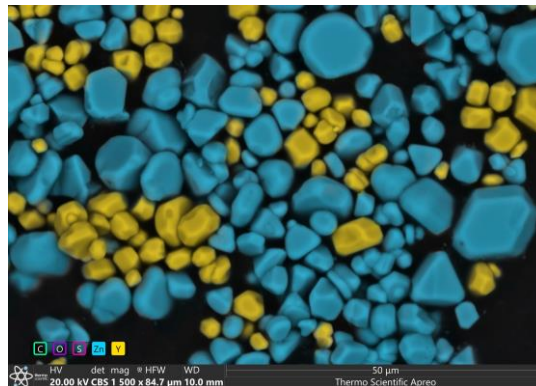
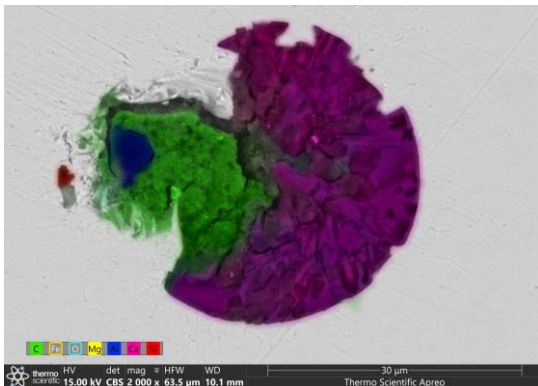
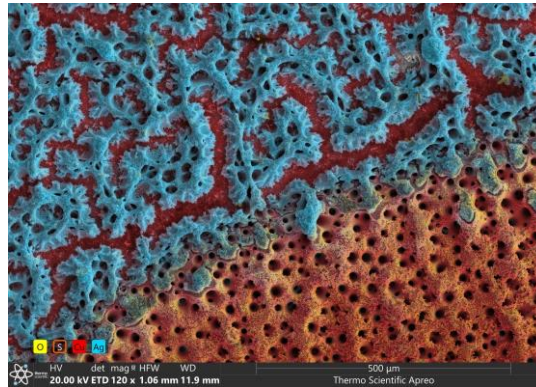
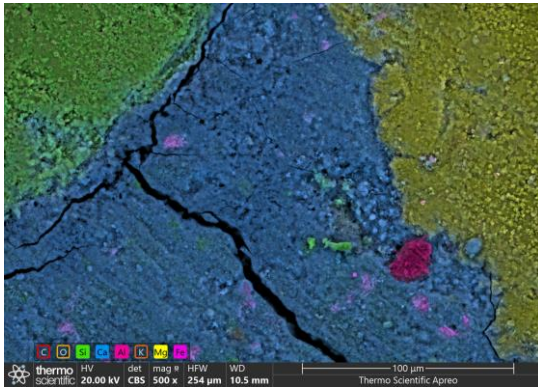
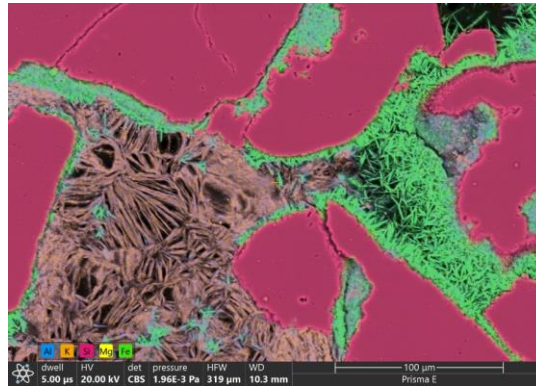
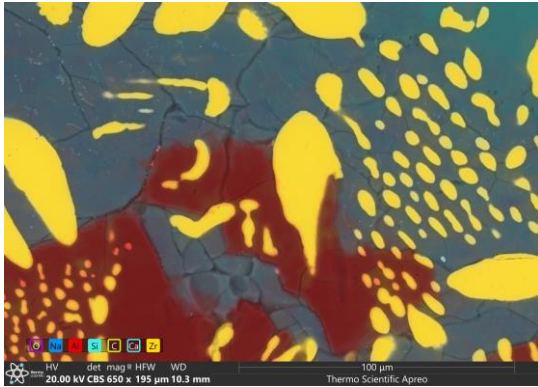
Immersion SEM

FEG on desktop SEM enables outstanding results



CaCO₃ particles, Pt coated, imaged at 10 kV

Live Quantitative Elemental Mapping with ColorSEM Technology



Fast

Get full compositional information up to 10 times faster with background X-ray collection, unique data processing, TV-rate pixel scanning, and an integrated user interface.

Intuitive

Color is switched on with a single click, all relevant functions are nearby, contrast is optimized with smart coloring, and live composition is shown with a tooltip.

Complete

ColorSEM Technology is always on, showing information that might otherwise be missed.

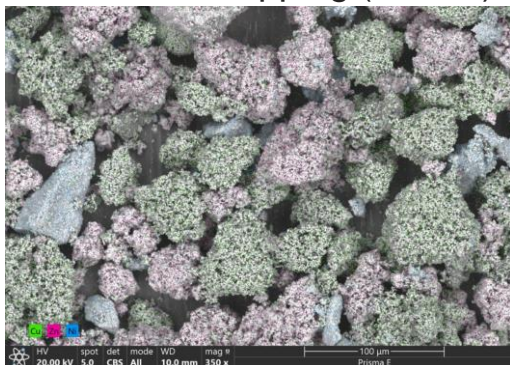
Reliable

Image coloring is based on live elemental quantification. The quant algorithms are based on decades of knowledge and experience to ensure reliable results.

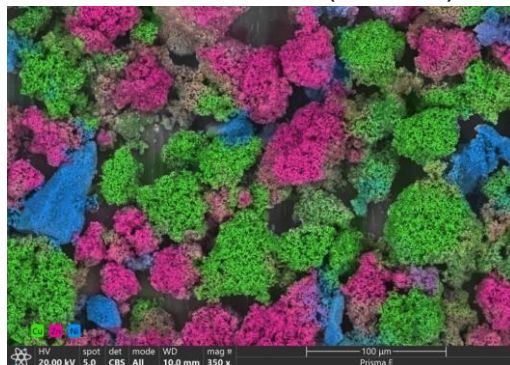
ColorSEM benefits

It's fast

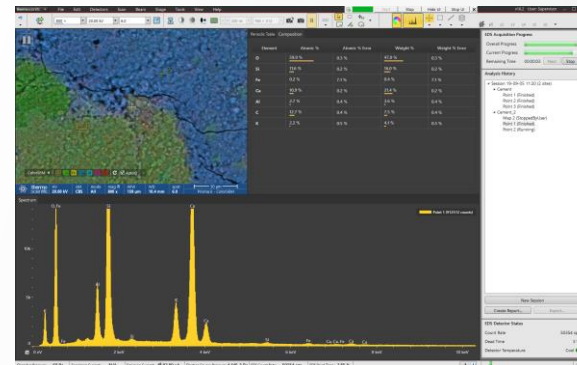
Traditional mapping (30 sec)



Live ColorSEM (30 sec)

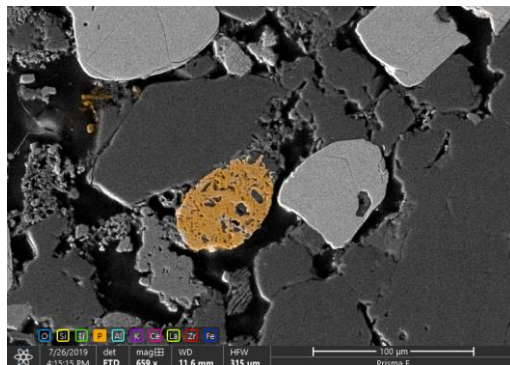
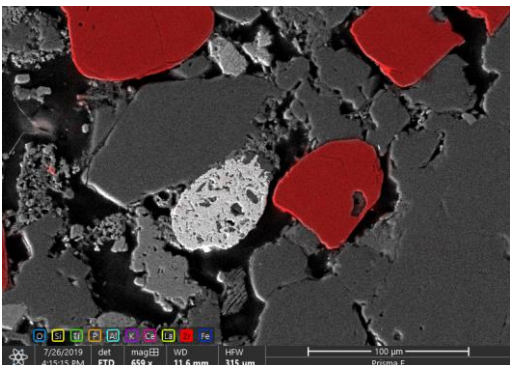


It's intuitive



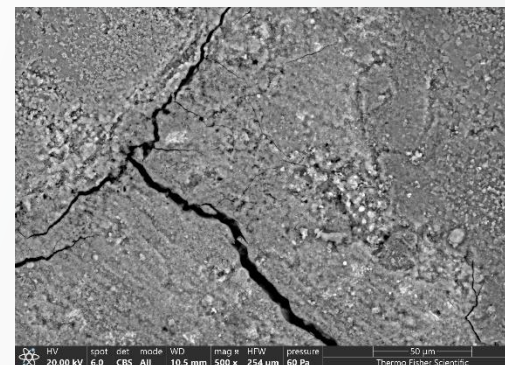
- Single UI, no switching
- No setup required
- Colors show elements
- Work directly on the SEM image for point & ID, etc
- All functions are one mouse click away

It's reliable

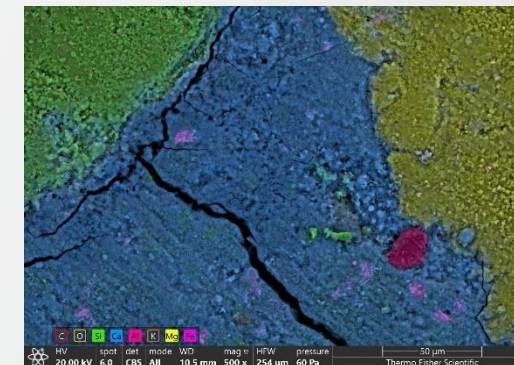


Materials correctly labeled, even when peaks overlap (Zr / P).
→ Live coloring is based on live quantification.

It's complete



Materials contrast not clear,
even in backscatter mode



ColorSEM: highlight materials
contrast you would otherwise miss

Identify and quantify metallic phases

Element	wt.% γ'	wt.% TaC	wt.% γ
Ni	66.4	11.9	58.9
Co	6.8	2.1	9.4
Cr	4.9	1.9	9.6
W	4.6		7
Ta	8.2	72.2	3.8
Al	6.6		4.4
Re	1.2		4.7

HV15.00 kV

curr3.2 nA

detT1

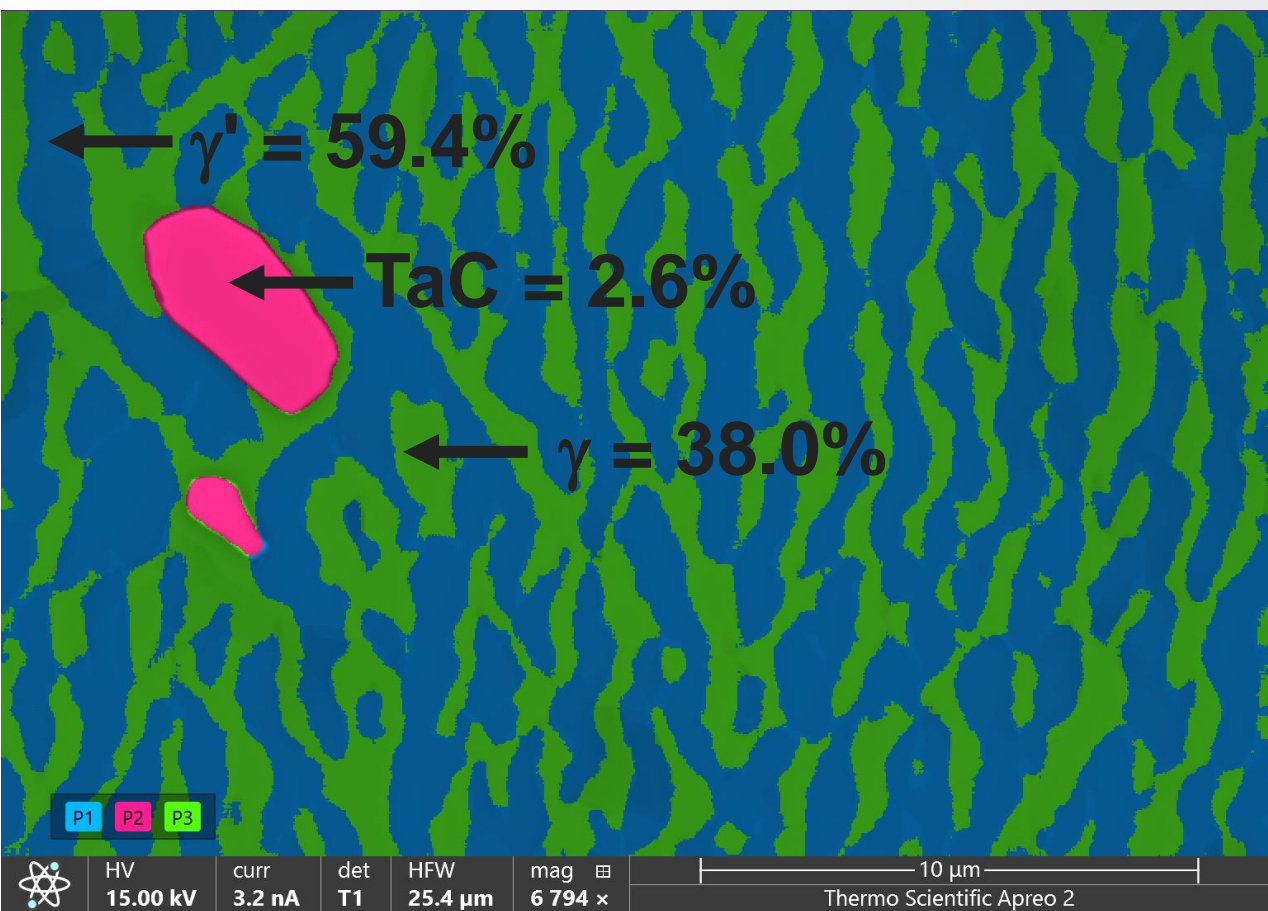
HFW25.4 μ m

mag6 794 \times

10 μ m

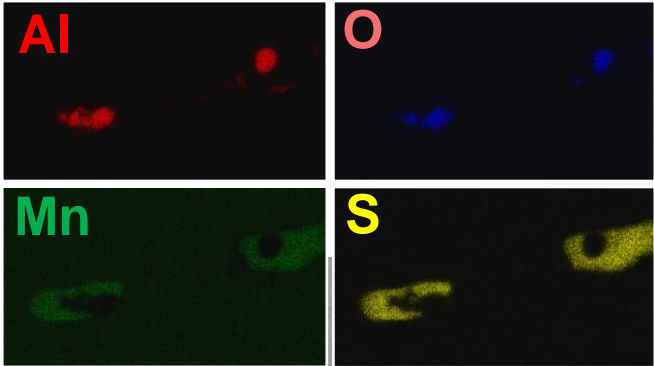
Thermo Scientific Apreo 2

SEM image

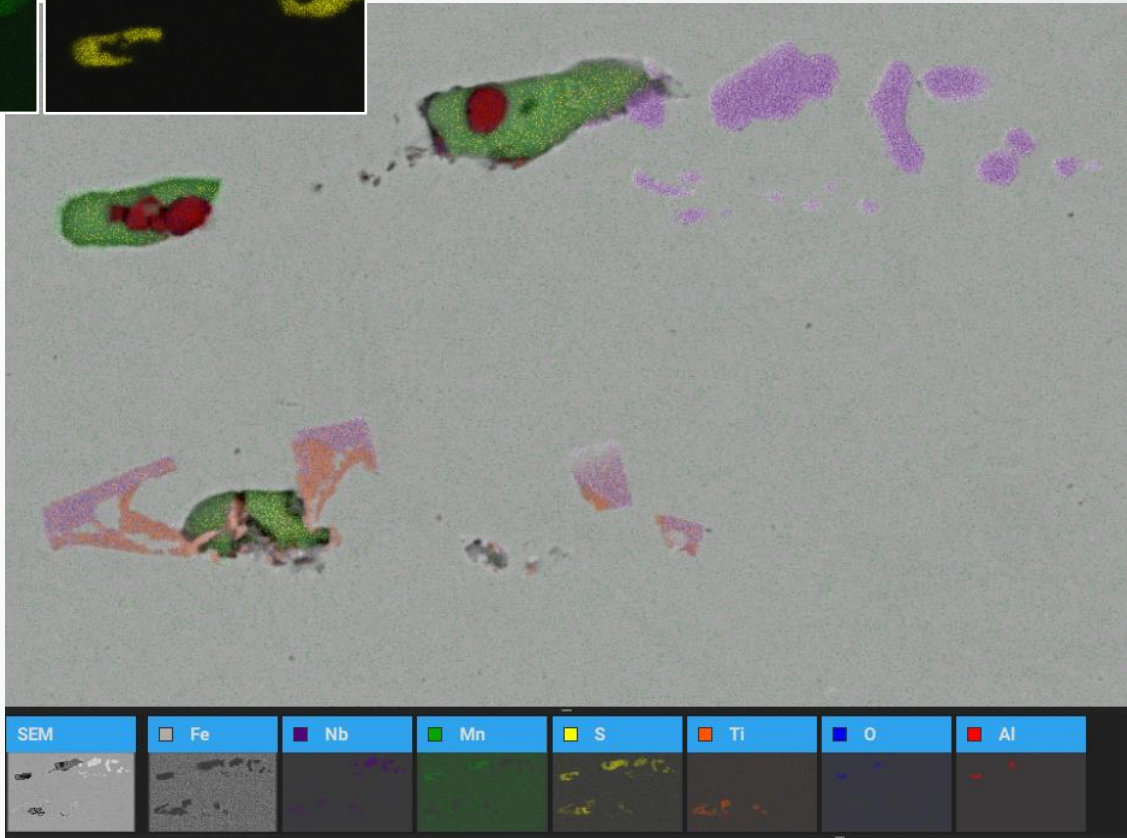


Phenom ParticleX Steel – with Phenom User Interface

New Phenom User Interface for regular imaging and EDS work

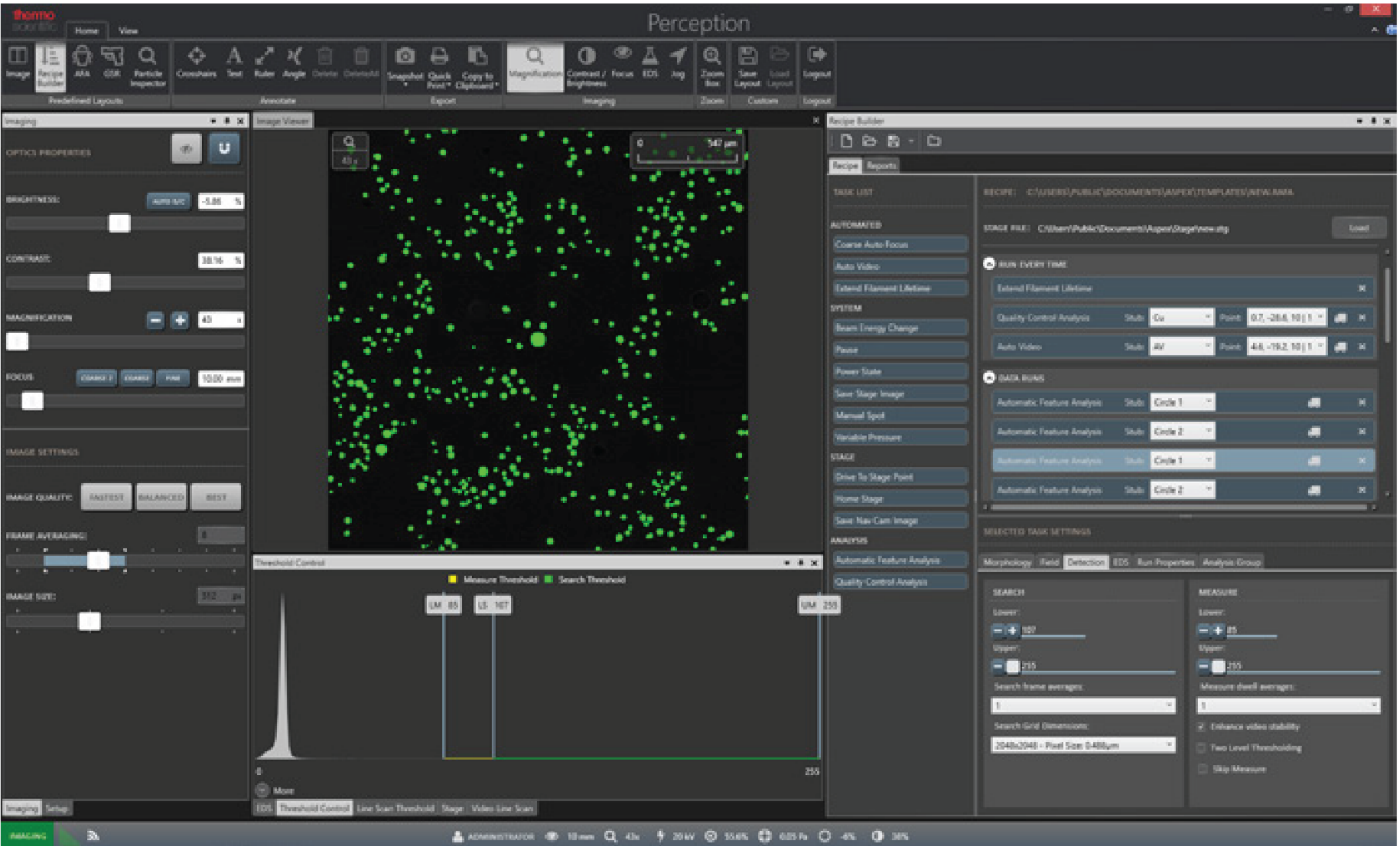


EDS mapping included



Particles Analysis Software

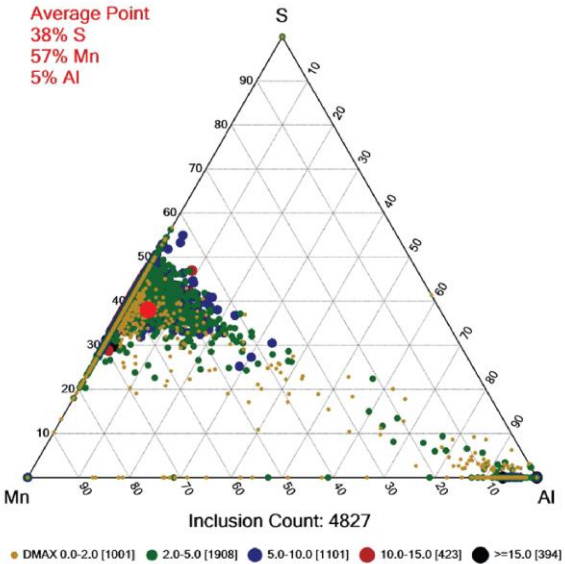
- Perception and Particles X for all our SEMs



Inclusion Classification Summary												
Classification	Particles	[%]	N	Mg	Al	Si	S	Ca	Ti	Mn	Features/mm ²	Incl.Index
Mn Sulfide	4130	84.8	1.5	1.2	1.3	0.6	36.2	2.1	2.2	54.0	20.1	94.4
Ti Nitride	511	10.5	30.7	0.2	0.5	0.7	5.5		51.2	10.5	2.5	3.0
Spinel Pure	201	4.1	0.1	32.1	56.5	2.5	1.3	0.9	1.4	4.7	1.0	0.9
Spinel Rich	23	0.5	4.6	19.3	39.2	1.4	7.4	1.0	12.0	14.4	0.1	0.1
Alumina	7	0.1	1.9	0.4	82.7	2.4	1.0	0.3	4.9	5.6	0.0	1.6
Mg Rich	1	0.0		49.8	1.4	1.5	18.8			28.6	0.0	0.00001
All above combined	4873	100.0	4.5	2.5	3.8	0.7	31.3	1.8	7.3	47.2	23.7	100.0

Sample Information	Sample Prep Information	Run Information
Company:	Component Surface By: Volume	Magnification: 220x
Operator Name:	Volume of Extraction(cm ³) 100	Number of Stage Fields: 61
Part # / Sample ID:	Projected Volume(cm ³) 100	Area Scanned(mm ²): 36.42
Analysis Date: 3/29/2021 1:30:40 PM	Filter Size (mm): 300	RunID's Present: Run_1

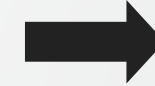
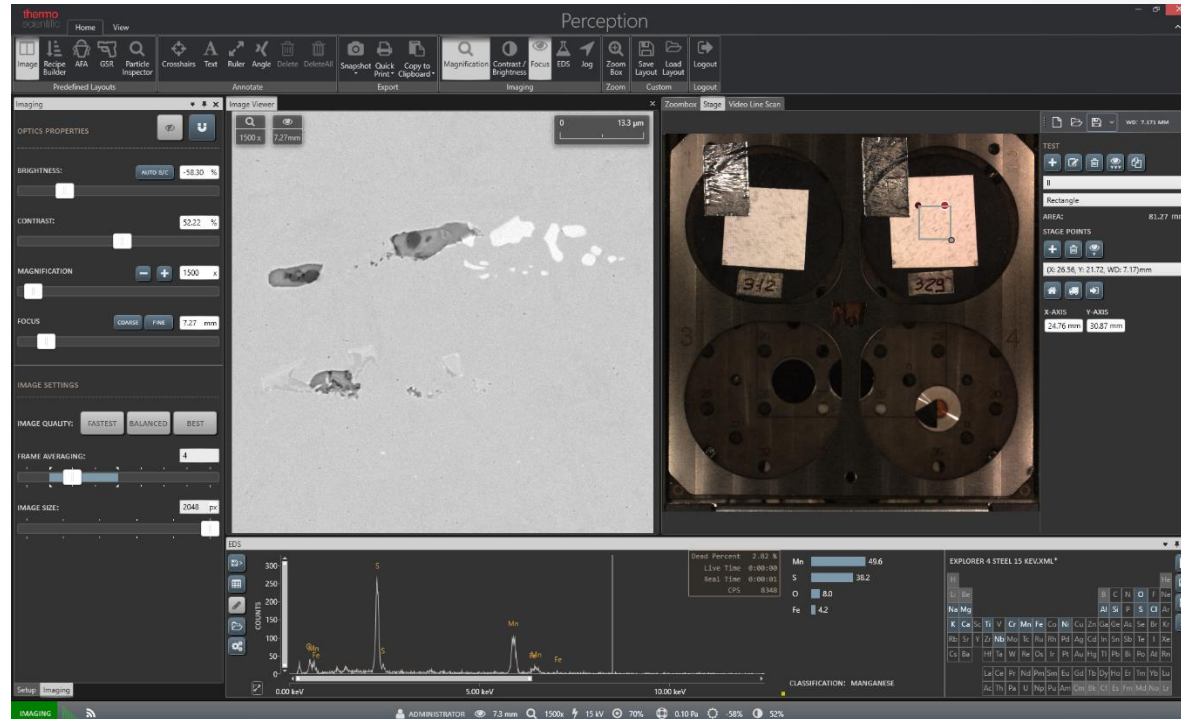
Size Class	
Size Range (um)	Total Count
Glass	1
Al ₂ O ₃	1
Si Rich	9
SiO ₂	1
Ca-Aluminosilicates	1
Aluminosilicates	1
Steel	1
Oxidized Al	1
Misc	1
Mineral	1
Non-Ferrous Metal	1
Misc Salts	1
Total Counts	36
Cleanliness Level	
Component Cleanliness Code (C)	
Specification:	



Automated analysis with Perception



Sample



Automated inclusion **detection**
Automated **image** acquisition
Automated **EDS** analysis
Automated inclusion **classification**

Conventional SEM product portfolio for Materials Science

Axia



Winning factor

Easy to use
and maintain

Resolution

3 nm @ 30 kV
8 nm @ 3 kV

**Low
Vacuum**

Optional
Or Prisma E

ChemiSEM



**Automated
Alignments
& Settings**



**SE, BSE, STEM, CL, EDS,
EBSD, Heating,
Maps, Autoscript**



Quattro



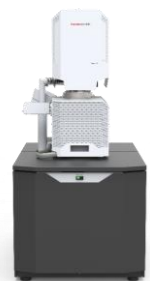
High resolution
of any sample

1 nm @ 30 kV
3 nm @ 1 kV

ESEM



Apreo



Excellent low-voltage
contrast & hi-res analytics

0.8 nm @ 1 kV

Optional



Verios



Nanoscale
characterization

0.7 nm @ 1 kV

-



Contents

1 Scanning Electron Microscopes

2 Dual Beam

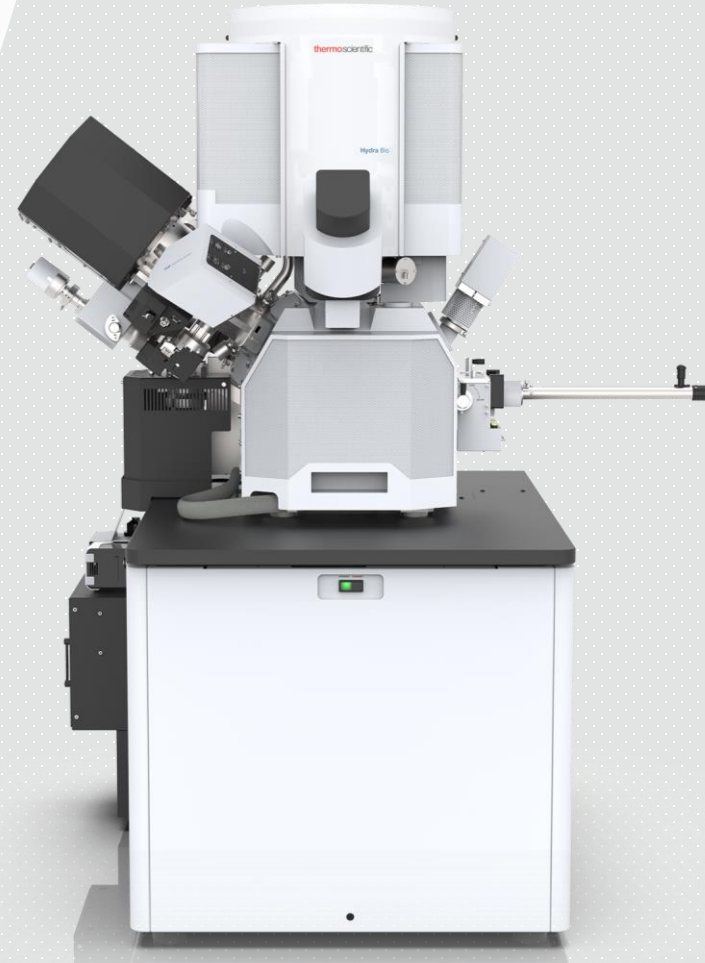
3 TEM

4 XPS

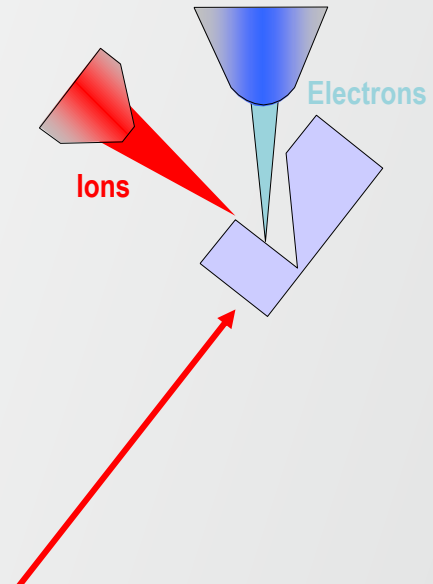
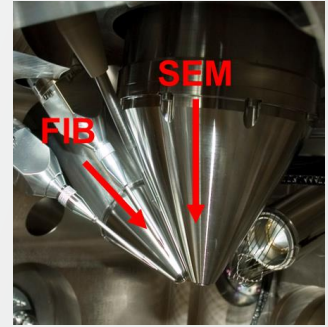
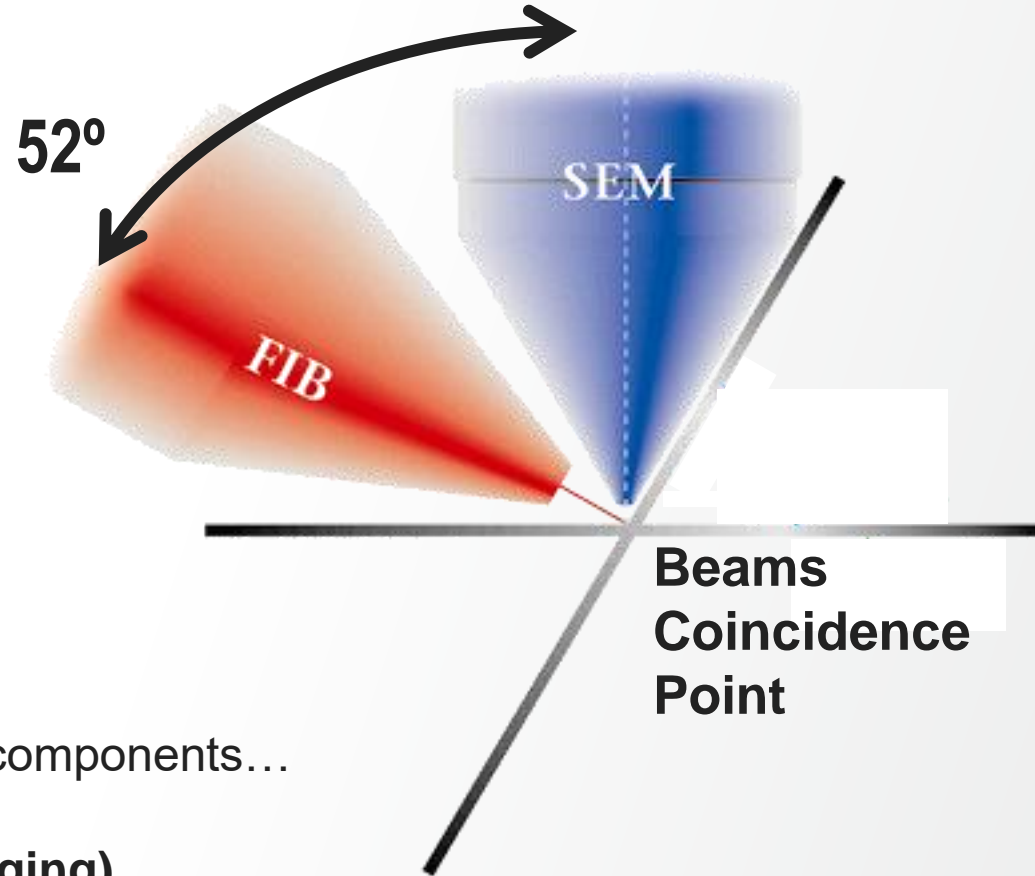
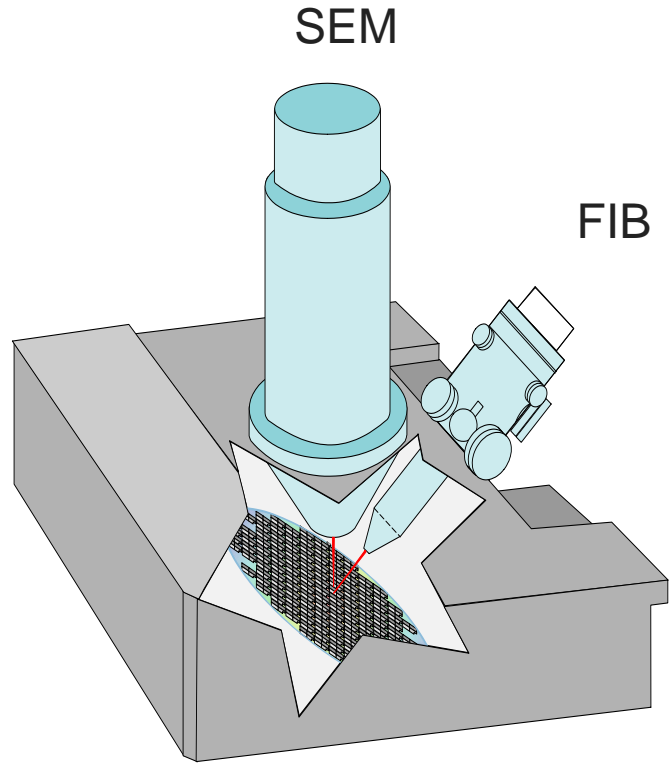
5 Inert Gas Sample Transfer Module

6 IonMiller

7 Avizo Software: data processing



What is DualBeam (FIB-SEM)?



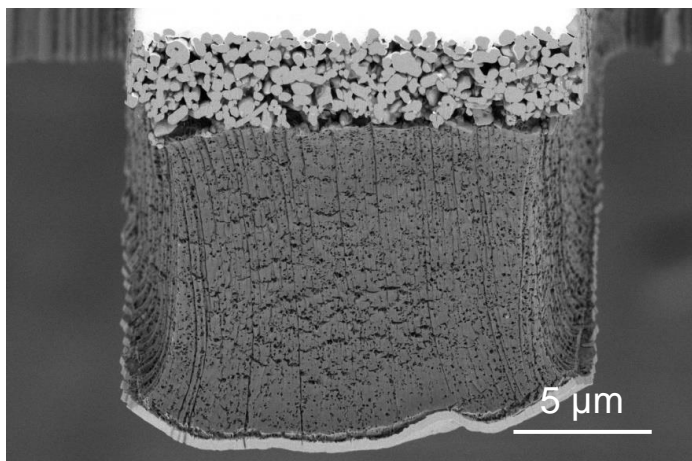
A DualBeam is defined by of two primary components...

Scanning Electron Microscope (for imaging)
+
Focused Ion Beam (milling)

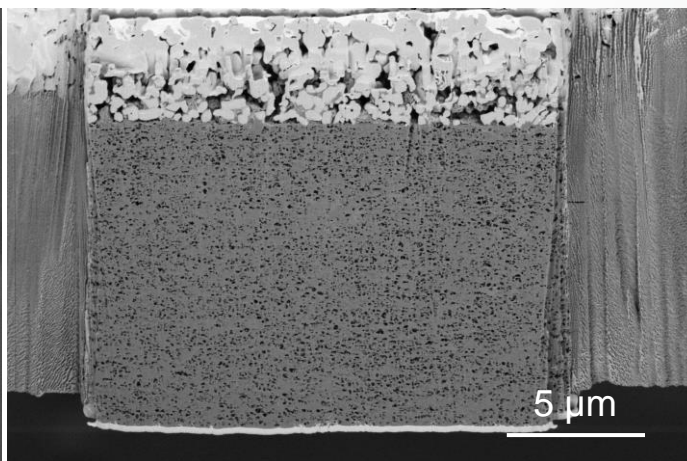
The sample and stage are maneuvered beneath the beams to optimize imaging and milling

2D Cross-section: Separator Analysis

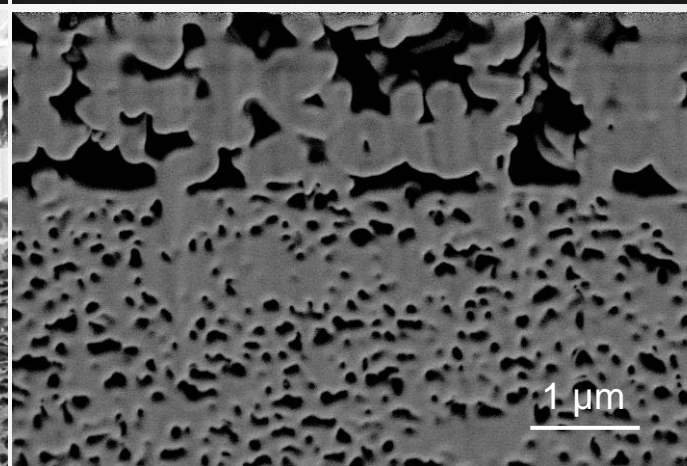
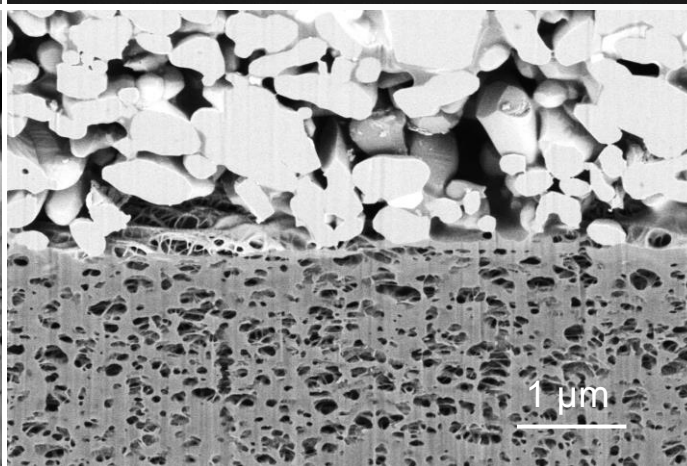
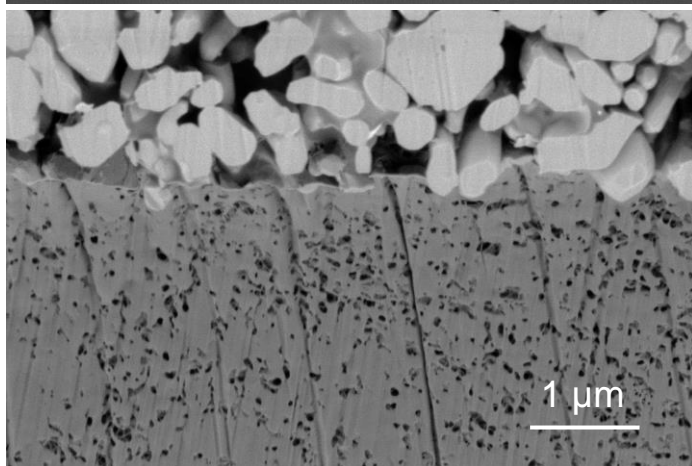
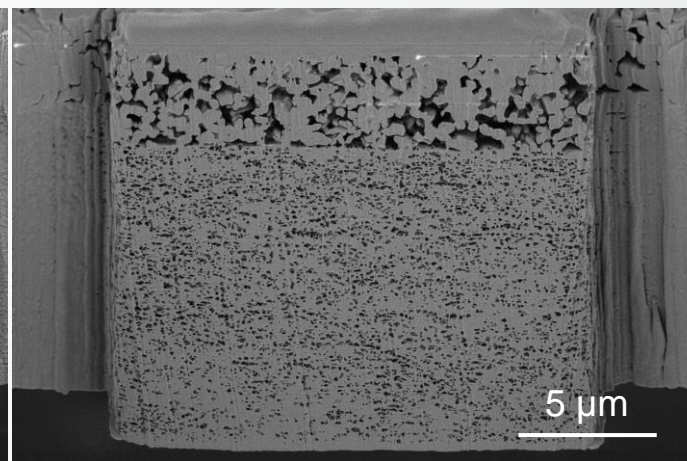
Room Temperature



-80 °C



-185 °C

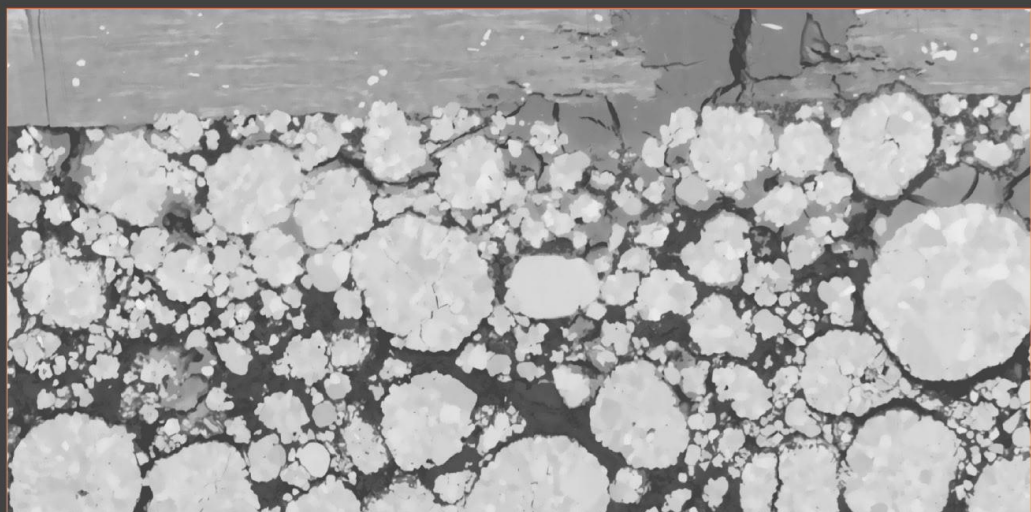


- Optimized FIB milling and imaging temperature at -80 °C
 - Pore structures are well preserved
 - Clear contrast among separator, pore, alumina particles and binder

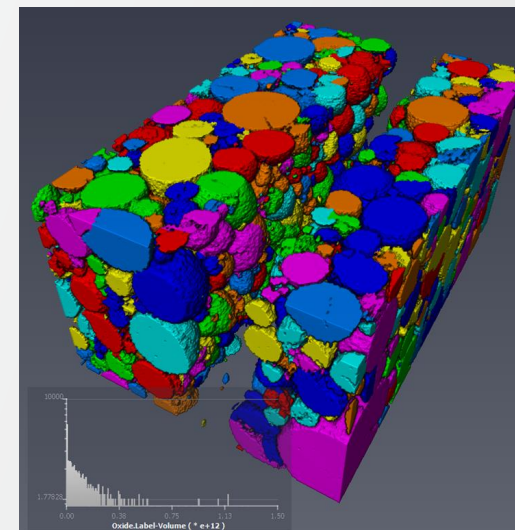
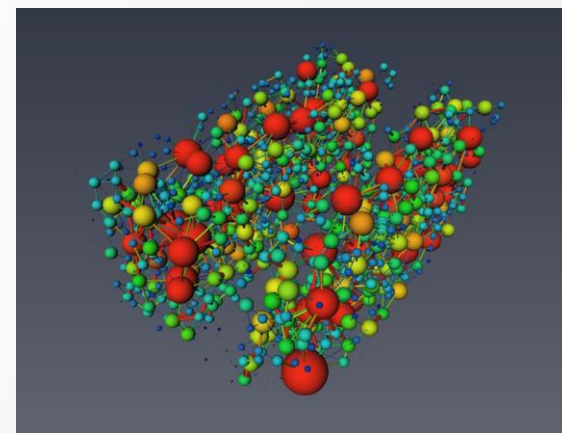
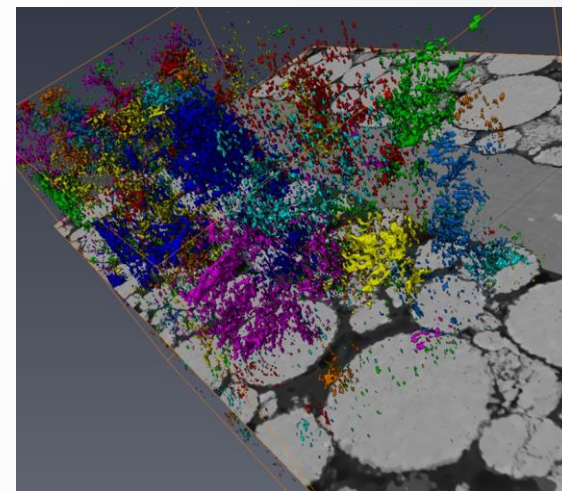
3D Imaging Analysis on NMC cathode via PFIB

3D Imaging via Auto Slice & View

Lithium ion battery: Cathode HPFIB

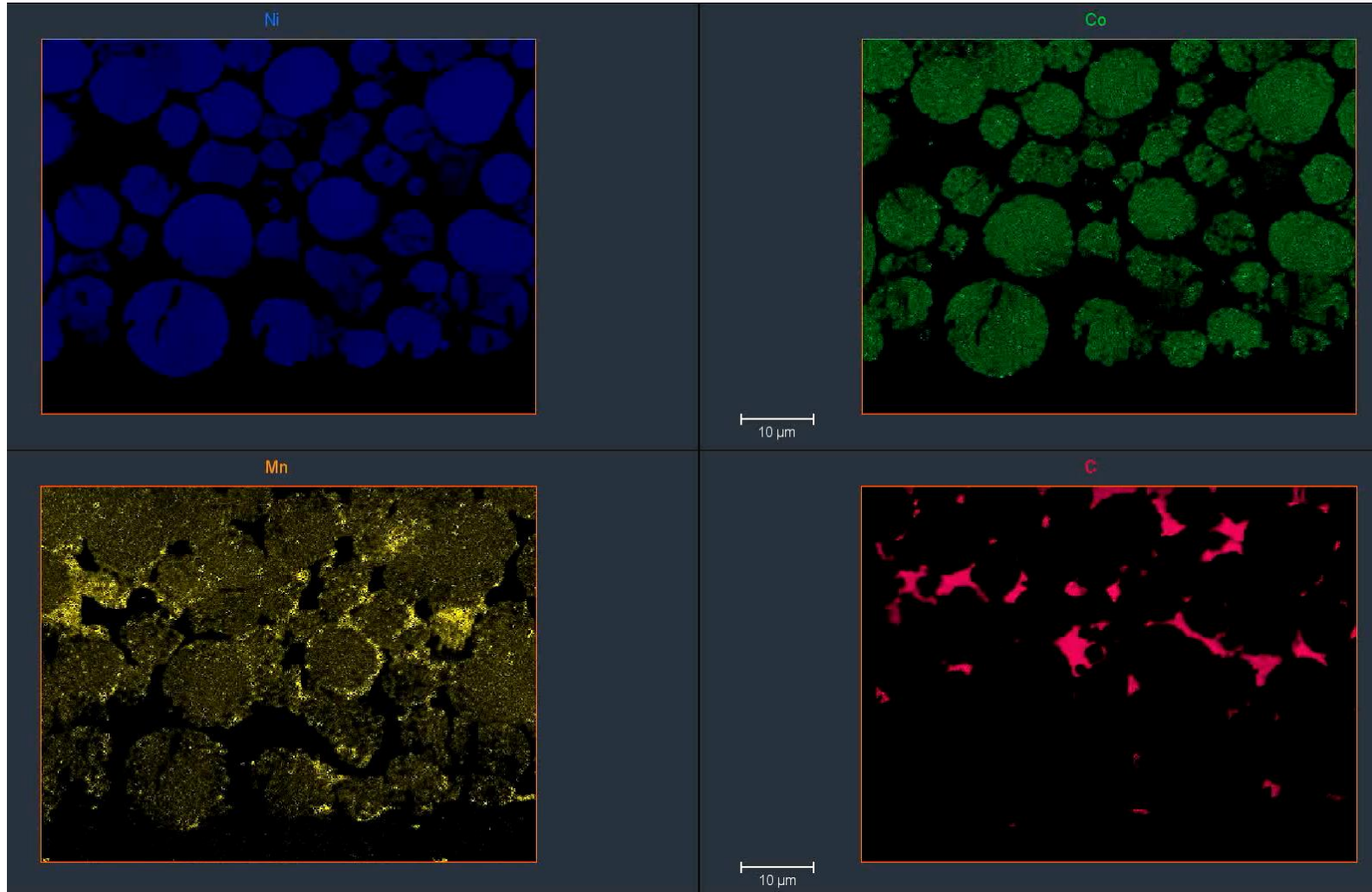


Structural Quantification via Avizo



Porosity and impregnation assessment

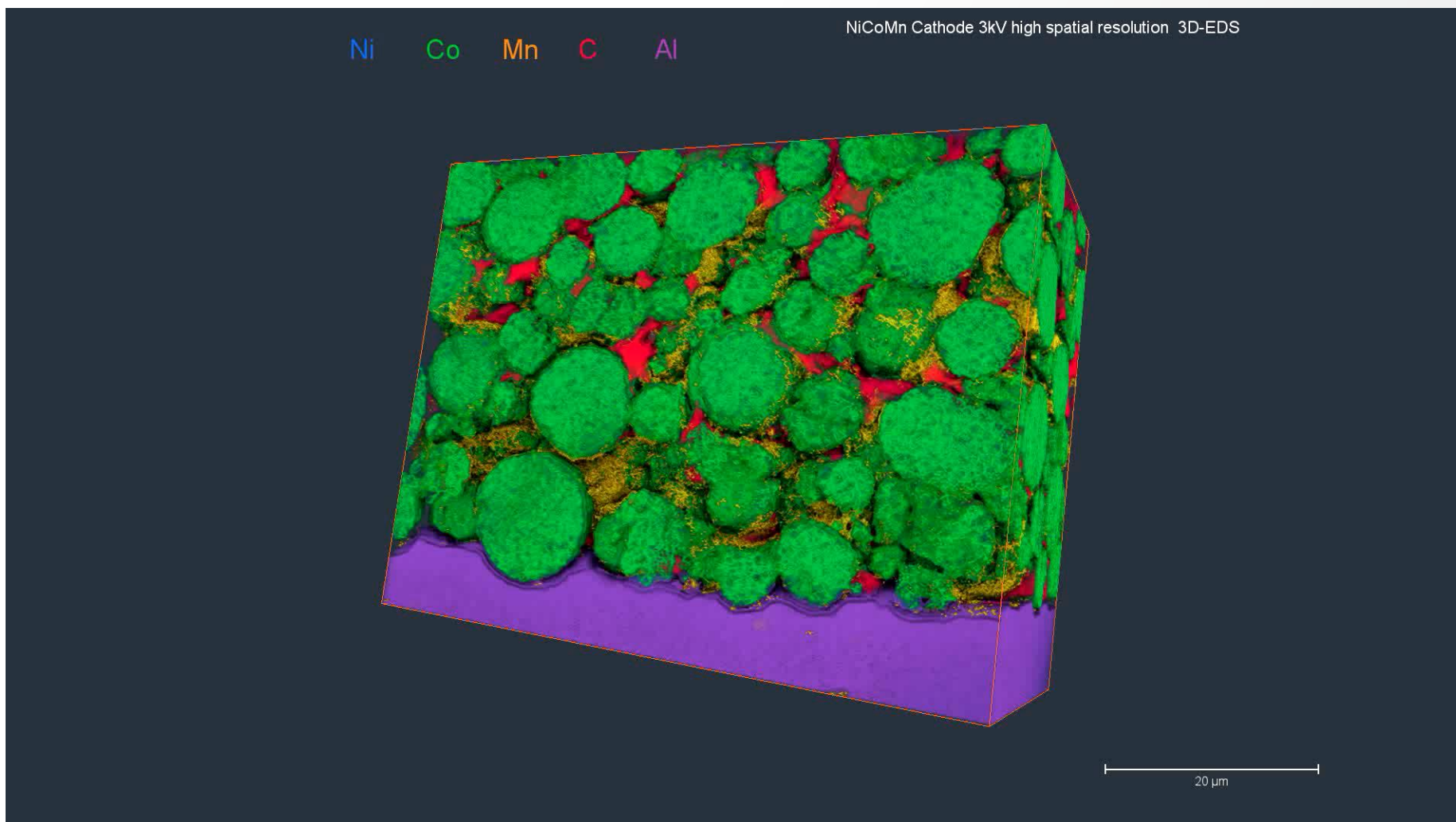
LiNiCoMnO (811) EDS3 slice movie



- The ratio of nickel to cobalt manganese 8:1:1 is the development trend. The cathode particles should be doped and coated to increase the charge and discharge cycle life of the battery.

Porosity and impregnation assessment

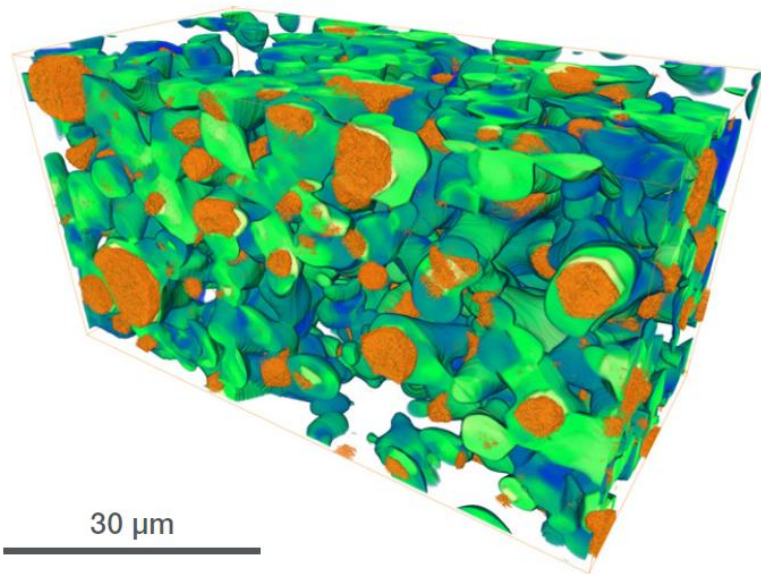
LiNiCoMnO (811) EDS3



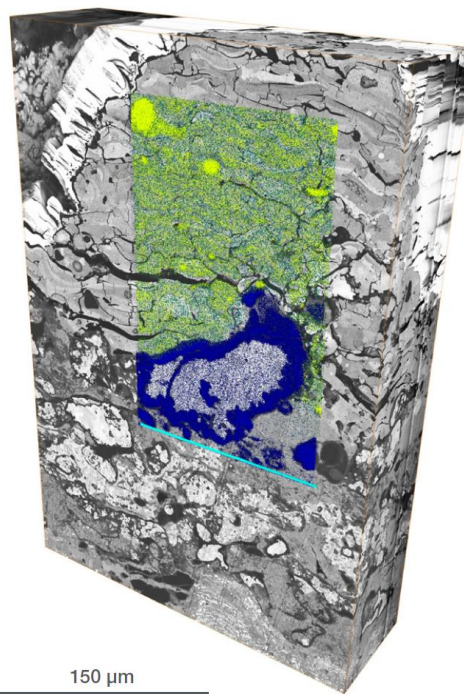
Data acquired: Devin Wu

What can we do with a Dual Beam ?

→ Structural analysis – 3D reconstruction

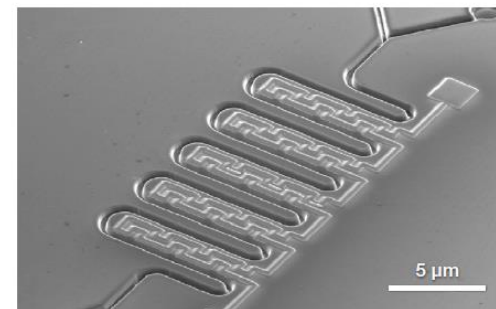


3D reconstruction of W-Mo-Cu sample using a combination of backscattered electron (green-blue) and energy dispersive X-ray (orange) data. Generated using a Scios DualBeam, Auto Slice and View Software, and visualized with Avizo Software.

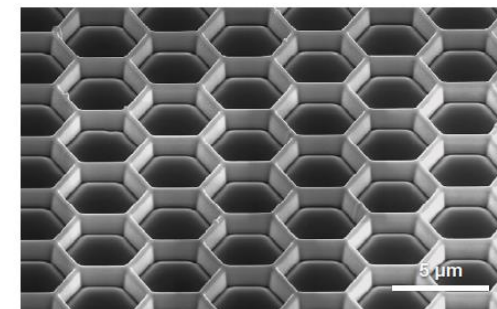


3D reconstruction of thermal barrier coating from an afterburner nozzle of a ramjet aero engine showing the microstructure state at end-of-life of the engine exhaust system. Overlaid EDS map shows elemental distribution on the top coat and bond coat interface: blue is aluminum, yellow is magnesium, and turquoise is yttria. The data have been produced with a Thermo Scientific Helios™ 5 PFIB, Auto Slice & View 5 Software and Avizo Software for Materials Science.

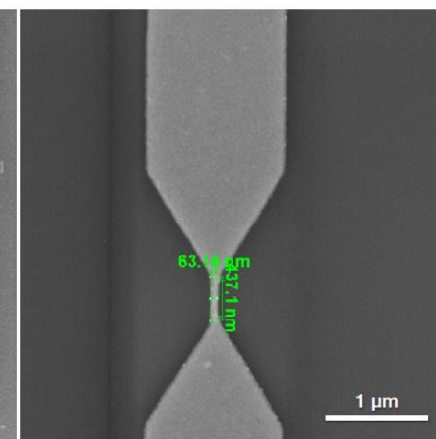
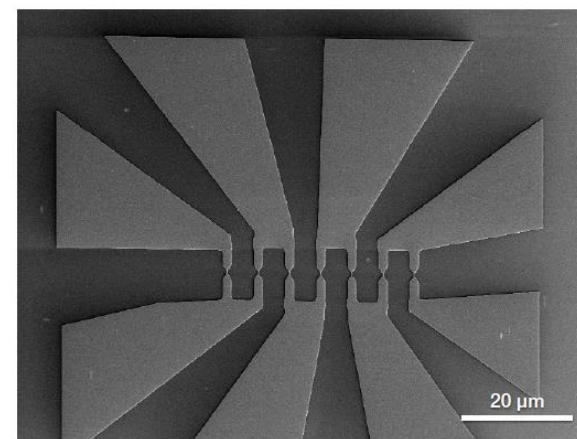
→ Nanoprototyping



A nano-fluidic system made with a multi-layered pattern in NanoBuilder Software. Each layer may consist of a deposition or milling sequence to selectively add or remove material.



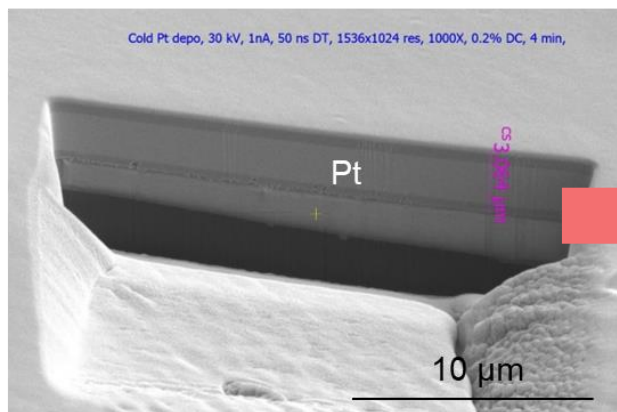
Secondary electron image of a honeycomb structure milled into a silicon substrate using a focused ion beam.



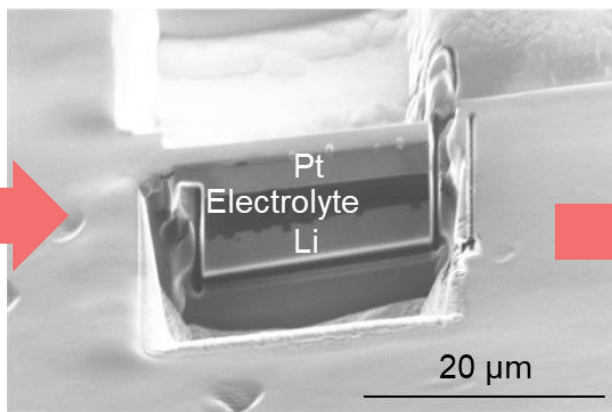
Left: Electromigration structure created with NanoBuilder Software. Right: Close up of a single channel. Critical dimensions as low as 10 nm are possible.

TEM Sample Preparation: Cryo Lift-out Process on a Li-metal Battery

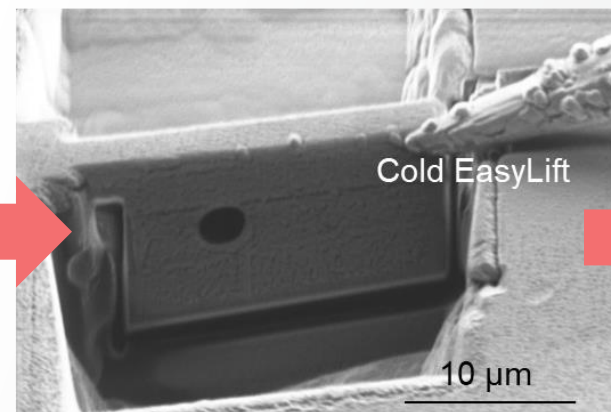
Cold Pt deposition and milling



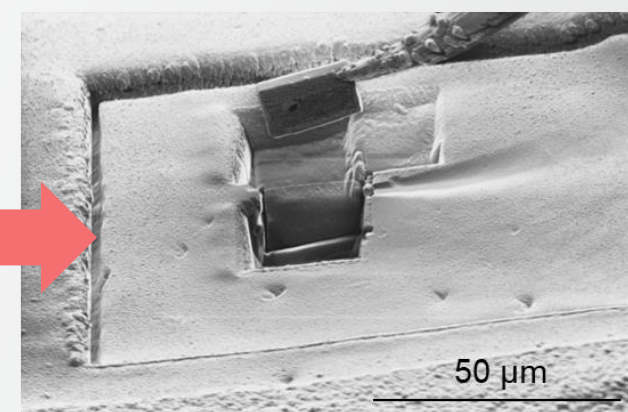
J-cut



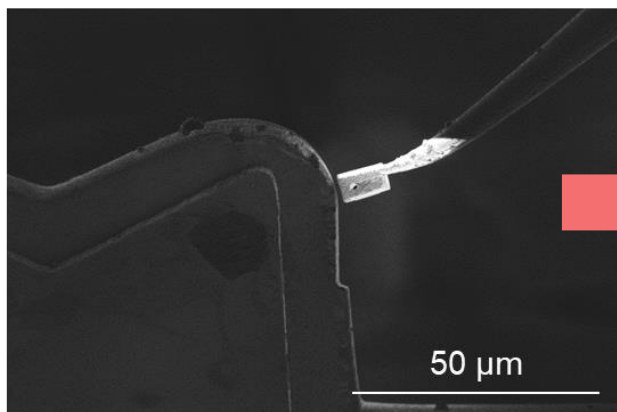
EasyLift attach



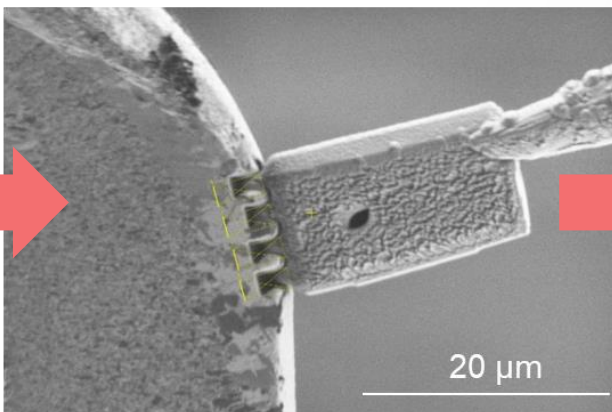
Lamella pull out



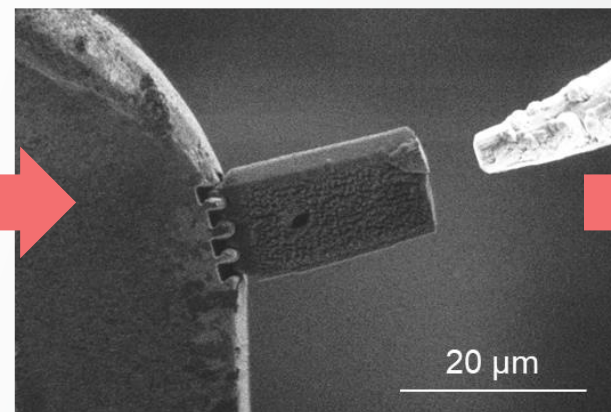
Cold lamella to grid



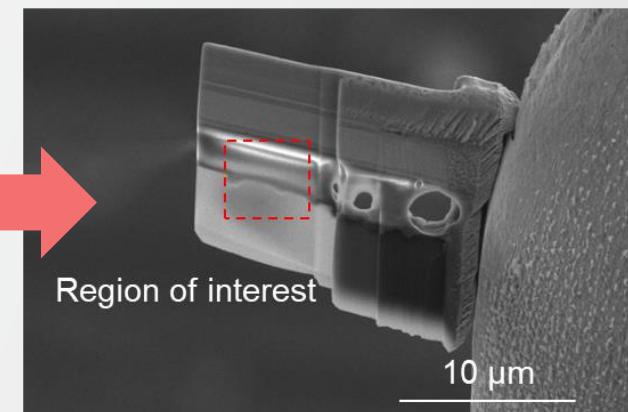
GIS free attach



EasyLift cut free



Further thinning at 100 pA



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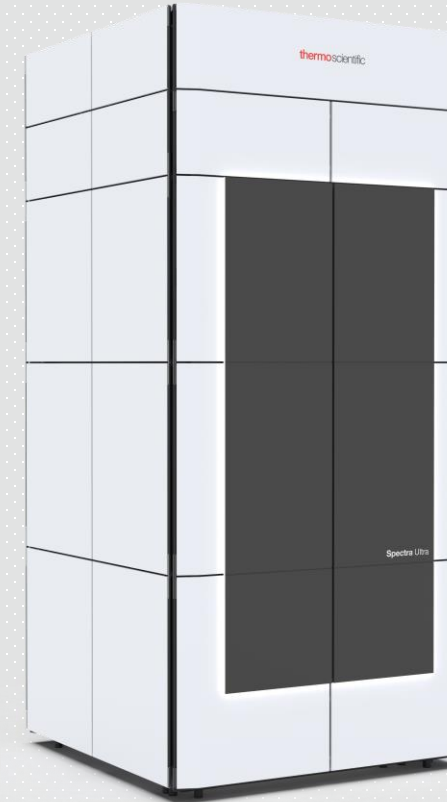
3 TEM

4 XPS

5 Inert Gas Sample Transfer Module

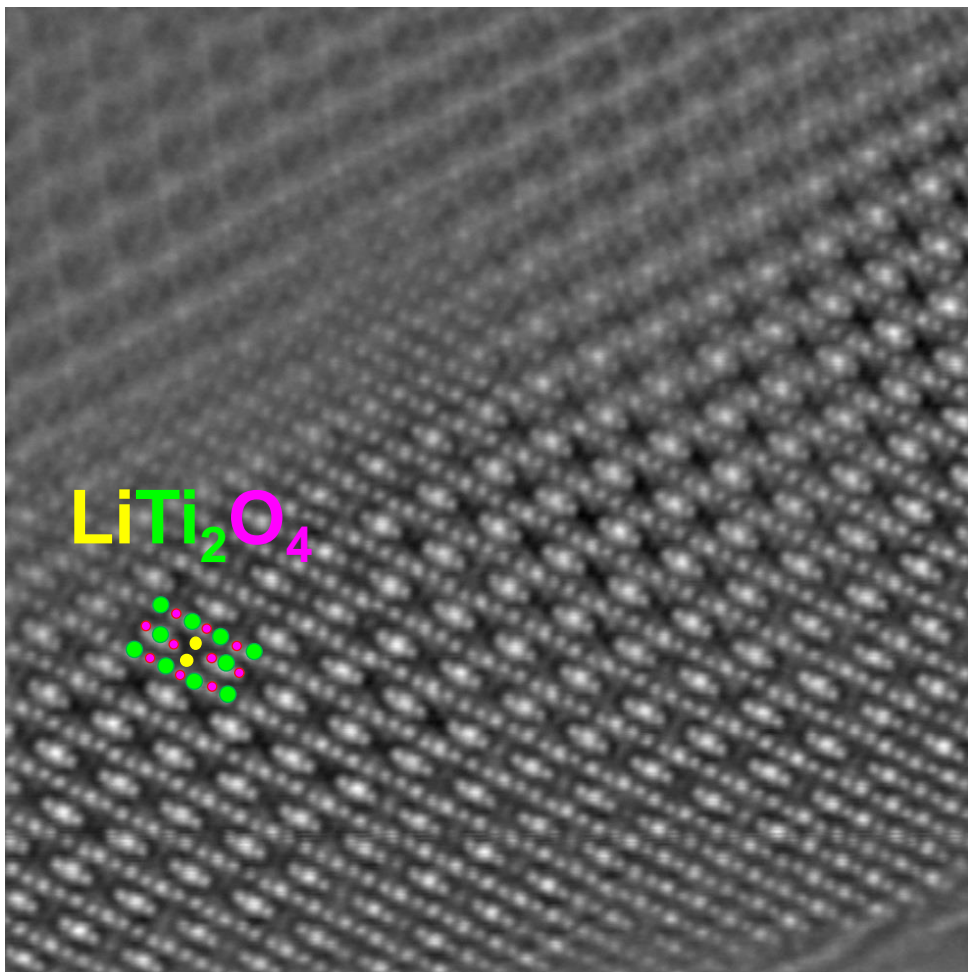
6 IonMiller

7 Avizo Software: data processing

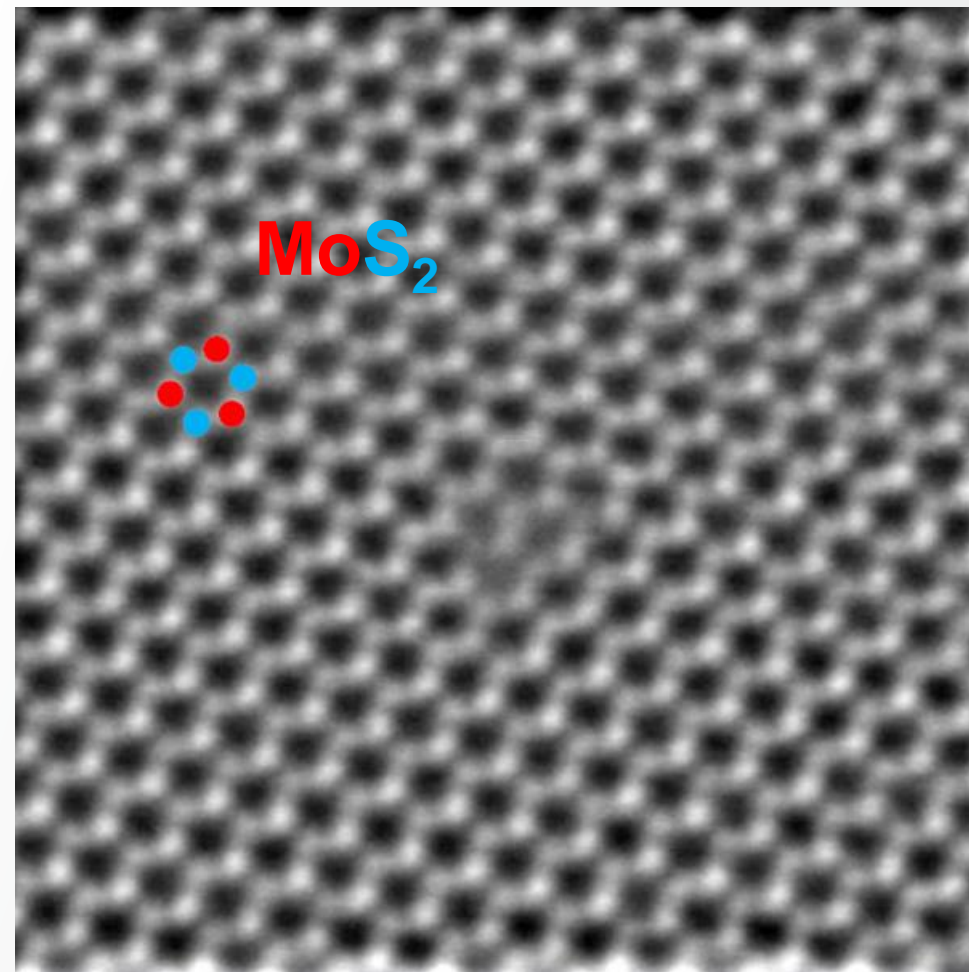


Imaging analysis of battery materials via TEM: iDPC

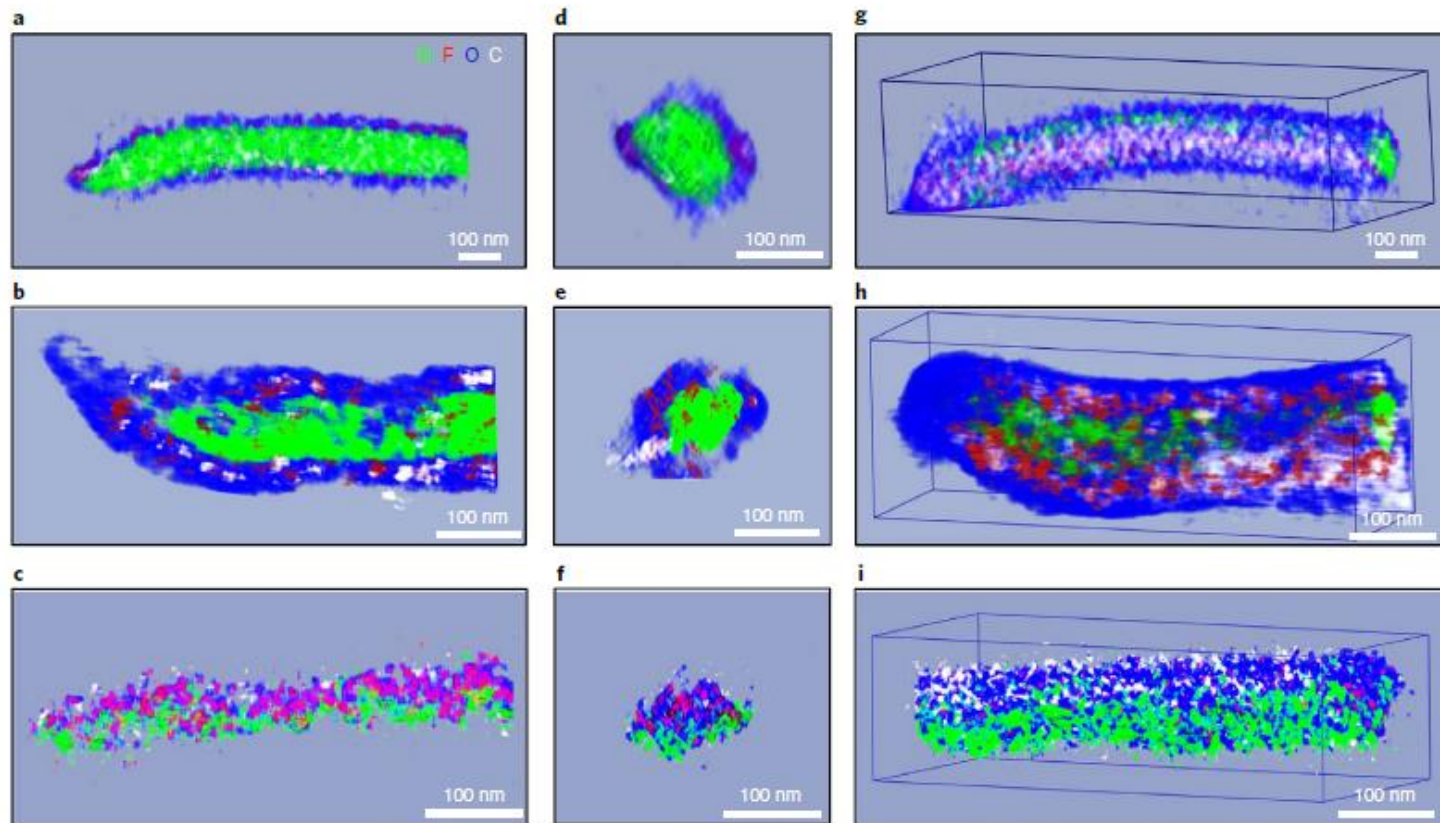
LiTi_2O_4 iDPC @ 300kV



MoS_2 bi-layer iDPC @ 30kV



Capacity fading due to SEI growth into the anode, studied in a Transmission Electron Microscope

nature
nanotechnology

ARTICLES

<https://doi.org/10.1038/s41565-021-00947-8>

Check for updates

Progressive growth of the solid-electrolyte interphase towards the Si anode interior causes capacity fading

TEM



Pacific
Northwest
NATIONAL LABORATORY

Cryo-STEM-EDS 3D Tomography to probe the SEI growth mechanism on Si-anode

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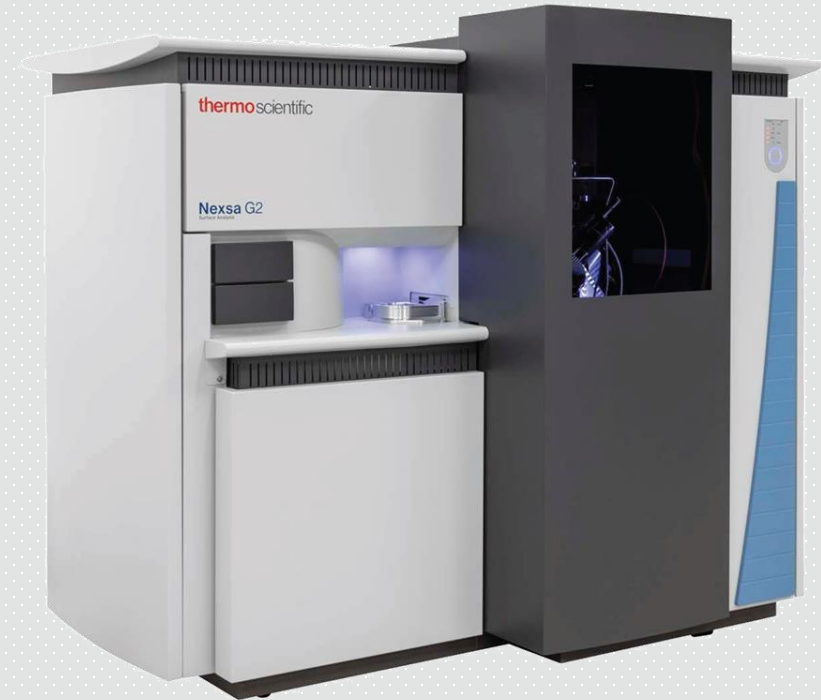
3 TEM

4 XPS

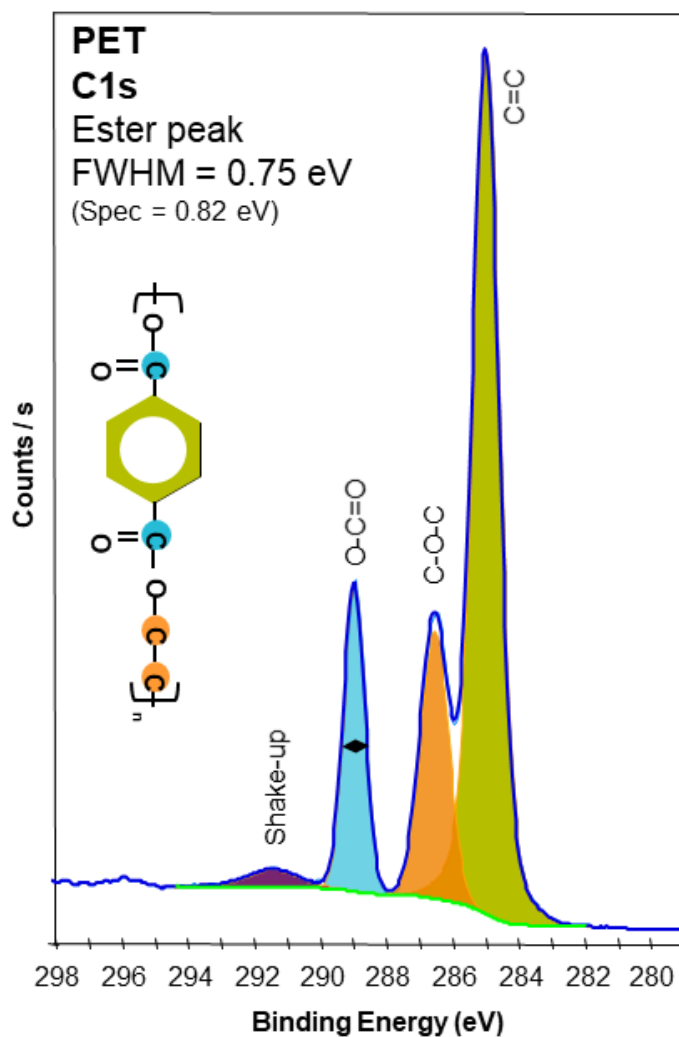
5 Inert Gas Sample Transfer Module

6 IonMiller

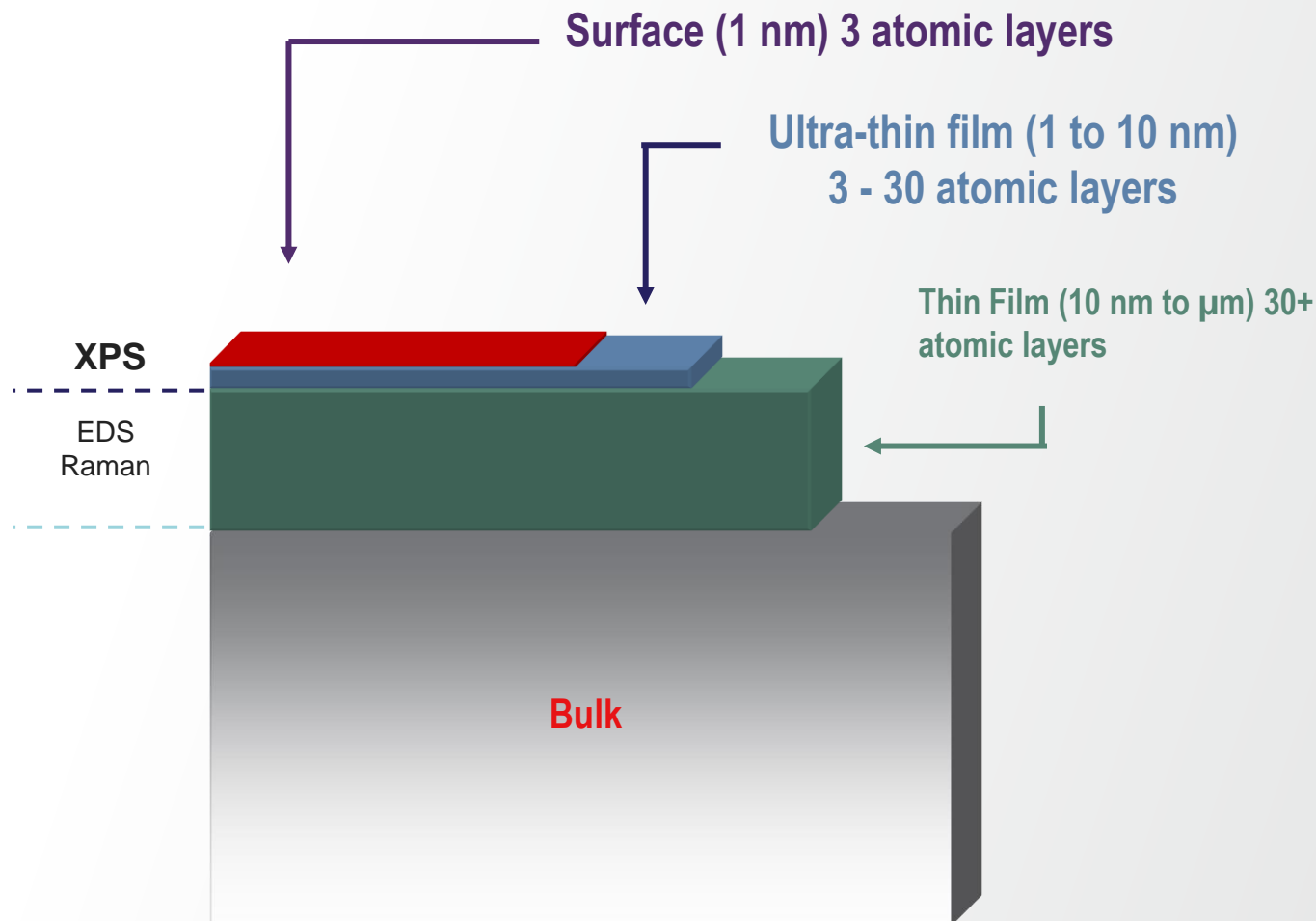
7 Avizo Software: data processing



XPS: Elemental & Chemical State Analysis of Surfaces

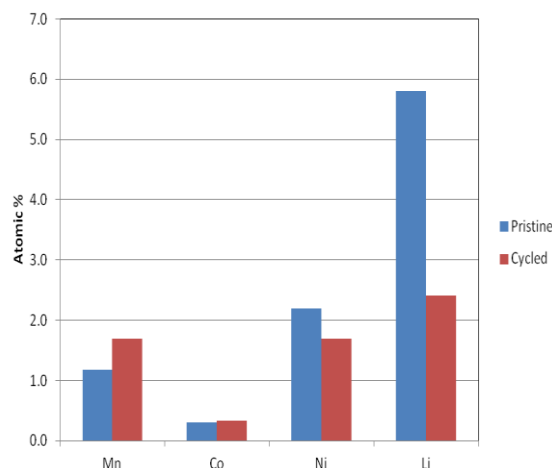


Note: Approximate layer thickness only. Actual values depend upon materials



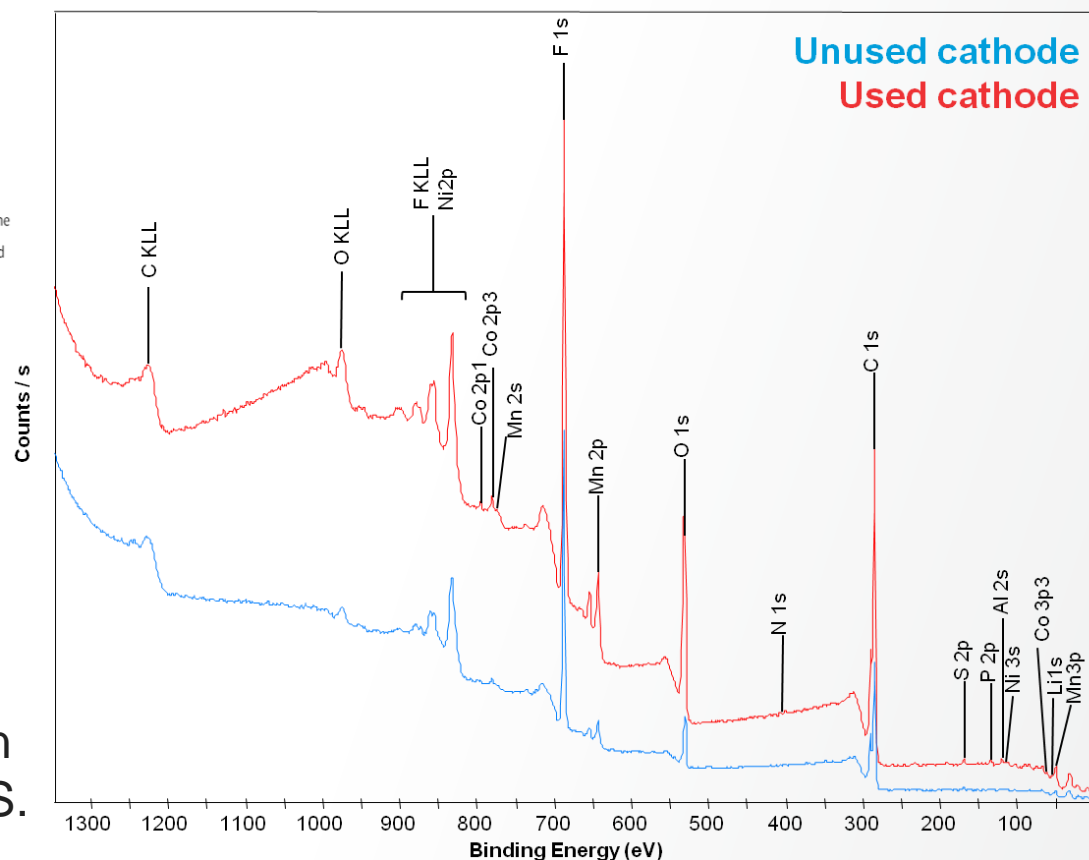
High Sensitivity XPS: Vital for Lithium Detection

- NexsaG2 has incredibly high sensitivity (6.5 million counts/s) with low X-ray power
 - Lithium is an element hard to detect, and surfaces could easily be damaged with X-rays



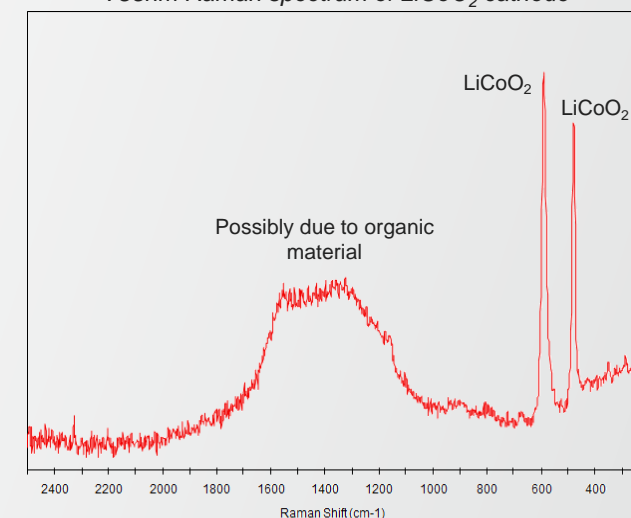
Comparison of **pristine** and **cycled** cathode material.

Variation in Li concentration is clearly evidenced by XPS.

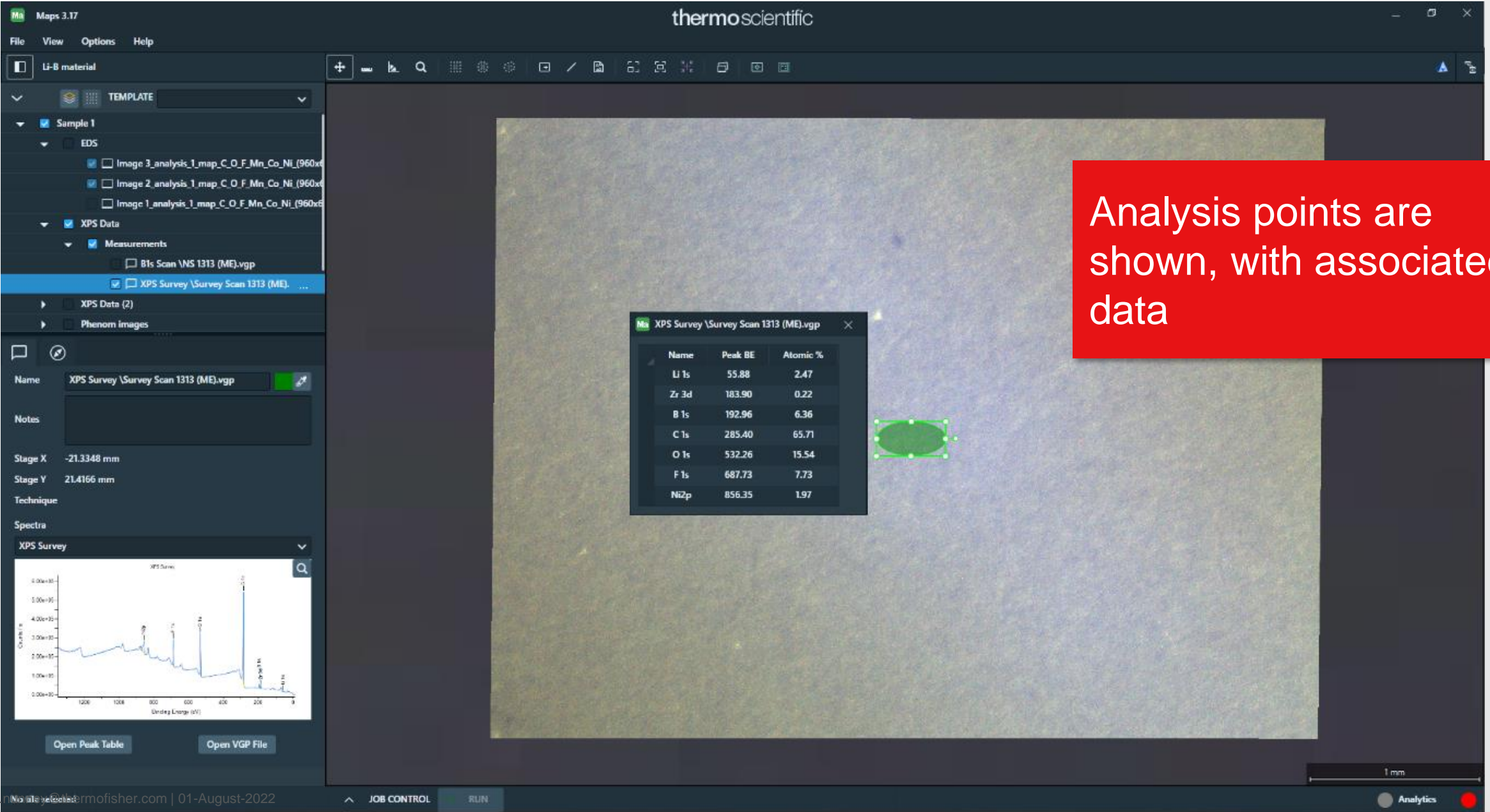


Co-incident Raman on NexsaG2 allows for bulk structural analysis of cathode material!

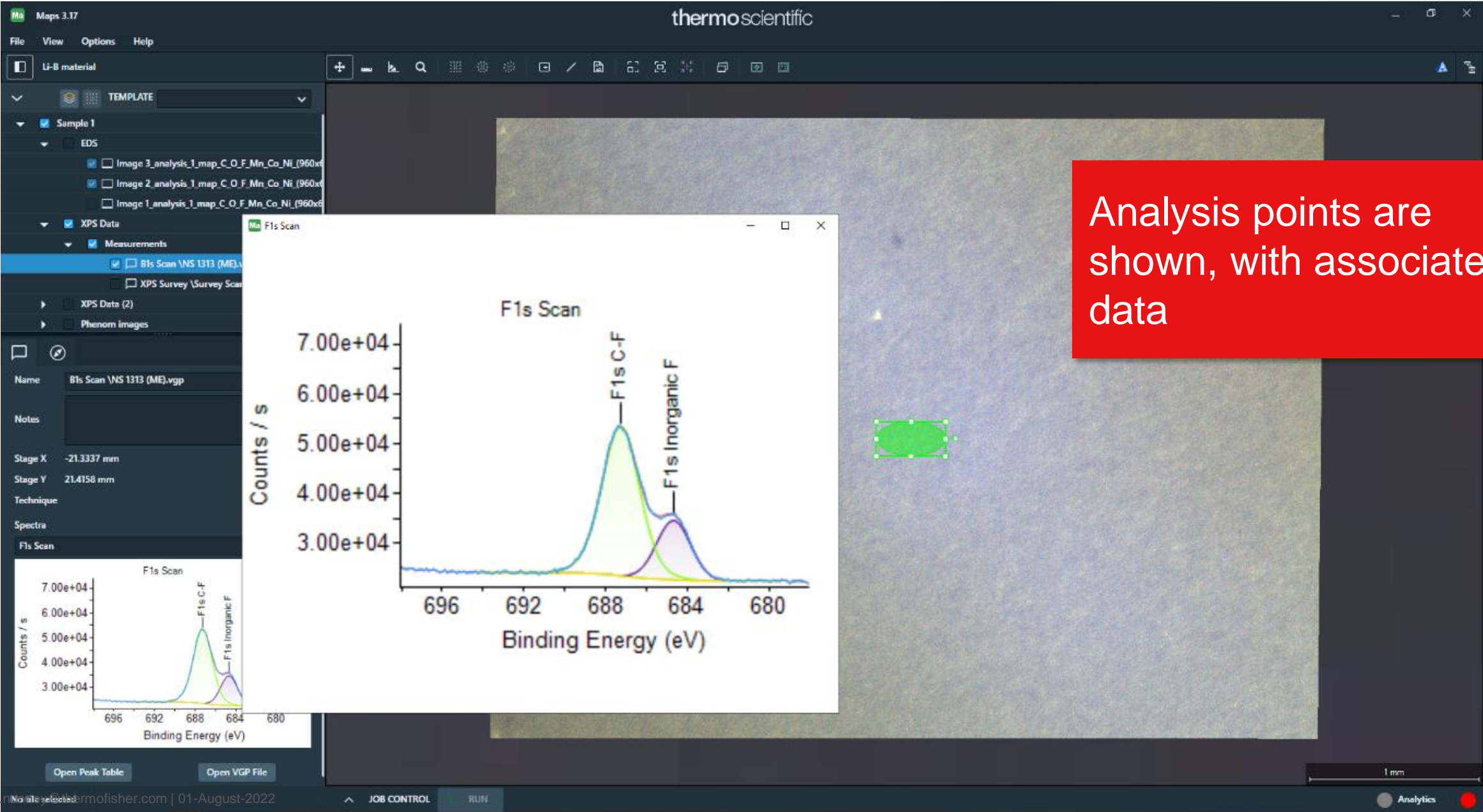
785nm Raman spectrum of LiCoO₂ cathode



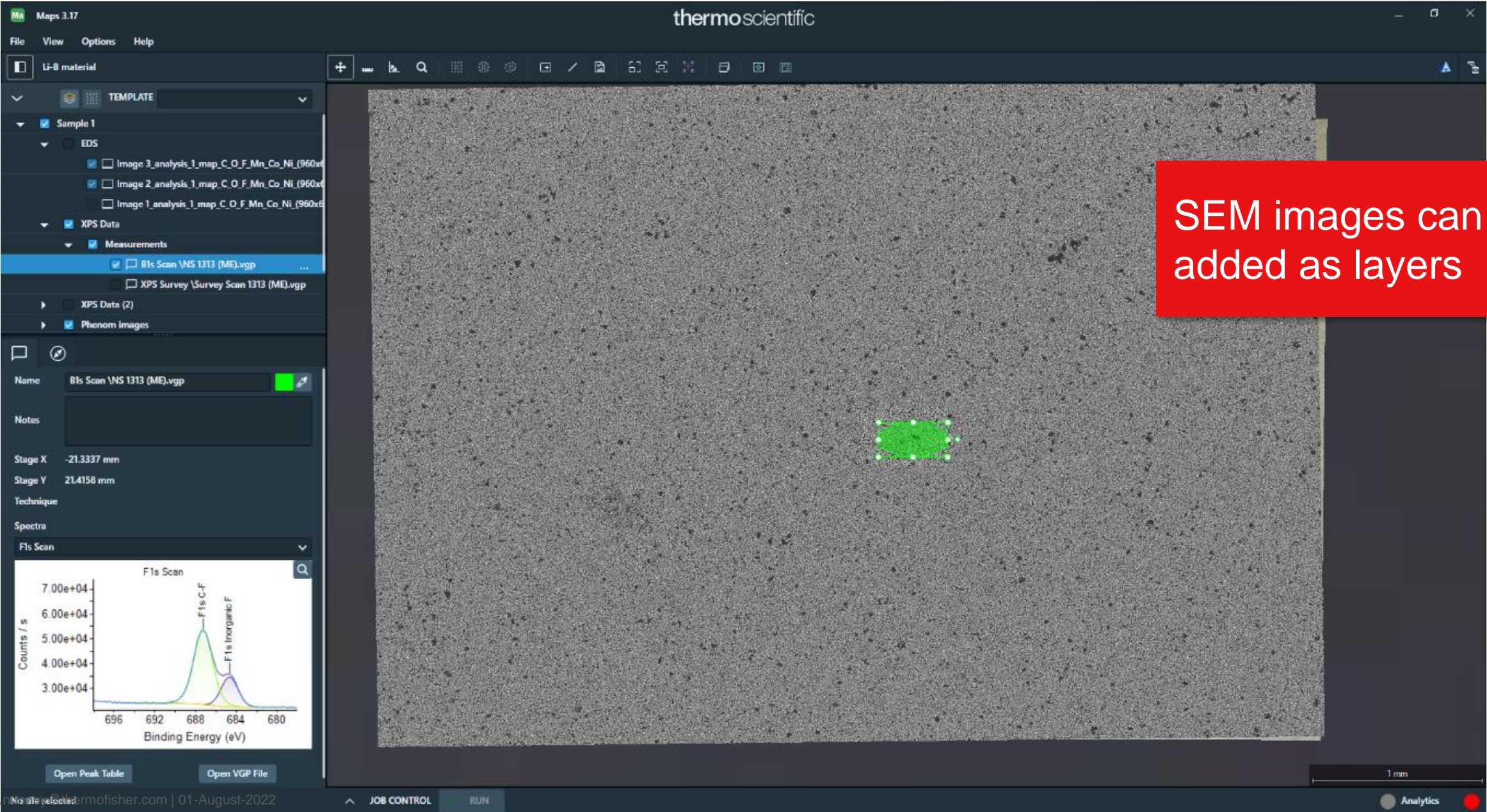
CISA: Correlative Microscopy → XPS x SEM



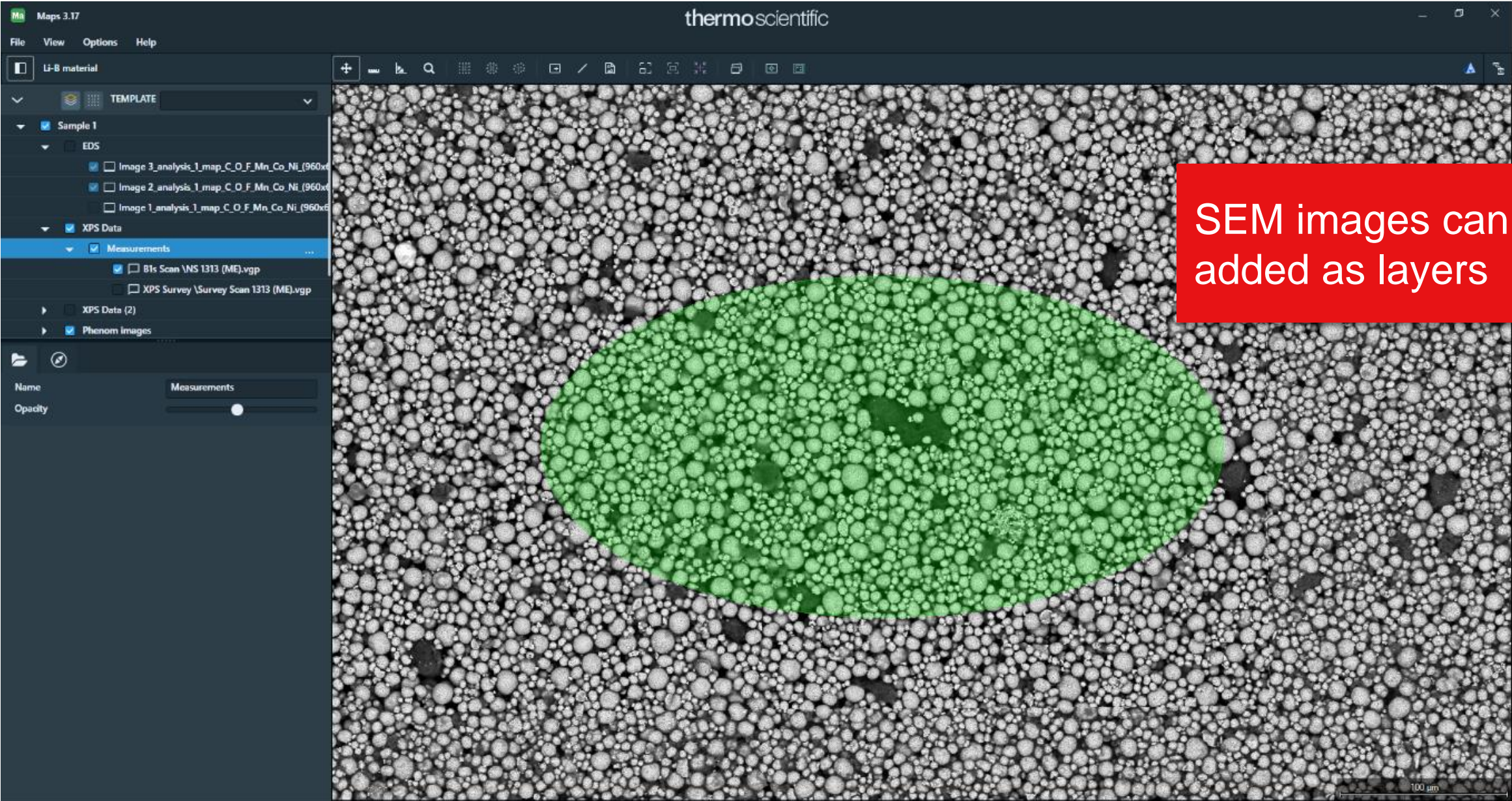
Example: Li-ion battery cathode



Example: Li-ion battery cathode

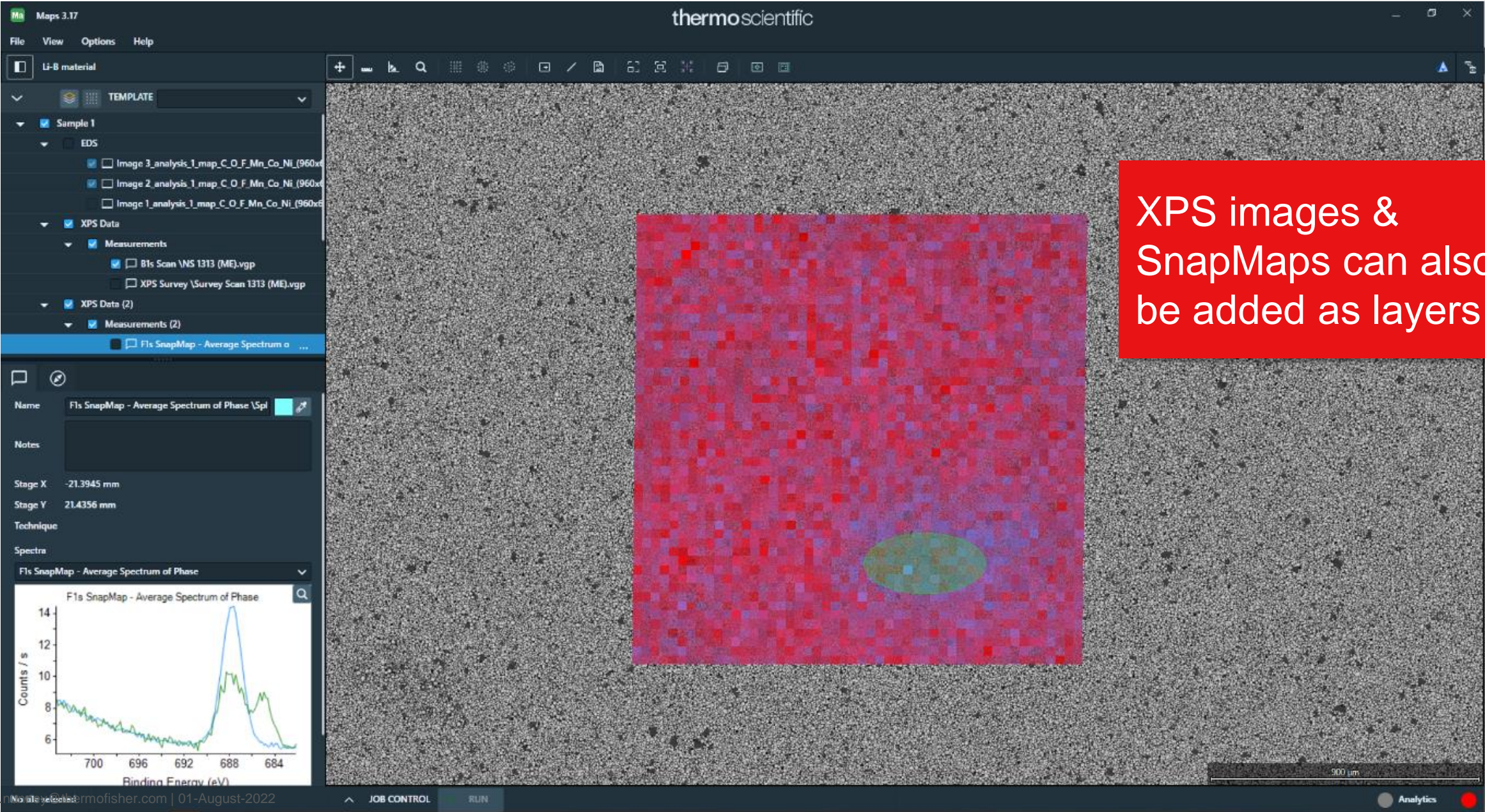


Example: Li-ion battery cathode

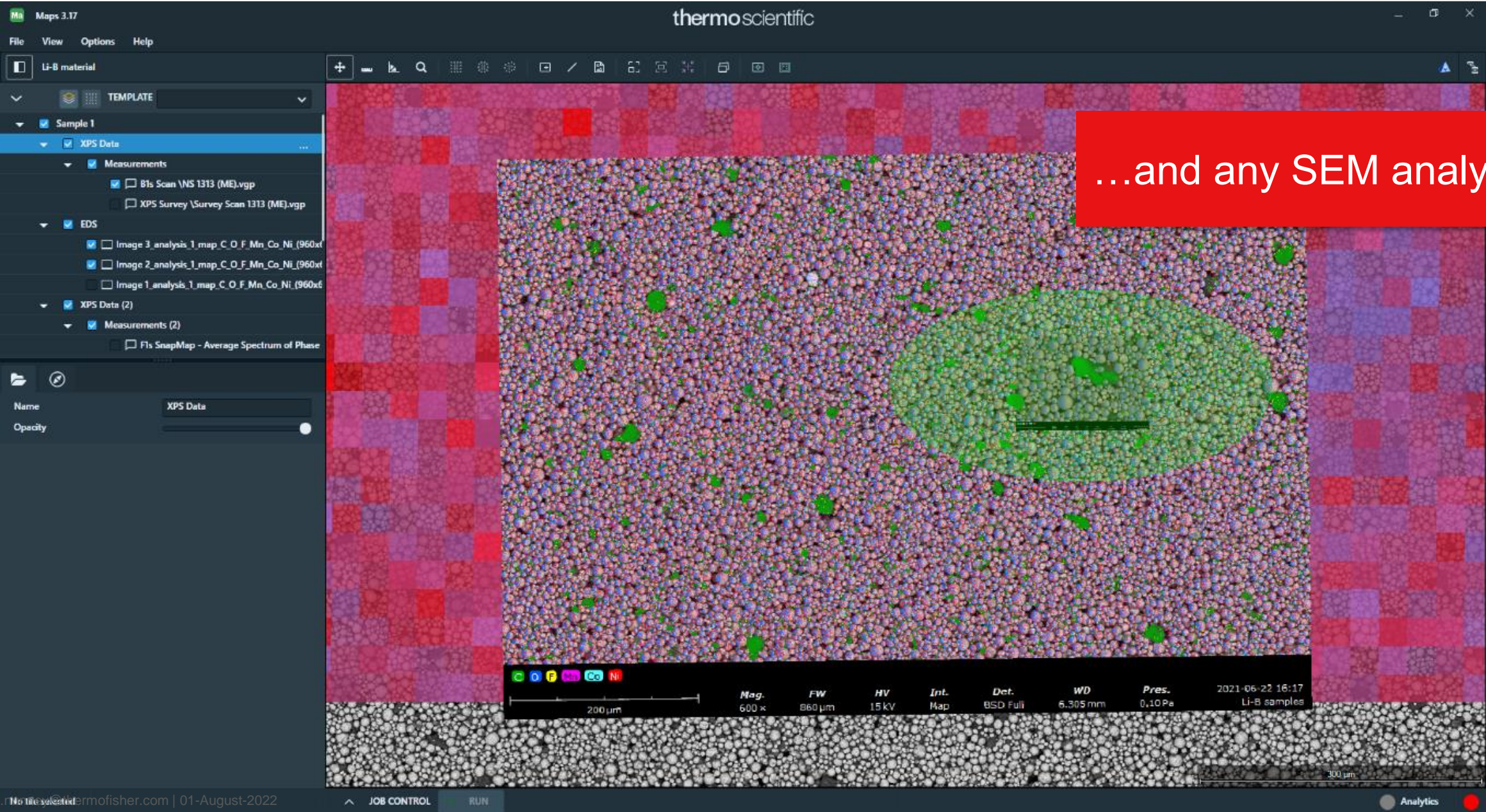


SEM images can be added as layers

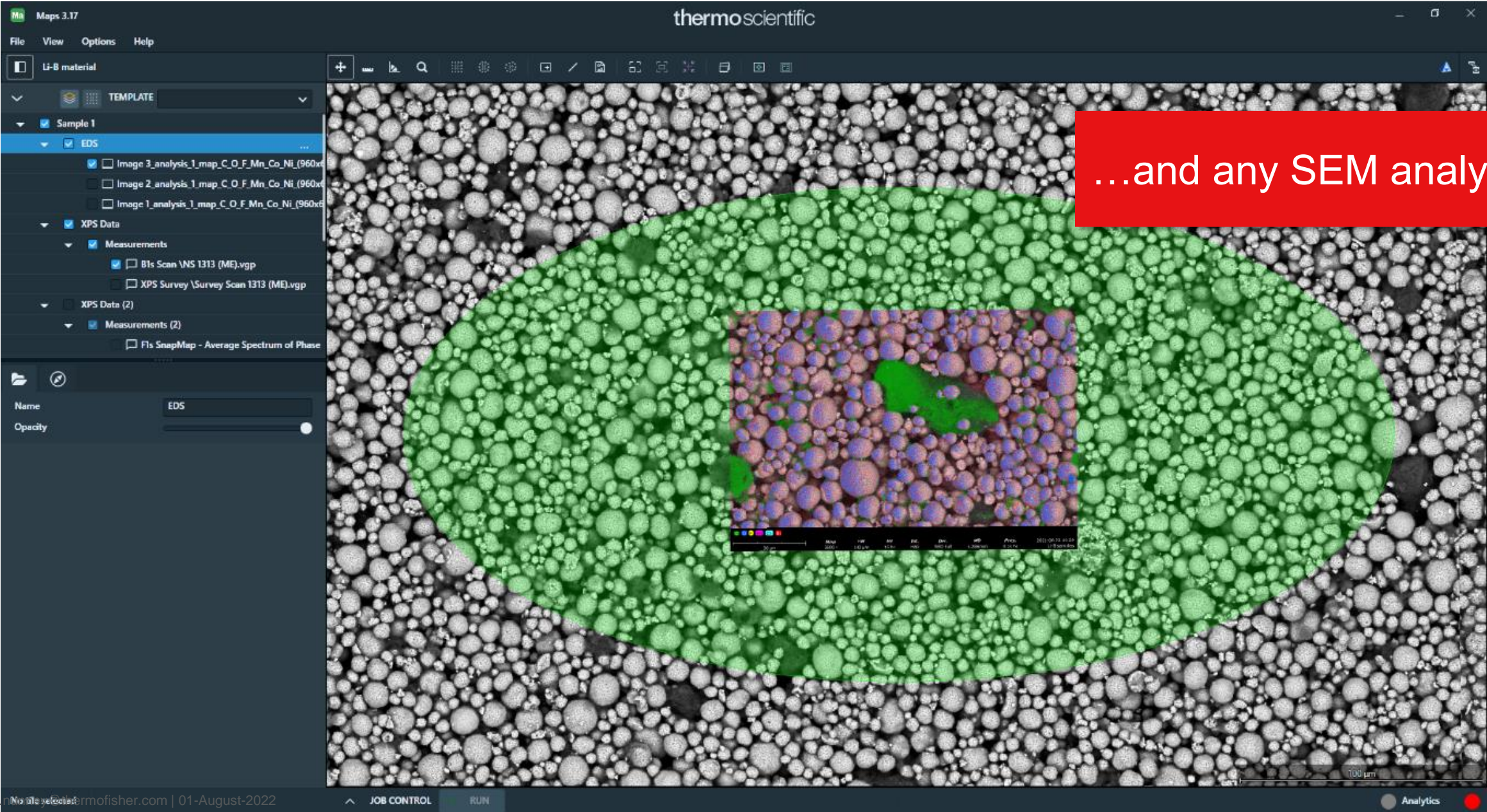
Example: Li-ion battery cathode



Example: Li-ion battery cathode



Example: Li-ion battery cathode



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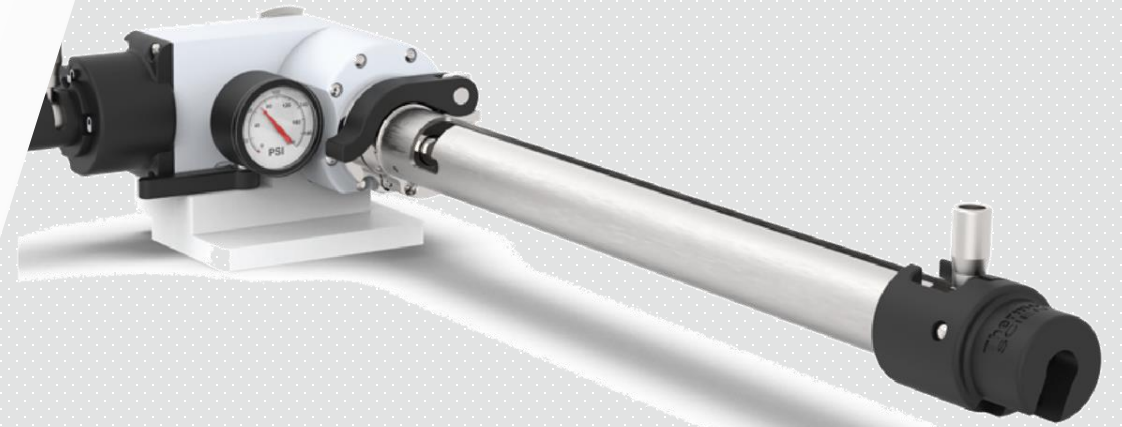
3 TEM

4 XPS

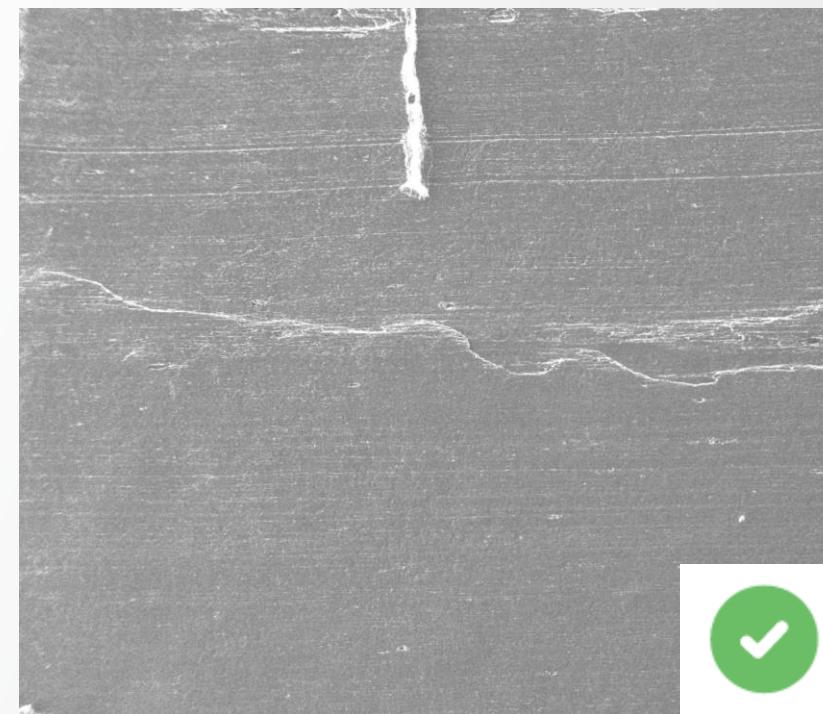
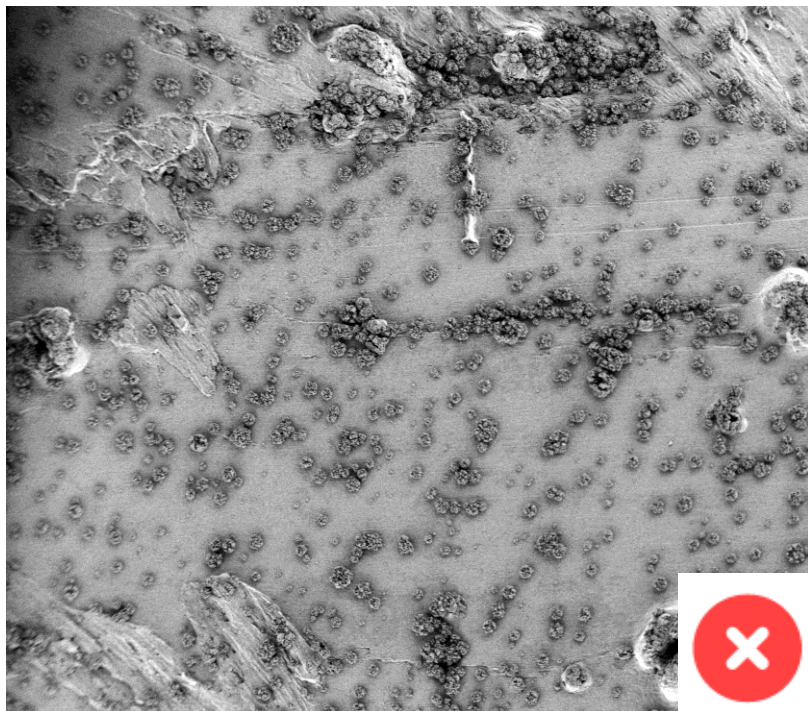
5 Inert Gas Sample Transfer Module

6 IonMiller

7 Avizo Software: data processing



How to observe the sample at its native state in the **electron microscope**?

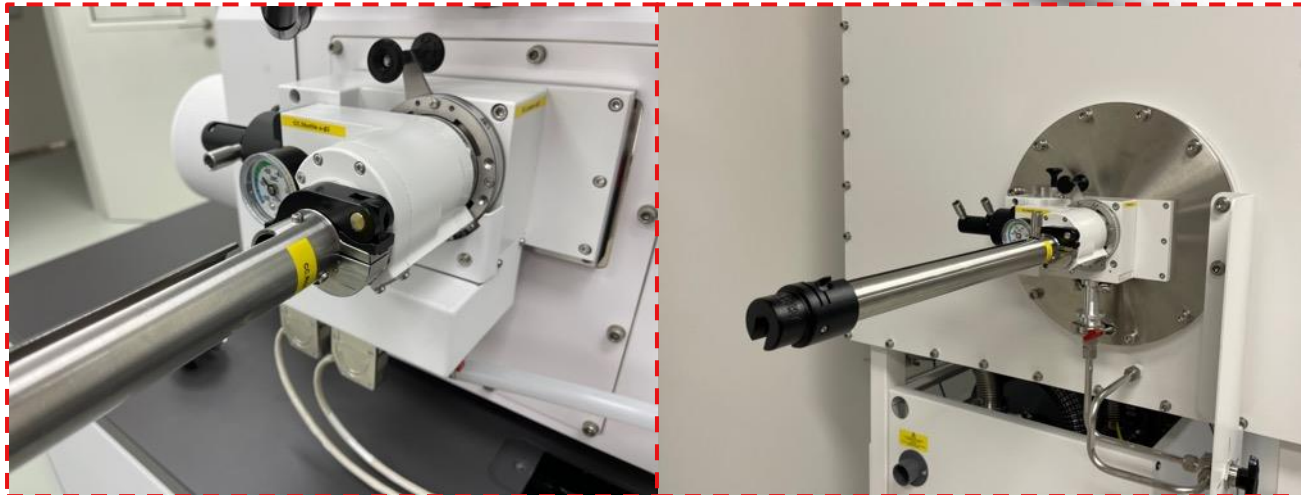


**We want to observe
initial state → Inert Gas Condition**

CleanConnect™ key benefits



positive argon pressure



Microscope side

Glovebox side

Key Benefits

Sample integrity is preserved by the use of inert gas sample transfer

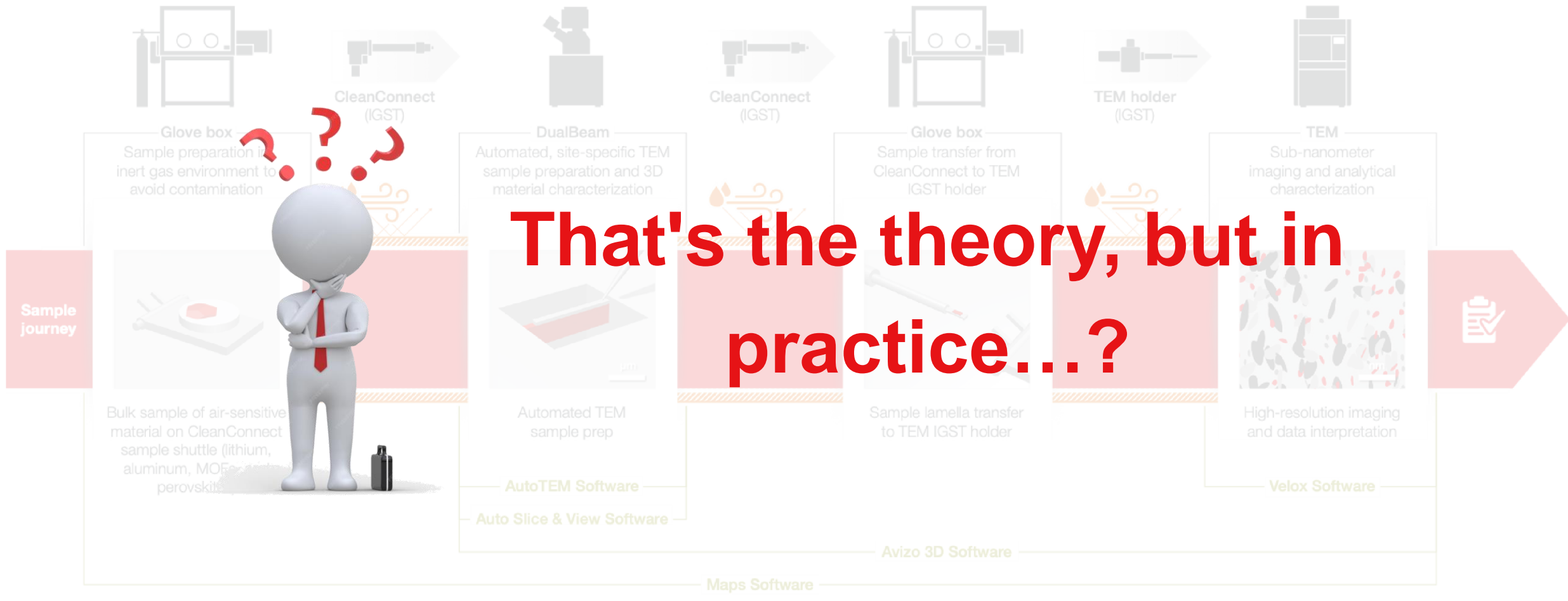
Seamless, automatic integration to a variety of Thermo Scientific SEM/DualBeams

Compatible with Cryo-stage with no any changes in system or microscope

Ergonomic and modular design enables uncomplicated sample handling

Compatible with most glove box systems and available with optional direct glove box connectivity

Thermo Scientific Inert Gas Sample Transfer workflow



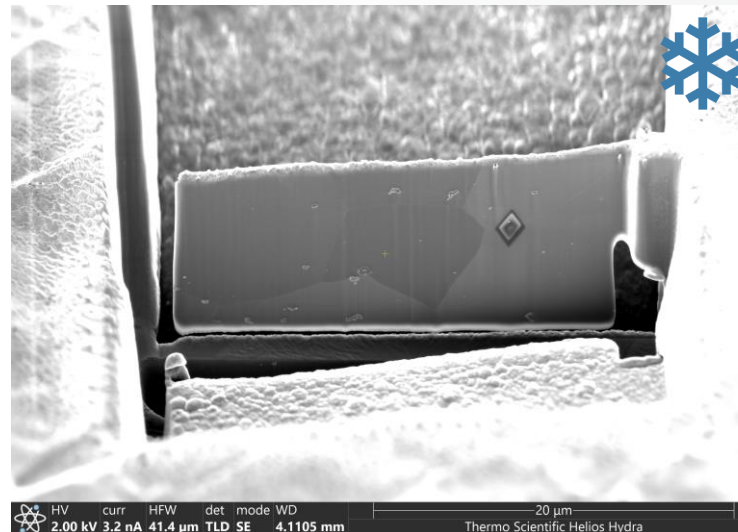
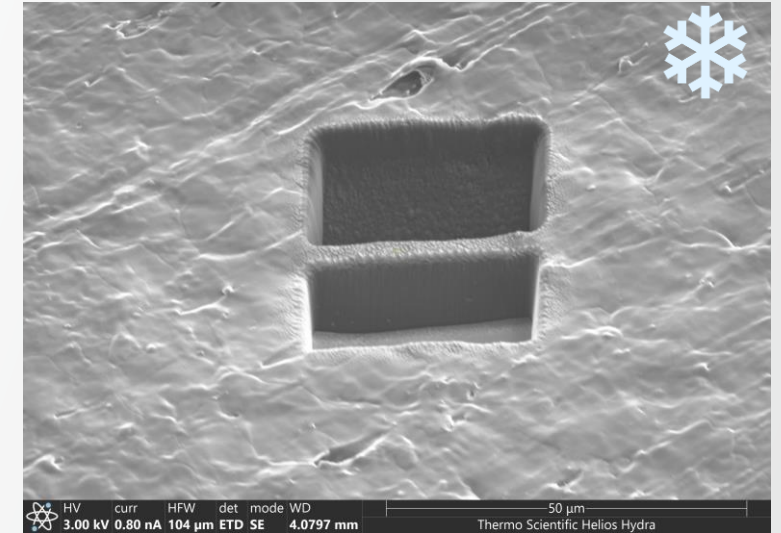
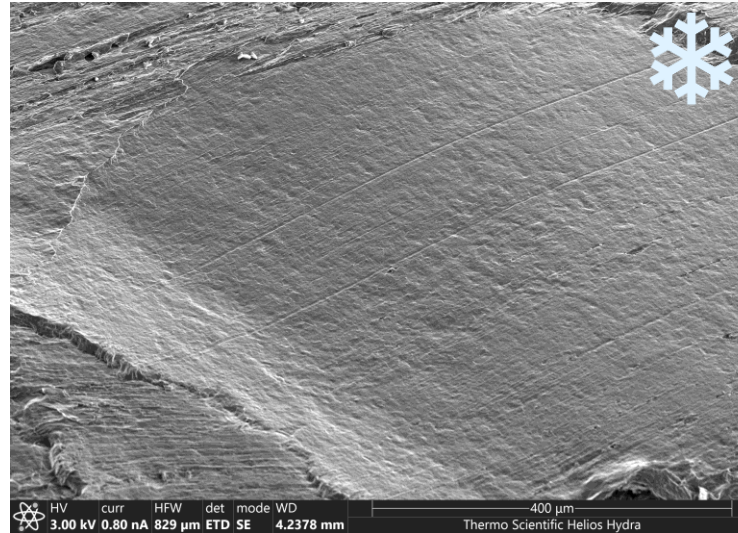
Application of IGST workflow on air-sensitive material

Proof Material #3: Li-metal lamellae preparation (Ar⁺ ion) and imaging

Helios Hydra PFIB



Whole process under
cryogenic condition at
-178 °C



**Lamellae not fine
enough for SEM
observation
→ slim down with
Arg milling beam**

Sample preparation using cryo PFIB (~ -180 °C)

Proof Material #3: Li-metal lamellae preparation (Ar⁺ ion) and imaging

Helio Hydra PFIB

- **Glove box → FIB** ✓
- **FIB → SEM ?**

Manipulator was held at
cryogenic temperatures
during the lift out

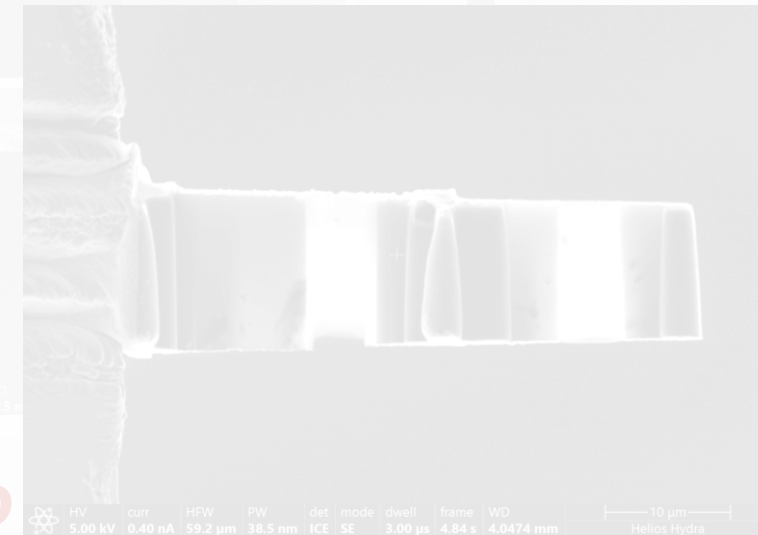
EasyLift Manipulator



Whole process under
cryogenic condition at
-178 °C

Only 100 nm thick !

Huge surface x volume ratio

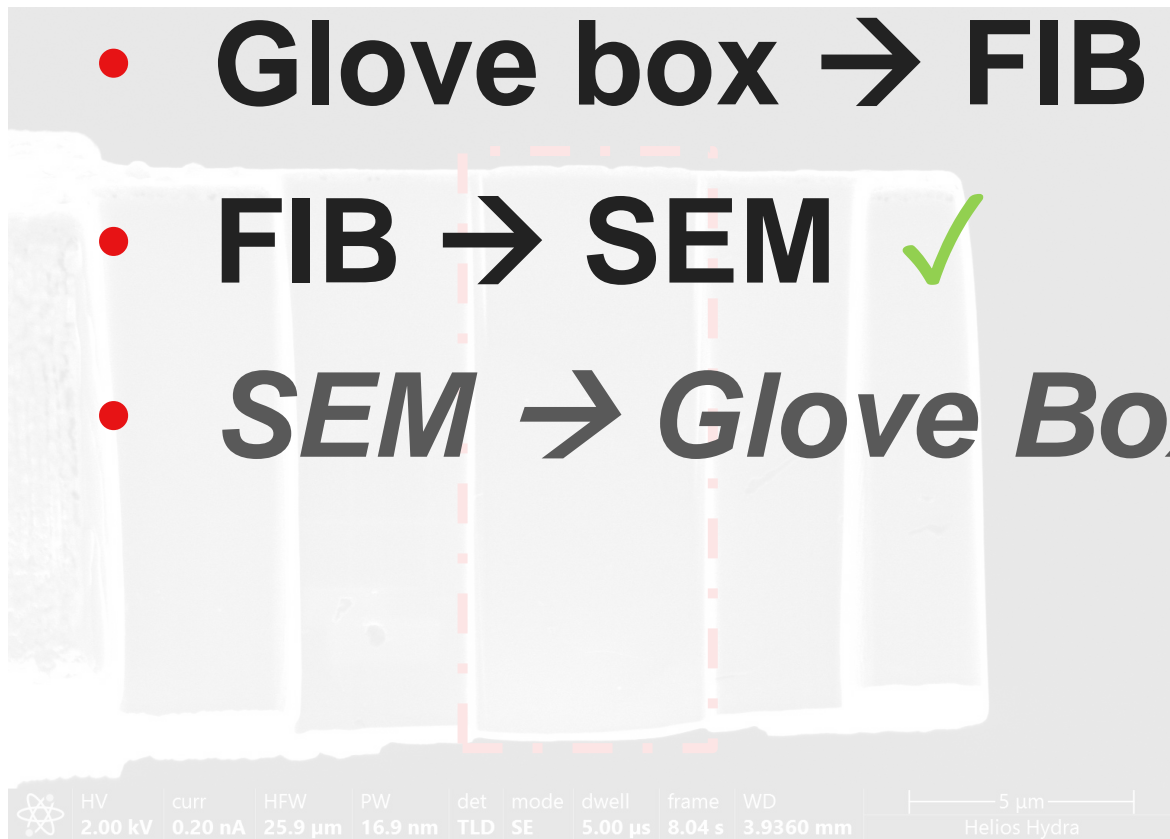


Application of IGST on air-sensitive materials

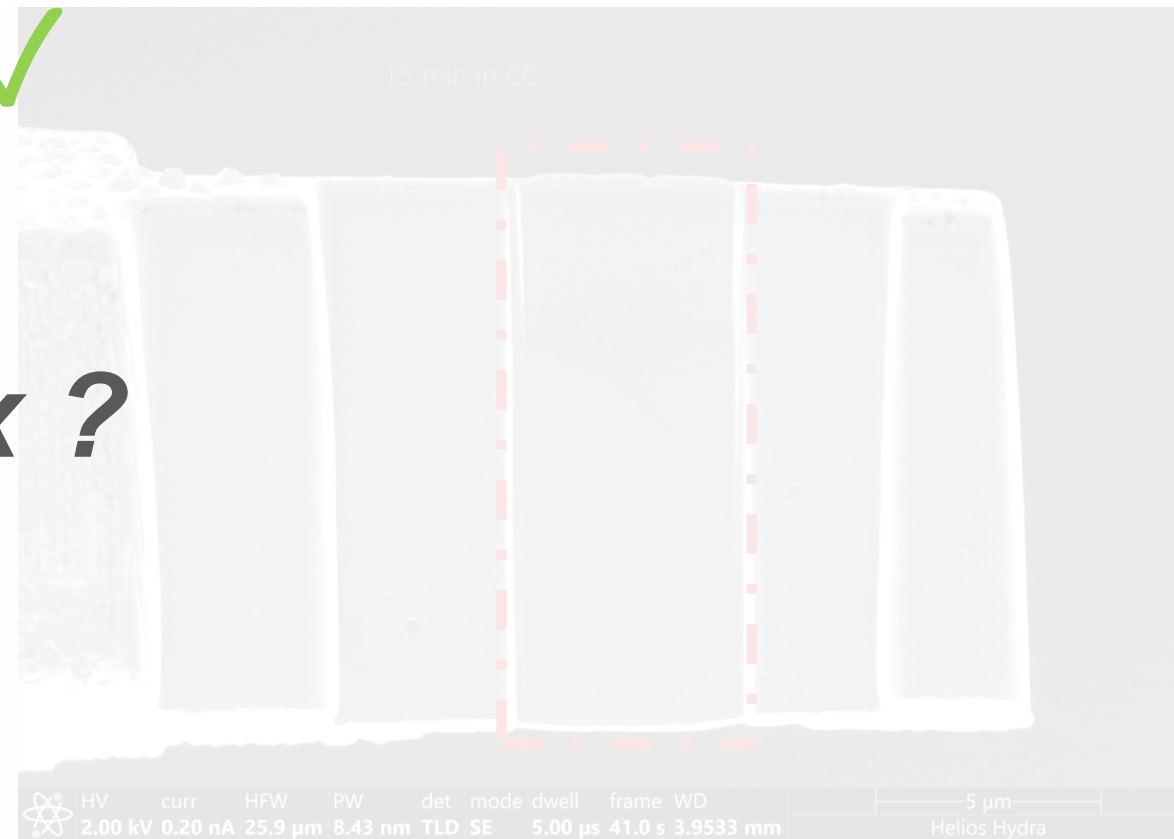
Proof Material #3: Li-metal lamellae preparation (Ar⁺ ion) and imaging

1st image inside the Helios chamber

- **Glove box → FIB** ✓
- **FIB → SEM** ✓
- **SEM → Glove Box ?**



2nd image inside the Helios chamber
after 15 minutes in CleanConnect



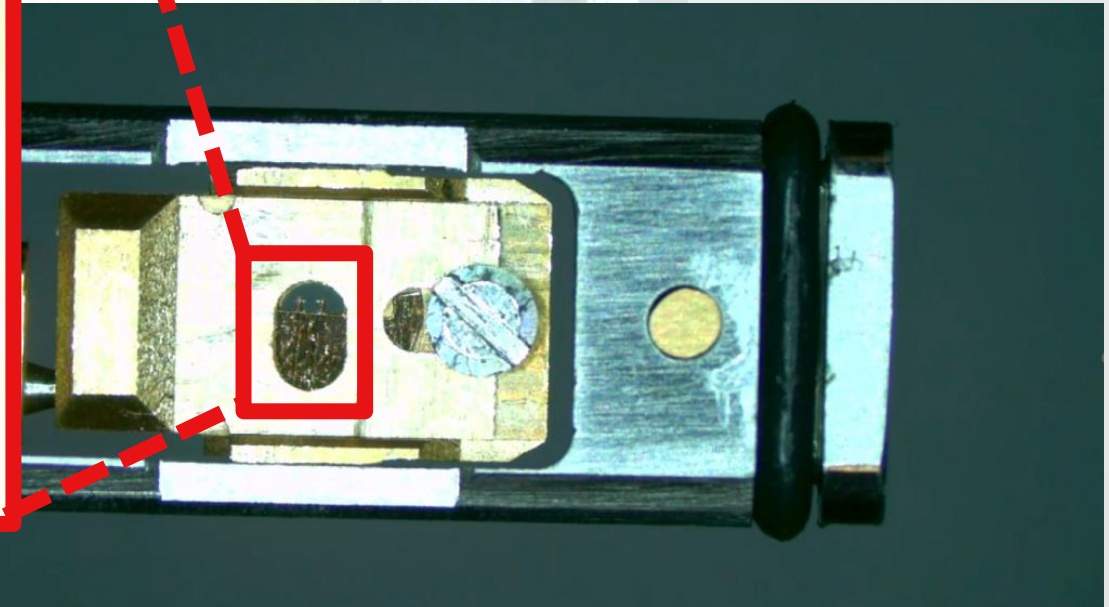
Excellent protection of Li-metal lamellae via CleanConnect

CleanConnect

- **Glove box → FIB** ✓
- **FIB → SEM** ✓
- **SEM → Glove Box** ✓
- *Glove Box → TEM ?*



Transfer to Cryo-IGST TEM holder



TEM Imaging

Acquired in Velox software using Ceta

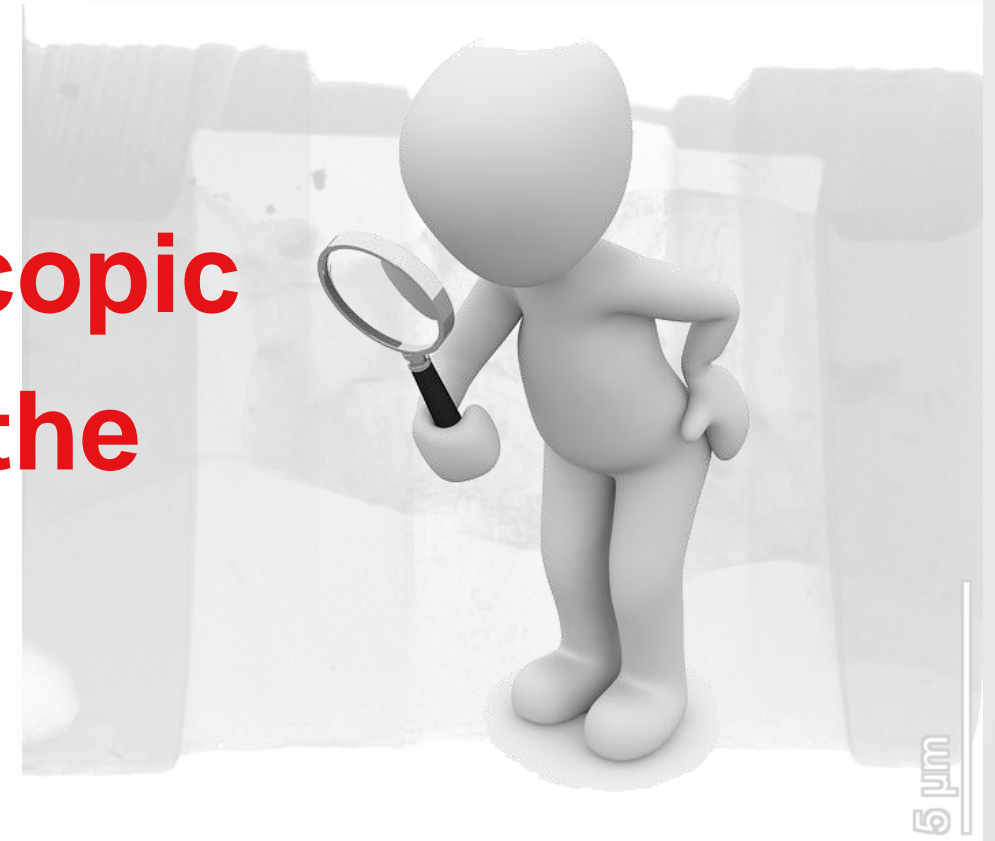
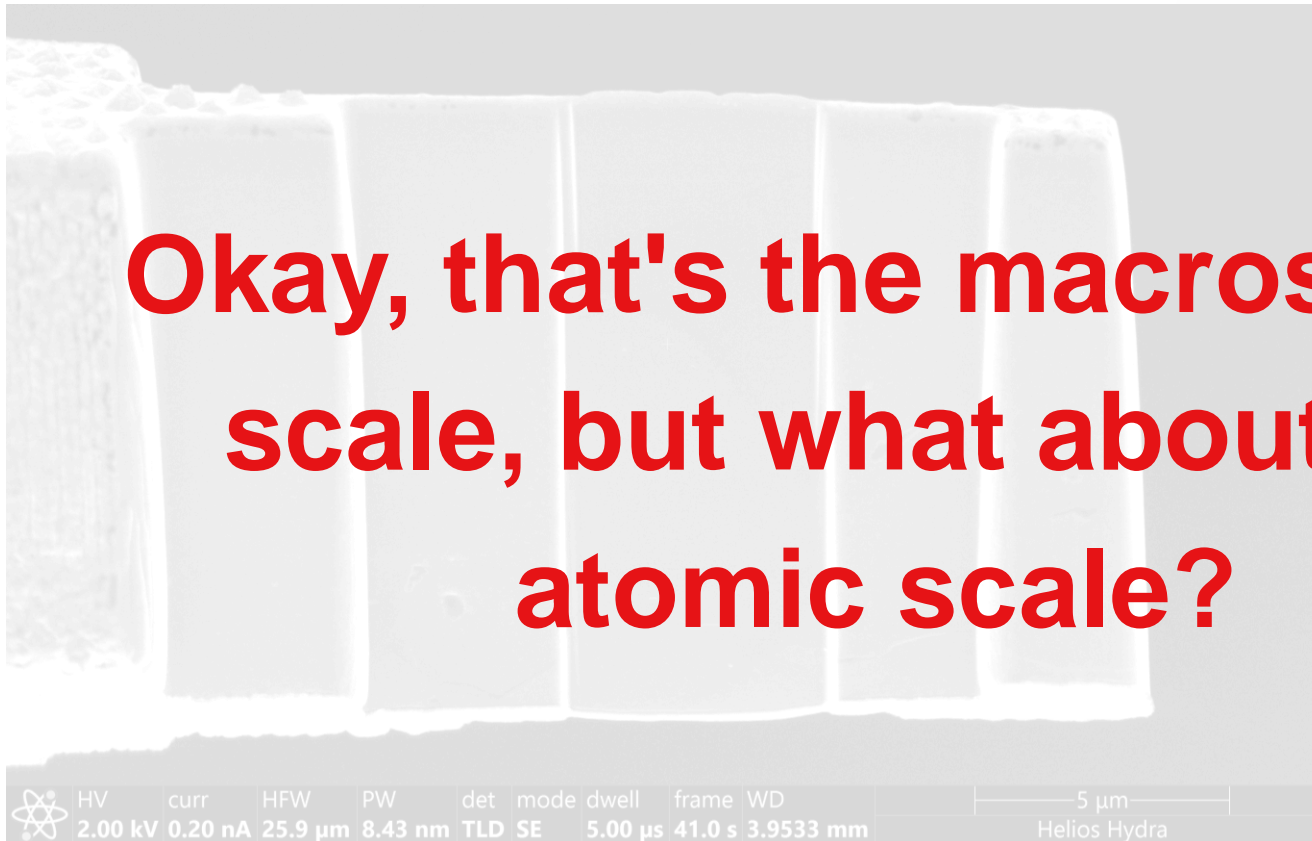


Helios Hydra PFIB



Talos F200X G2 TEM

Okay, that's the macroscopic
scale, but what about the
atomic scale?



Application of IGST workflow on air-sensitive material

Proof Material #3: Li-metal lamellae preparation (Ar^+ ion) and imaging

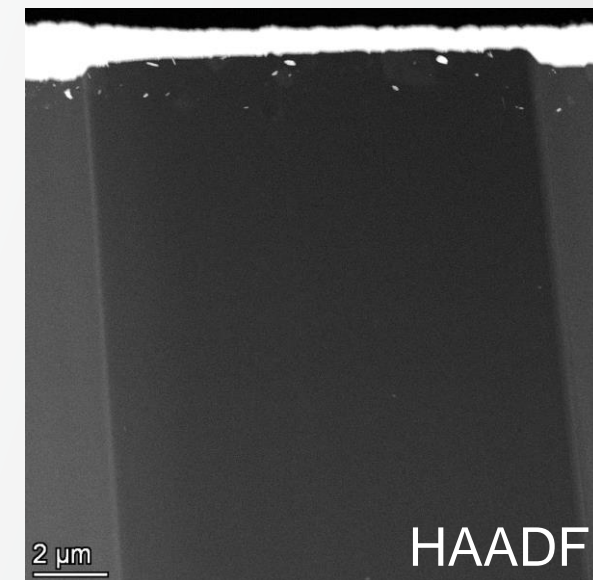
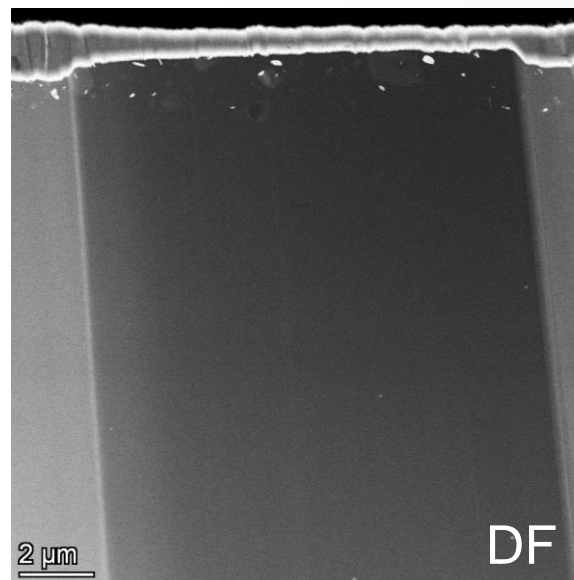
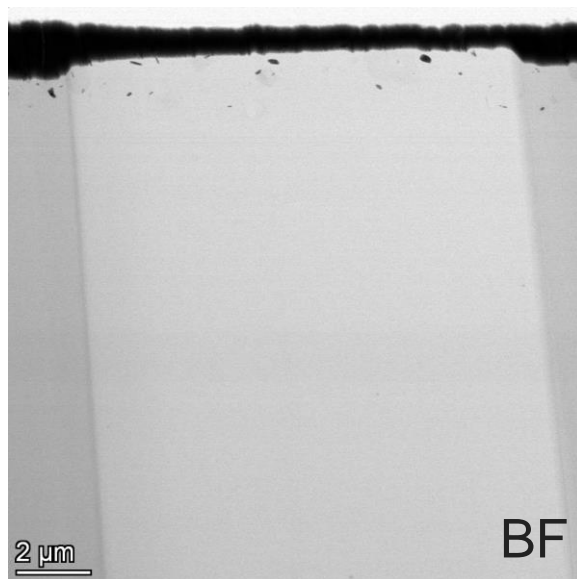
- **Glove box \rightarrow FIB** ✓
- **FIB \rightarrow SEM** ✓
- **SEM \rightarrow Glove Box** ✓
- **Glove Box \rightarrow TEM** ✓



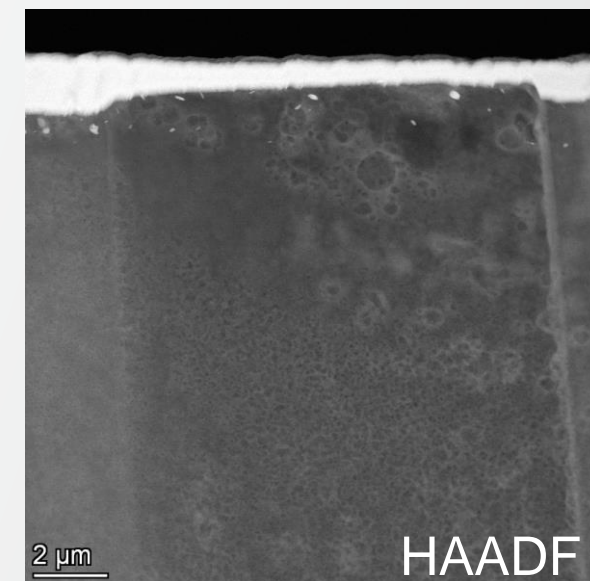
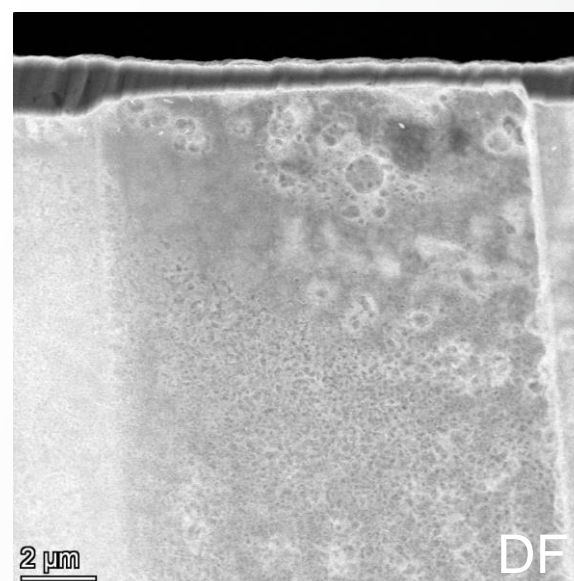
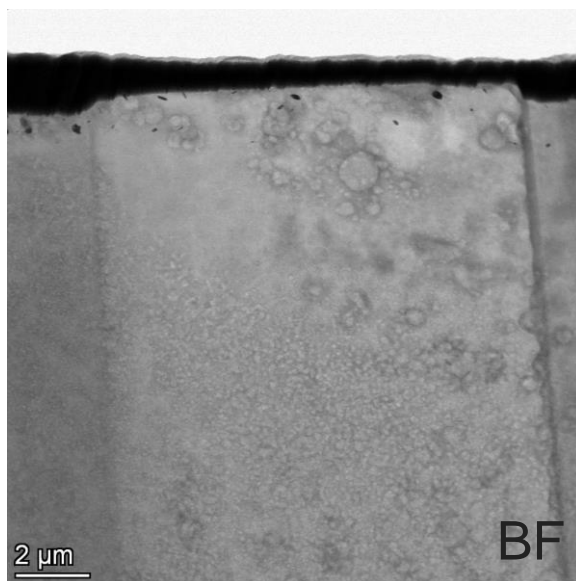
Clean connect solution Vs Conventional workflow

Li metal STEM imaging comparison with and without air exposure (15 s)

**Lamella #1 by
clean connect
solution**



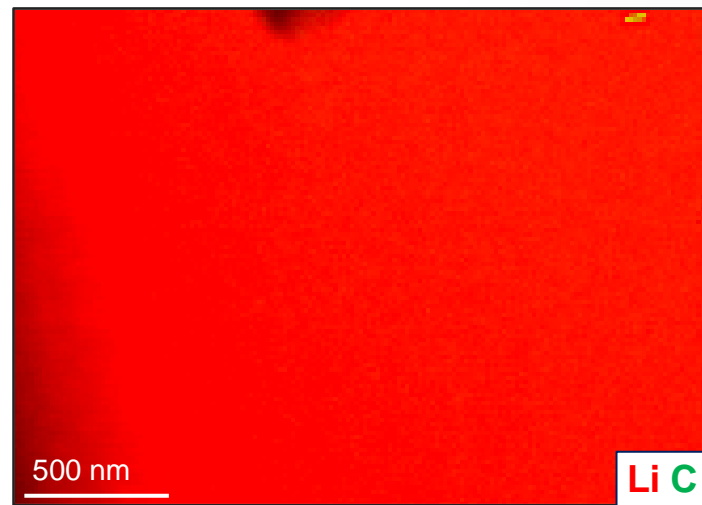
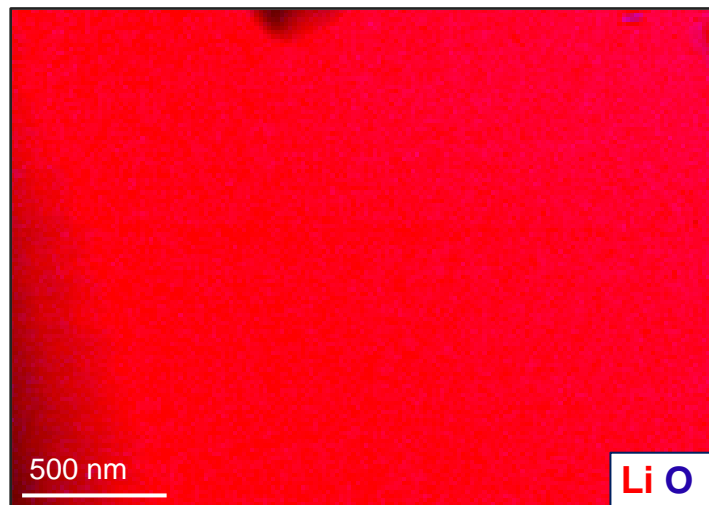
**Lamella #1 after
15s air
exposure**



Clean connect solution Vs Conventional workflow

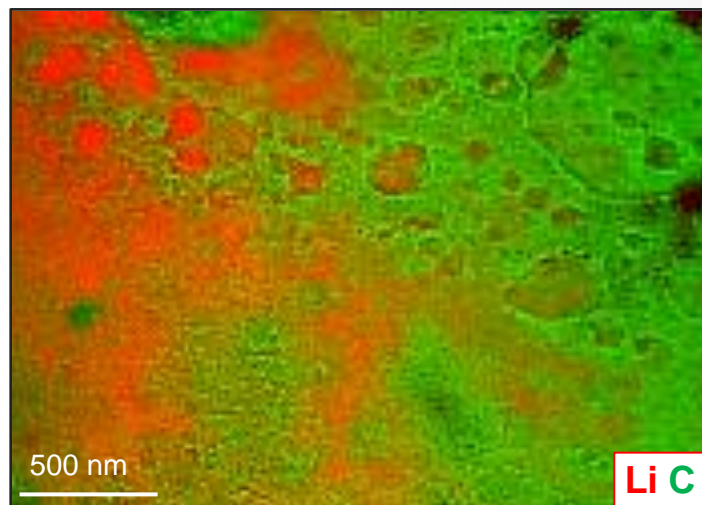
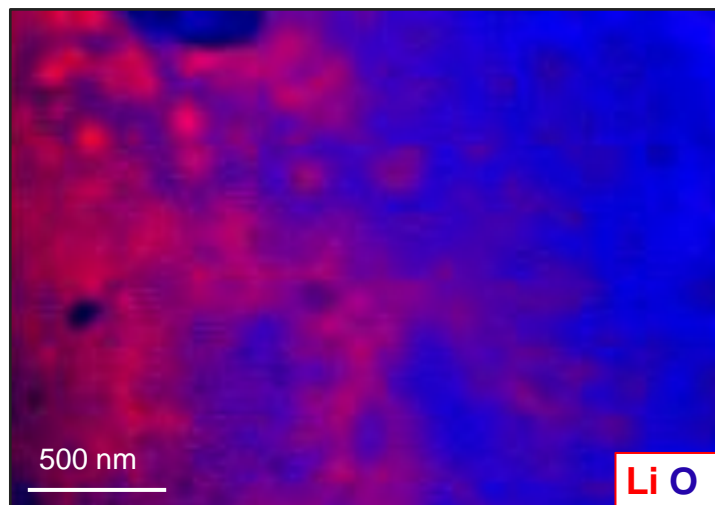
Li metal EELS analysis comparison with and without air exposure (Lamella #1)

Without air exposure



Element	Shell	Signal (Counts)	Comp. (at.%)
Li	K	6.768032e+11	94 ± 4
C	K	5.9267e+09	2.98 ± 0.14
O	K	9.3609e+08	2.92 ± 0.14

After 15s air exposure



Element	Shell	Signal (Counts)	Comp. (at.%)
Li	K	7.20142e+10	41.6 ± 1.2
C	K	1.83907e+10	22.0 ± 0.6
O	K	9.61318e+09	36.4 ± 1.1

→ ***Oxidation effects***

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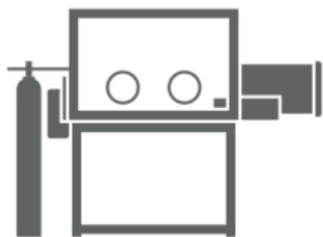
7 Avizo Software: data processing



CleanMill and CleanConnect

CleanMill and CleanConnect compatible enabling the Thermo Scientific IGST workflow

Enabling observation of materials in their native state



Glovebox



CleanConnect
(IGST)



Cross Polisher



CleanConnect
(IGST)



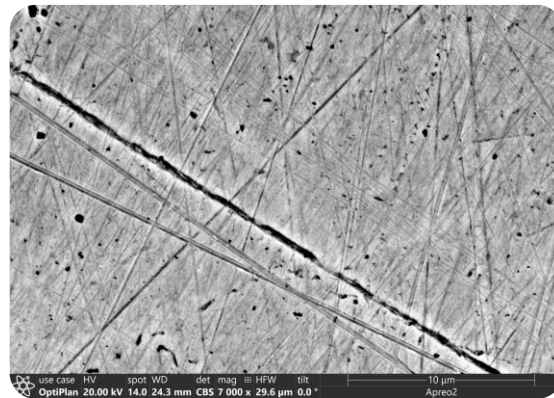
SEM



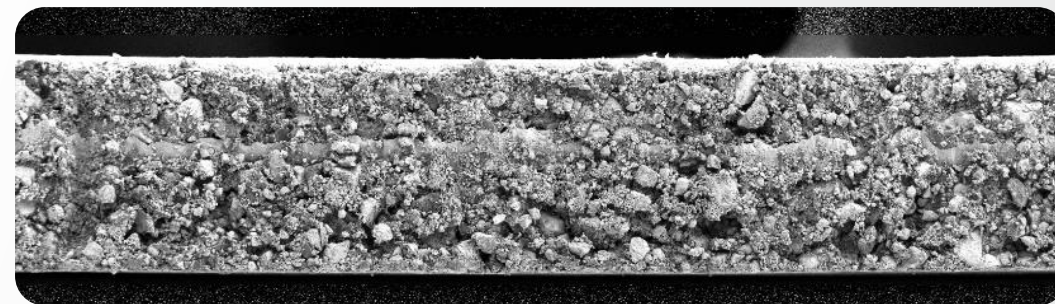
Sample Preparation for Nanoanalysis

Reliable & Repeatable sample prep is required for success in any surface examination

Common Issues

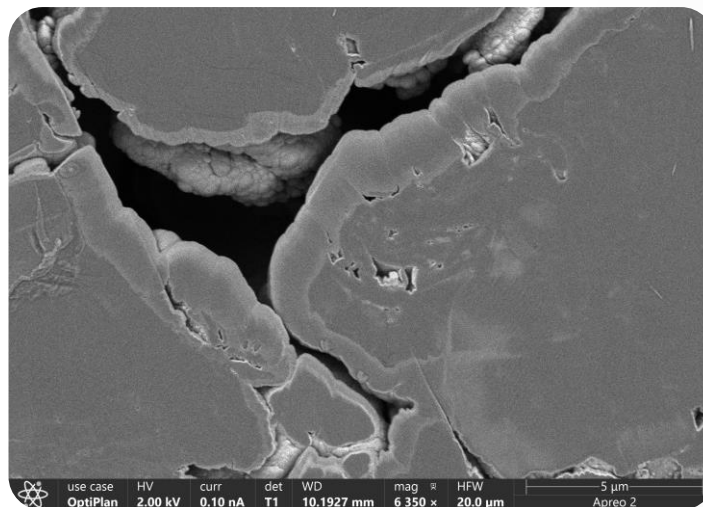


Mechanical Polishing

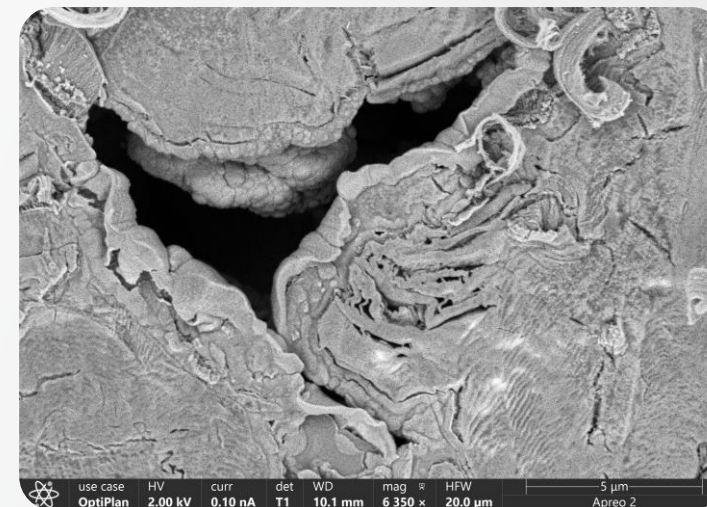


Composite Materials & Polymers

Energy & Next Gen Materials



Lithiated Graphite Anode

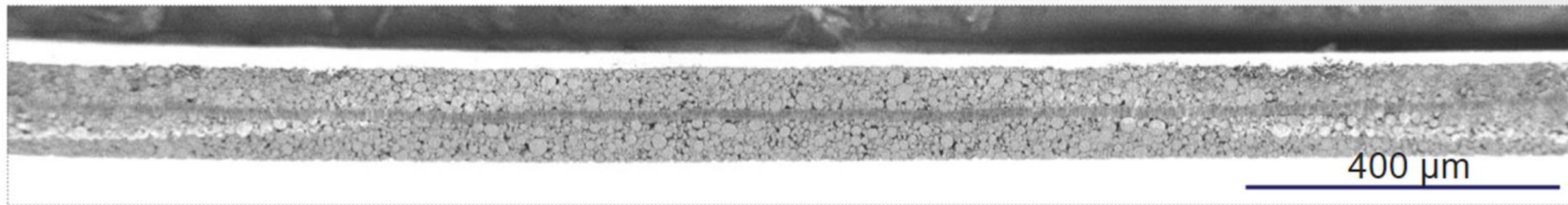


After 1 min air exposure

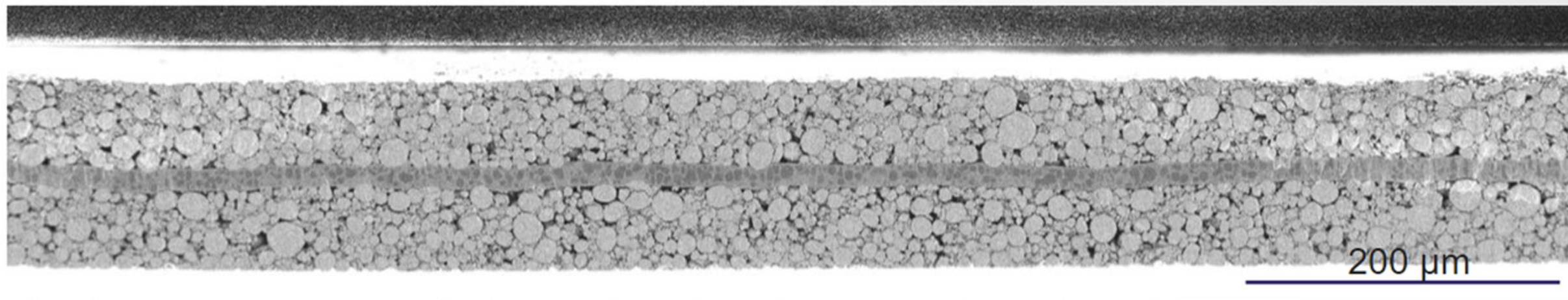
CleanMill Results: Cathode NMC

40° Oscillation, 1.5° tilt, 1 hour polishing; 16 kV

HFW: 2 mm

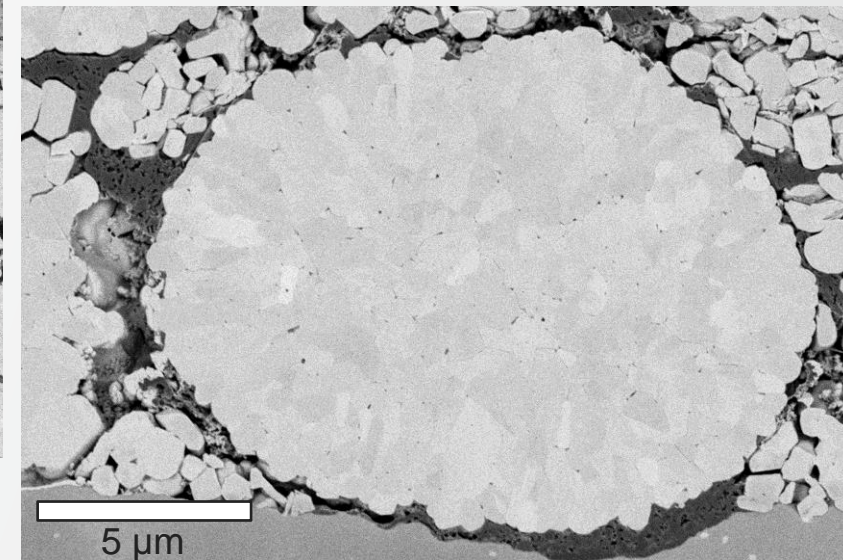
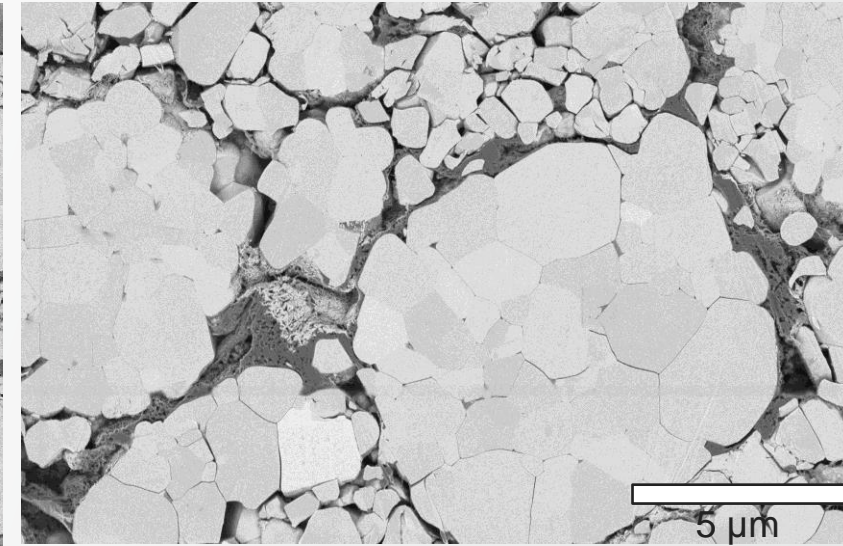
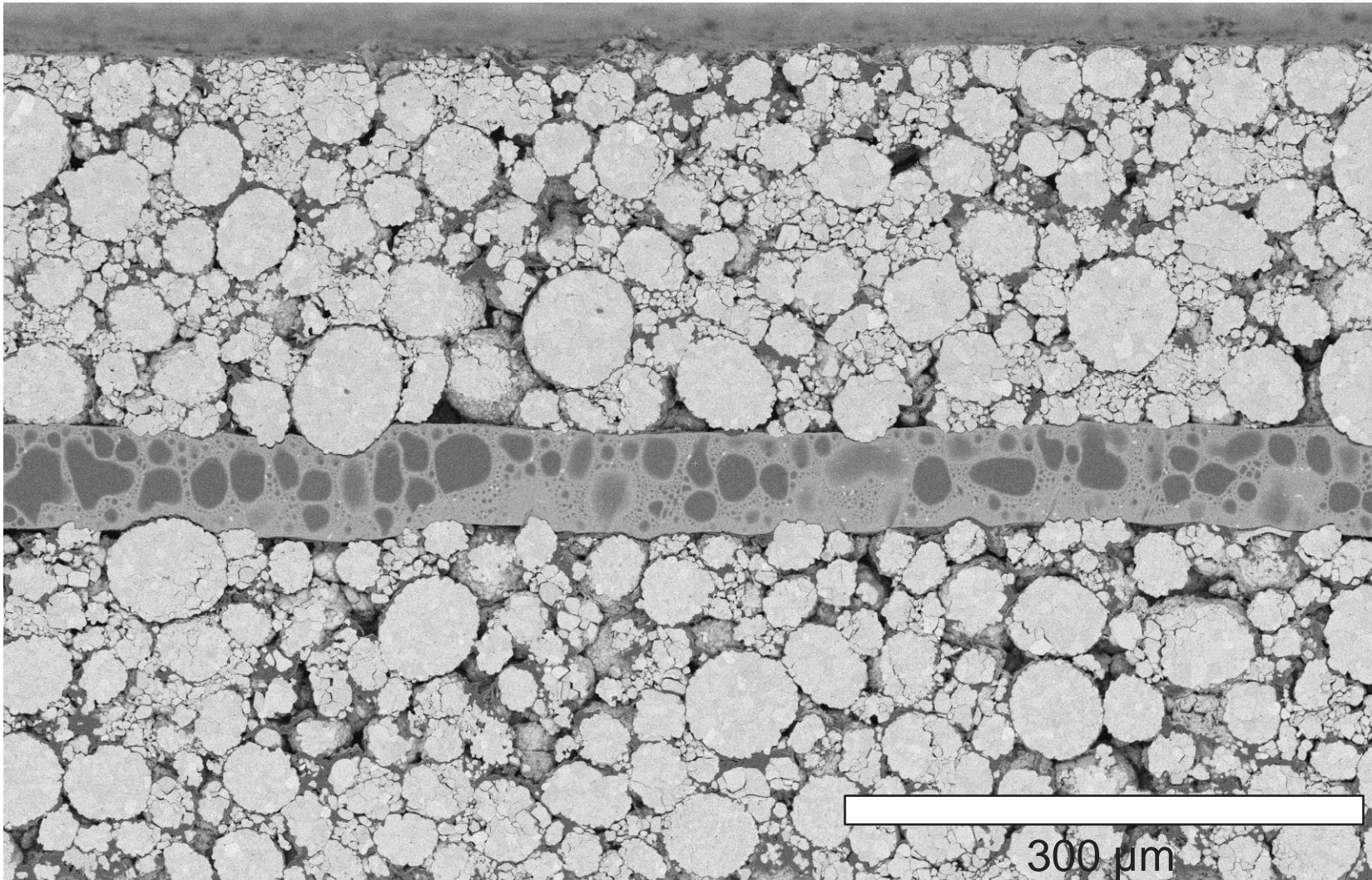


HFW: 1 mm



CleanMill Results: Cathode NMC

40° Oscillation, 1.5° tilt, 1 hour polishing; 16 kV



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7 **Avizo Software: data processing**



Identification of micro cracks cathode

Challenge

Improve performance of batteries by better understanding of degradation mechanism

Problem

Hard and tedious to be able to correctly analyze micro-cracks without being an image processing expert.

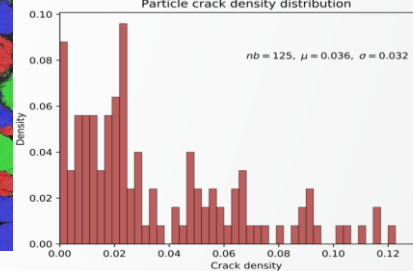
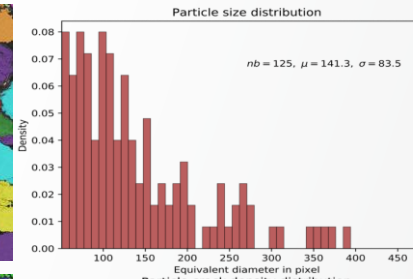
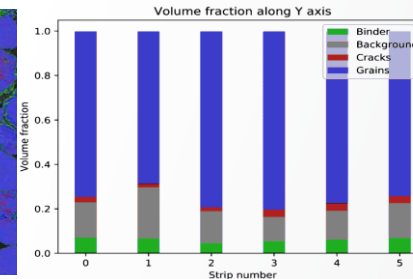
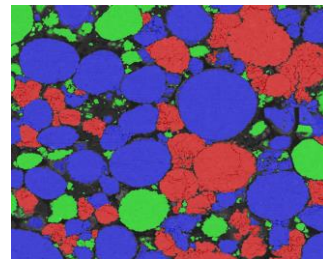
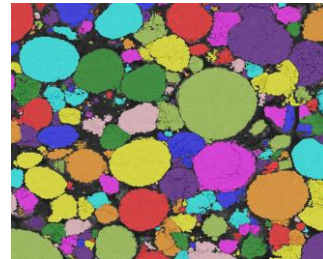
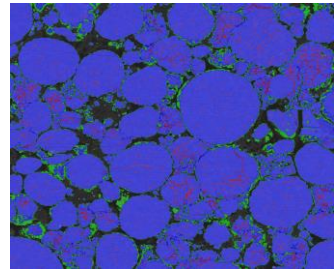
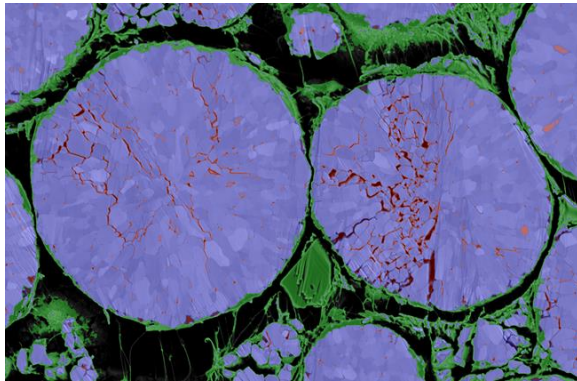
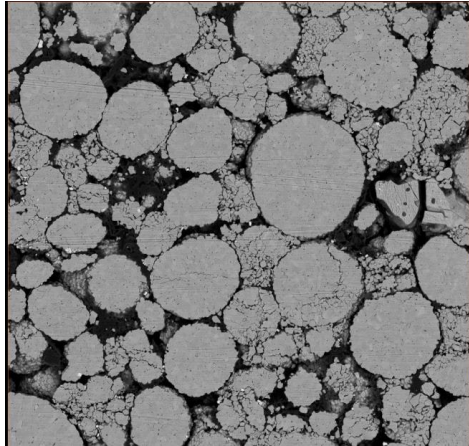
Need

Automated detection of micro cracks playable by non image processing experts

Impact

Improve existing electrode manufacturing process validation and new electrode architecture development.

Identification of Micro Cracks Cathode



- Fully automatable workflows for crack detection and measurements
- Advanced segmentation tools including complete deep learning environment
- Report generation

Impact:

Advanced image processing packaged in an intuitive way, with simple GUI and which can be played by non experts

Unattended identification of particles on a tiled dataset

Challenge

Improve output and precision of particle analysis in cathode materials in an unattended way

Problem

Not easy to master different software environments and trigger automation on a large tiled dataset without being an image processing expert

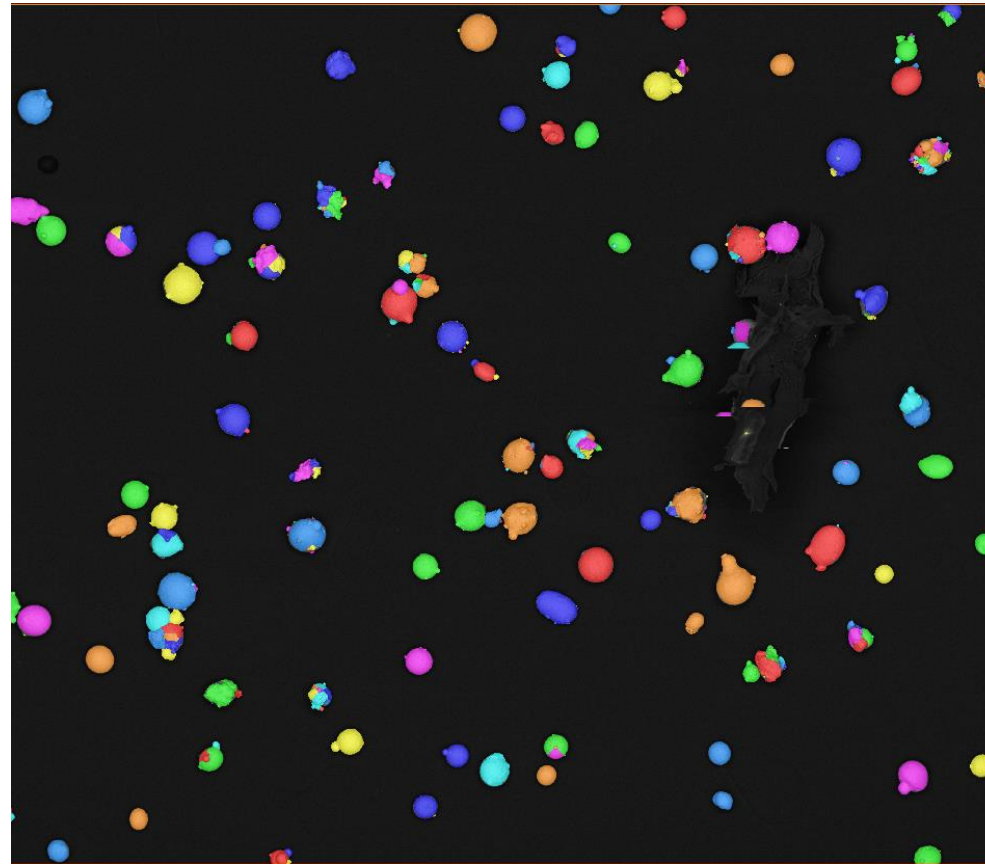
Need

Analyze different particle morphologies, chemical composition, density and association and so on ...

Impact

Dramatically Improve output of analysis in the electrode manufacturing process validation and new electrode architecture development.

Unattended identification of particles on a tiled dataset



- Fully automatable workflows for crack detection and measurements
- Advanced segmentation tools including complete deep learning environment
- Report generation

Impact:

Advanced analysis of a battery separator

• Challenge

- Suboptimal performances in charging / discharging
- Unable to scale analysis

Problem

- Tedious
- Highly manual
- Prone to errors

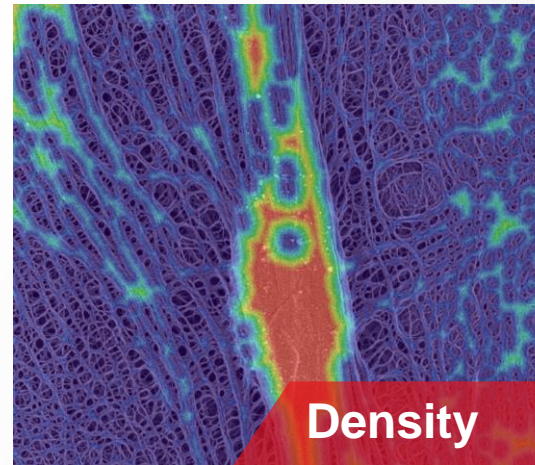
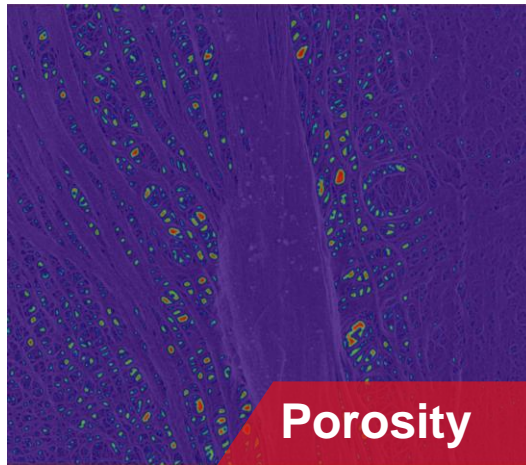
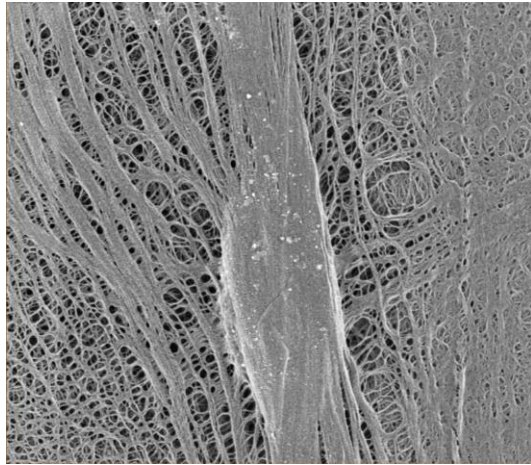
Need

- Automated process
- Fast and reproducible

Impact

- Better understanding of transport mechanisms and separator performance
- Better throughput thanks to automation of recipes

Identification of Micro Cracks Cathode



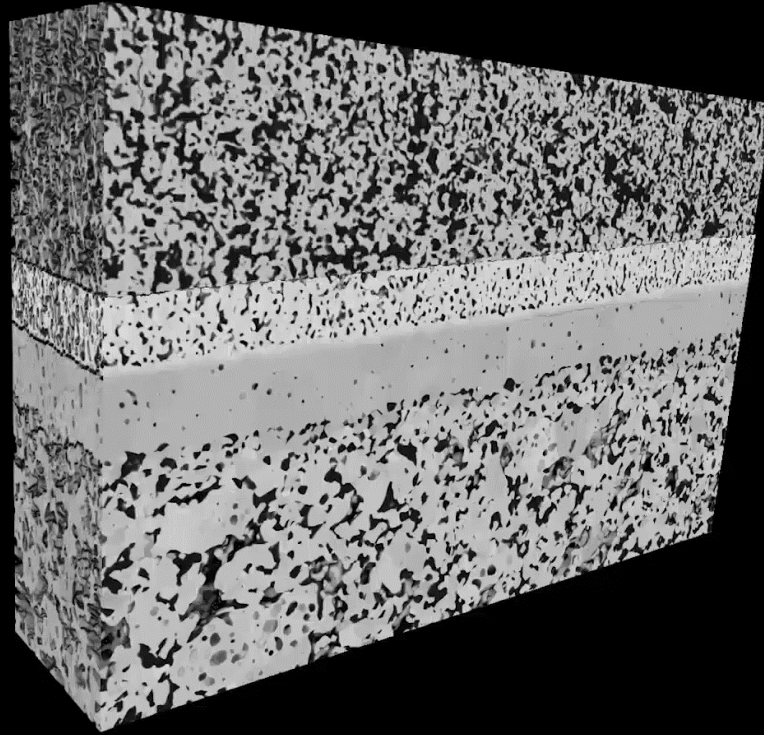
- Fully automatable workflows getting density and porosity information
- Advanced segmentation tools including complete deep learning environment
- Report generation

Impact:

Design better performing batteries with less scrap parts through better understanding of separator performances

Fuel Cell structure and tortuosity

Amira-Avizo
Software



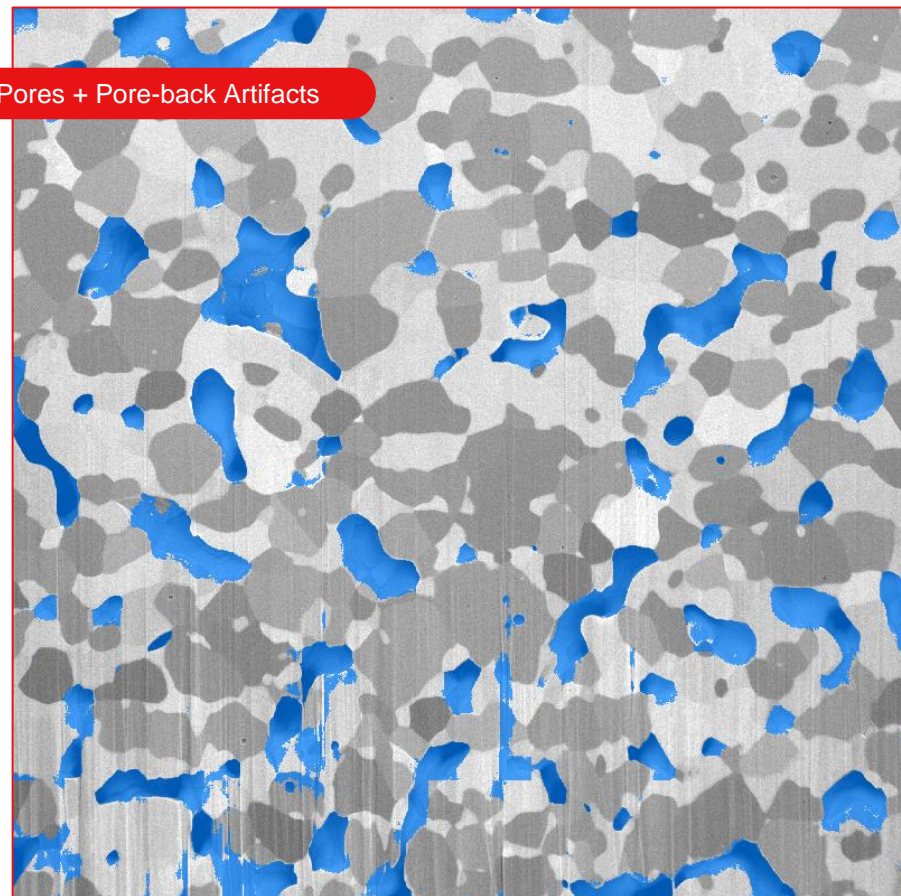
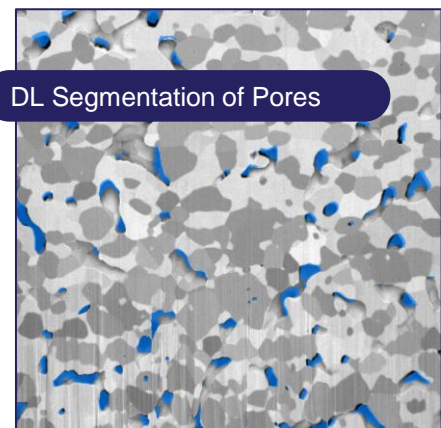
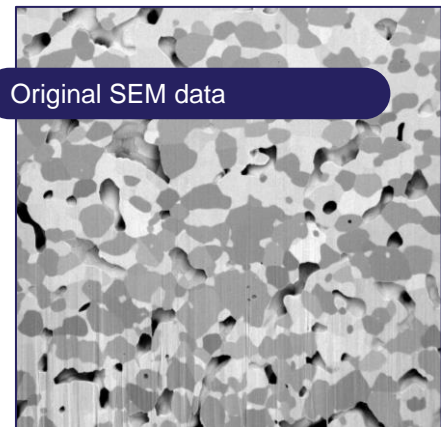
PlasmaFIB acquisition of a Solid Oxide Fuel Cell (SOFC)

- Pores/particles extraction
- Pore network modeling
- Tortuosity estimation
- Triple phase boundaries
- Absolute permeability
- Molecular diffusion simulation

Impact :

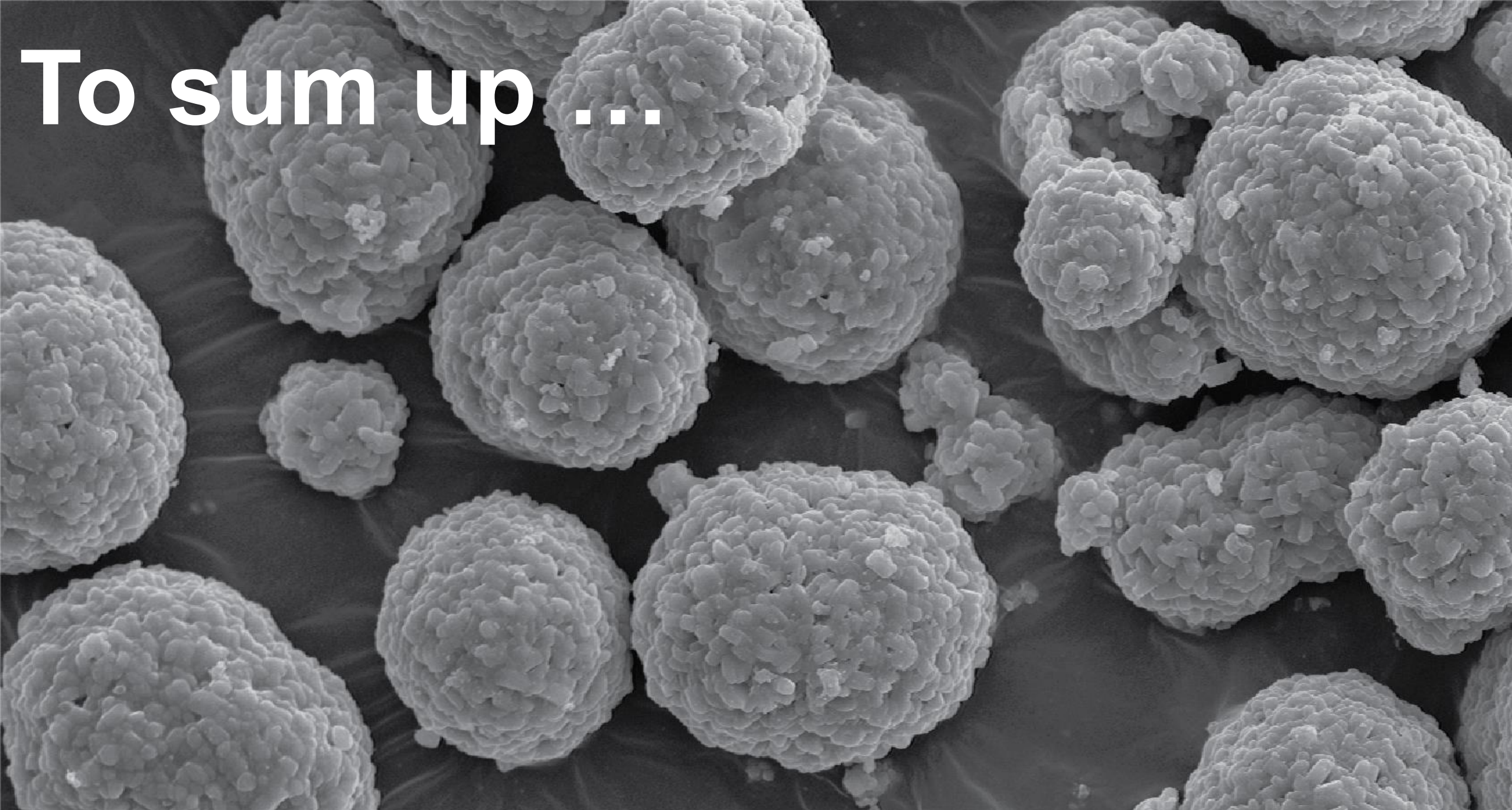
Need to perform simulation faster and easier in a digital way so that it becomes part of the design workflow of battery materials and Cell Manufacturing.

Deep learning for better accuracy

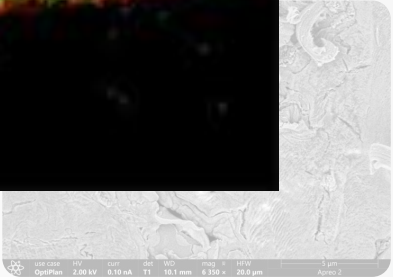
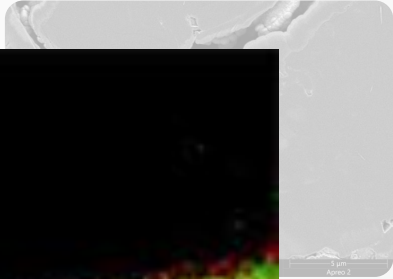
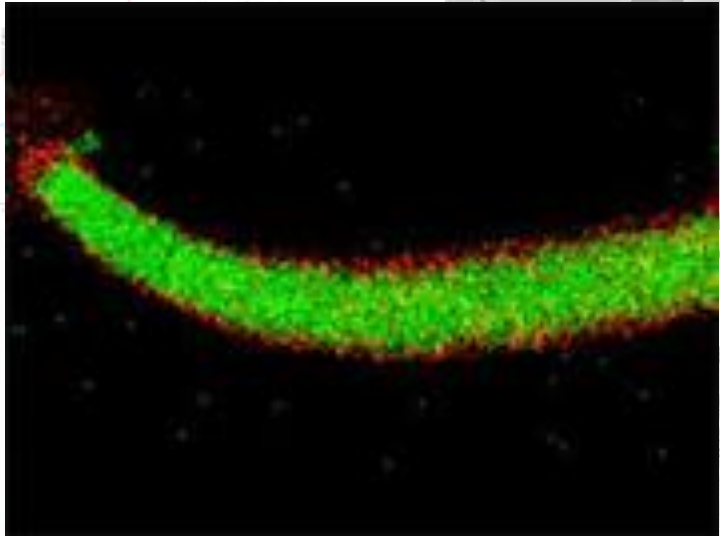
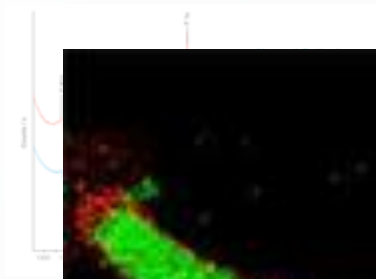
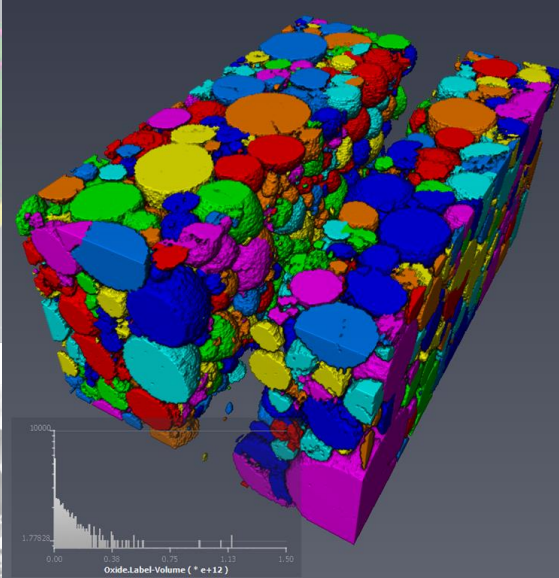
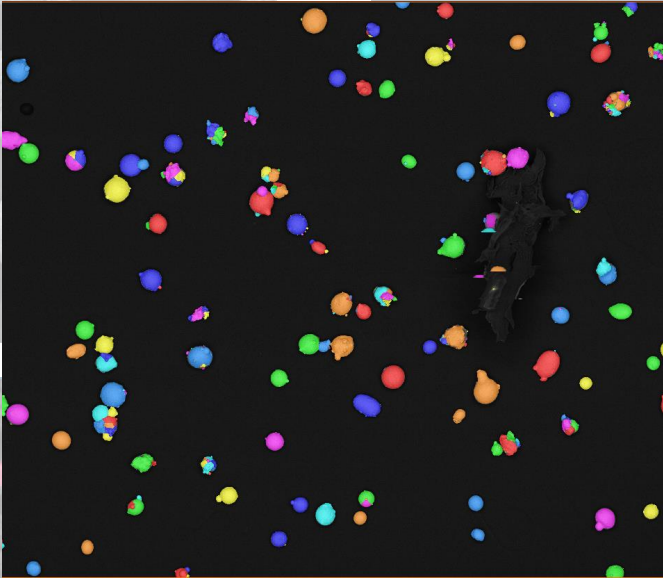
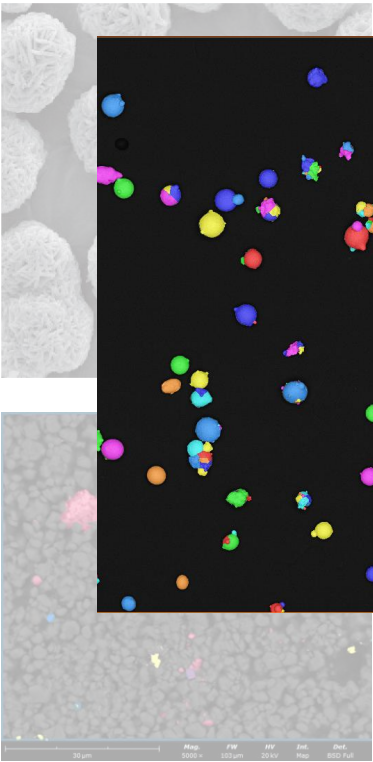
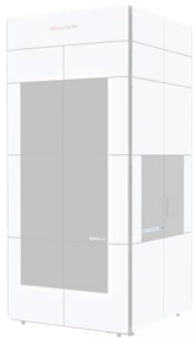


Phase	Pore Fraction		
	Min	Mean	Max
True Porosity (DL)	3.69 %	4.23 %	4.84 %
Porosity + Pore-Back	9.17 %	10.86 %	12.38 %

Impact :
Prevent overcounting porosity by 250%, usable by non-experts



Thermo Fisher Materials MSD-EM portfolio



After 1 min air exposure

Thank you

